



PENTIUM® II XEON™ PROCESSOR AT 400 AND 450 MHZ

- Binary compatible with applications running on previous members of the Intel microprocessor family
- Optimized for 32-bit applications running on advanced 32-bit operating systems
- Dynamic Execution micro architecture
- Dual Independent Bus architecture: Separate dedicated external 100 MHz System Bus and dedicated internal cache bus operating at full processor core speed
- Power Management capabilities
 - System Management mode
 - Multiple low-power states
- SMBus interface to advanced manageability features
- Single Edge Contact (S.E.C.) cartridge packaging technology; the S.E.C. cartridge delivers high performance processing and bus technology in mid range to high end servers and workstations
- 100 MHz system bus speeds data transfer between the processor and the system
- Integrated high performance 16K instruction and 16K data, nonblocking, level-one cache
- Available in 512K, 1 M, 2M unified, nonblocking level-two cache
- Enables systems which are scalable up to four processors and 64 GB of physical memory

The Intel® Pentium® II Xeon™ processor is designed for mid-range to high-end servers and workstations, and is binary compatible with previous Intel Architecture processors. The Pentium II Xeon processor provides the best performance available for applications running on advanced operating systems such as Windows* 95, Windows NT, and UNIX*. The Pentium II Xeon processor is scalable to four processors in a multiprocessor system and extends the power of the Pentium Pro processor with new features designed to make this processor the right choice for powerful workstation, advanced server management, and mission-critical applications. Pentium II Xeon processor-based workstations offer the memory architecture required by the most demanding workstation applications and workloads. Specific features of the Pentium II Xeon processor address platform manageability to meet the needs of a robust IT environment, maximize system up time and ensure optimal configuration and operation of servers. The Pentium II Xeon processor enhances the ability of server platforms to monitor, protect, and service the processor and its environment.





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1.0. INTRODUCTION

The Pentium II Xeon processor is a follow-on to the Pentium Pro and Pentium II processors. The Pentium II Xeon processor, like the Pentium Pro and Pentium II processors, implements a Dynamic Execution micro-architecture—a unique combination of multiple branch prediction, data flow analysis, and speculative execution. This enables Pentium II Xeon processors to deliver higher performance than the Pentium processor, while maintaining binary compatibility with all previous *Intel Architecture* processors. The Pentium II Xeon processor is available in 512K, 1M and 2 MB L2 cache options.

The Pentium II Xeon processor improves upon the Pentium Pro processor by adding MMX™ technology for 3-D compute-intensive applications, and by utilizing the S.E.C. (Single Edge Contact) package technology first introduced on the Pentium II processor. This new packaging technology allows Pentium II Xeon processors to implement the Dual Independent Bus Architecture and have up to 2-MBytes of level 2 cache. Like the Pentium Pro processor, level 2 cache communication occurs at the full speed of the processor core.

A significant feature of the Pentium II Xeon processor, from a system perspective, is the built-in direct multiprocessing support. For systems with up to four processors, it is important to consider the additional power burdens and signal integrity issues of supporting multiple loads on a high speed bus. The Pentium II Xeon processor supports both uniprocessor and multiprocessor implementations with up to four processor on each local processor bus, or *system bus*.

The Pentium II Xeon processor system bus operates using GTL+ signaling levels with a new type of buffer utilizing active negation and multiple terminations. This new bus logic is called *Assisted Gunning Transistor Logic*, or *AGTL+*. The Pentium II Xeon processors also deviate from the Pentium Pro processor in implementing an S.E.C. cartridge package supported by the SC330 connector. (See Section 6.0. for the processor mechanical specifications.) This document provides information to allow the user to design a system using Pentium II Xeon processors.

1.1. Terminology

In this document, a '#' symbol after a signal name refers to an active low signal. This means that a signal is in the active state (based on the name of the signal) when driven to a low level. For example, when FLUSH# is low, a flush has been requested. When NMI is high, a nonmaskable interrupt has occurred. In the case of lines where the name does not imply an active state but describes part of a binary sequence (such as address or data), the '#' symbol implies that the signal is inverted. For example, D[3:0] = 'HLHL' refers to a hex 'A', and D [3:0] # = 'LHLH' also refers to a hex 'A' (H= High logic level, L= Low logic level).

The term 'system bus' refers to the interface between the processor, system core logic and other bus agents. The system bus is a multiprocessing interface to processors, memory and I/O. The term 'cache bus' refers to the interface between the processor and the L2 cache. The cache bus does NOT connect to the system bus, and is not accessible by other agents on the system bus. Cache coherency is maintained with other agents on the system bus through the MESI cache protocol as supported by the HIT# and HITM# bus signals.

The term "Pentium II Xeon processor" refers to the cartridge package which interfaces to a host system board through a SC330 connector. Pentium II Xeon processors include a processor core, a level 2 cache, system bus termination and various system management features. The Pentium II Xeon processor includes a thermal plate for cooling solution attachment and a protective cover.

1.1.1. S.E.C. Cartridge Terminology

The following terms are used often in this document and are explained here for clarification:

- **Cover**—The processor casing on the opposite side of the thermal plate.
- **Pentium® II Xeon™ processor**—The 100 MHz SC330 product including internal components, substrate, thermal plate and cover.

- **L1 cache**—Integrated static RAM used to maintain recently used information. Due to code locality, maintaining recently used information can significantly improve system performance in many applications. The L1 cache is integrated directly on the processor core.
- **L2 cache**—The L2 cache increases the total cache size significantly through the use of multiple components.
- **Processor substrate**—The structure on which components are mounted inside the S.E.C. cartridge (with or without components attached).
- **Processor core**—The processor's execution engine.
- **S.E.C. cartridge**—The processor packaging technology used for the Pentium II Xeon processor. S.E.C. is short for "Single Edge Contact" cartridge.
- **Thermal plate**—The surface used to connect a heatsink or other thermal solution to the processor.

Additional terms referred to in this and other related documentation:

- **Slot 2**—Former nomenclature for the connector that the S.E.C. cartridge plugs into, just as the Pentium® Pro processor uses Socket 8. Now called 330-Contact Slot Connector (SC330).
- **Retention mechanism**—A mechanical component designed to hold the processor in a **SC330 connector**.
- **SC330**—Abbreviation for the 330-Contact Slot Connector that the S.E.C. cartridge plugs into, just as the Pentium Pro processor uses Socket 8.

1.2. References

The reader of this specification should also be familiar with material and concepts presented in the following documents:

- *CPU-ID Instruction* application note (Order Number 241618)
- *Pentium® II Xeon™ Processor I/O Buffer Models, Quad Format* (Electronic Form)

- *Pentium® II Xeon™ Processor Power Distribution Guidelines* (Order Number 243772)
- *Pentium® II Xeon™ Processor Specification Update* (Order Number 243776)
- *Slot 2 Enabling Technology Vendor List* (www.developer.intel.com)
- *Intel Architecture Software Developer's Manual* (Order Number 243193)
 - *Volume I: Basic Architecture* (Order Number 243190)
 - *Volume II: Instruction Set Reference* (Order Number 243191)
 - *Volume III: System Programming Guide* (Order Number 243192)
- *Slot 2 Connector Specification*
- *VRM 8.2 DC-DC Converter Design Guidelines* (www.developer.intel.com)
- *VRM 8.3 DC-DC Converter Design Guidelines* (www.developer.intel.com)
- *Slot 2 Termination Card Design Guidelines* (Order Number 243772)
- *Pentium® II Xeon™ Processor/Intel® 450NX PCIset AGTL+ Layout Guidelines* (Order Number 243790)
- *100 MHz 2-Way SMP Pentium® II Xeon™ Processor/Intel® 440GX AGPset AGTL+ Layout Guidelines* (Order Number 243775)
- *Pentium® II Processor Developer's Manual* (Order Number 243502)
- *Pentium® II Xeon™ Processor SMBus Thermal Reference Guidelines* (Order Number 243791)

Most or all of this documentation can be found on Intel's developer's world wide web site: www.developer.intel.com.

2.0. ELECTRICAL SPECIFICATIONS

2.1. The Pentium® II Xeon™ Processor System Bus and VREF

Most Pentium II Xeon processor signals use a **variation** of the Pentium Pro processor GTL+ signaling technology. The Pentium II Xeon processor differs from the Pentium II processor and

Pentium Pro processor in its output buffer implementation. The buffers that drive most of the system bus signals on the Pentium II Xeon processor are actively driven to V_{CCORE} for one clock cycle after the low to high transition to improve rise-times and reduce noise. These signals should still be considered open-drain and require termination to a supply that provides the high signal level. Because this specification is different from the standard GTL+ specification, it is referred to as *Assisted Gunning Transistor Logic* (AGTL+) in this document. AGTL+ logic and GTL+ logic are compatible with each other and may both be used on the same system bus. For more information on the GTL+ specification, see the *Pentium® Pro Family Developer's Manual, Volume I*.

AGTL+ inputs use differential receivers which require a reference signal (V_{REF}). V_{REF} is used by the receivers to determine if a signal is a logical 0 or a logical 1. The Pentium II Xeon processor generates its own version of V_{REF} . V_{REF} must be generated on the motherboard for other devices on the AGTL+ system bus. Termination is used to pull the bus up to the high voltage level and to control signal integrity on the transmission line. The processor contains termination resistors that provide termination for each Pentium II Xeon processor. These specifications assume the equivalent of 6 AGTL+ loads and termination resistors to ensure the proper timings on rising and falling edges. See test conditions described with each specification.

Due to the existence of termination on each of up to 4 processors in a Pentium II Xeon processor system, the AGTL+ bus is typically not a daisy chain topology as in previous P6 family processor systems. Also new to Pentium II Xeon processors, timing specifications are defined to points internal to the processor packaging. **Analog signal simulation of the system bus is required** when developing Pentium II Xeon processor based systems to ensure proper operation over all conditions. *Pentium® II Xeon™ Processor I/O Buffer Models* are available for simulation.

The *100 MHz 2-Way SMP Pentium® II Xeon™ Processor/Intel® 440GX AGPset AGTL+ Layout Guidelines* and *Pentium® II Xeon™ Processor/Intel® 450NX PCIset AGTL+ Layout Guidelines* contains information on possible layout topologies and other information for analog simulation.

2.2. Power and Ground Pins

The operating voltage of the processor die and of the L2 cache die differ from each other. There are two groups of power inputs on the Pentium II Xeon processor package to support this voltage difference between the components in the package. There are also five pins defined on the package for core voltage identification (VID_{CORE}), and five pins defined on the package for L2 cache voltage identification (VID_{L2}). These pins specify the voltage required by the processor core and L2 cache respectively. These have been added to cleanly support voltage specification variations on current and future Pentium II Xeon processors.

For signal integrity improvement and clean power distribution within the S.E.C. package, Pentium II Xeon processors have 67 V_{CC} (power) and 56 V_{SS} (ground) inputs. The 67 V_{CC} pins are further divided to provide the different voltage levels to the components. V_{CCORE} inputs for the processor core account for 35 of the V_{CC} pins, while 8 V_{TT} inputs (1.5 V) are used to provide an AGTL+ termination voltage to the processor and 20 V_{CCL2} inputs are for use by the L2 cache. One $V_{CCSMBUS}$ pin is provided for use by the SMBus and one V_{CCTAP} for the test access port. $V_{CCSMBUS}$, V_{CCL2} , and V_{CCORE} must remain electrically separated from each other. On the circuit board, all V_{CCORE} pins must be connected to a voltage island and all V_{CCL2} pins must be connected to a separate voltage island (an island is a portion of a power plane that has been divided, or an entire plane). Similarly, all V_{SS} pins must be connected to a system ground plane.

2.3. Decoupling Guidelines

Due to the large number of transistors and high internal clock speeds, the processor is capable of generating large average current swings between low and full power states. This causes voltages on power planes to sag below their nominal values if bulk decoupling is not adequate. Care must be taken in the board design to ensure that the voltage provided to the processor remains within the specifications listed in Table 5. Failure to do so can result in timing violations or a reduced lifetime of the component.

**2.3.1. PENTIUM® II XEON™ PROCESSOR
V_{CC}CORE**

Regulator solutions must provide bulk capacitance with a low Effective Series Resistance (ESR) and the system designer must also control the interconnect resistance from the regulator (or VRM pins) to the **330-contact slot connector**. Simulation is required. Bulk decoupling for the large current swings when the part is powering on, or entering/exiting low power states, is provided on the voltage regulation module (VRM) defined in the *VRM 8.2 DC–DC Converter Design Guidelines* and the *VRM 8.3 DC–DC Converter Design Guidelines*. The input to V_{CC}CORE should be capable of delivering a recommended minimum dI_{CCORE}/dt defined in Table 6 while maintaining the required tolerances defined in Table 5. See the *Pentium® II Xeon™ Processor Power Distribution Guidelines*.

2.3.2. LEVEL 2 CACHE DECOUPLING

Regulator solutions need to provide bulk capacitance with a low Effective Series Resistance (ESR) in order to meet the tolerance requirements for V_{CC}L2. Use similar design practices as those recommended for V_{CC}CORE. See the *Pentium® II Xeon™ Processor Power Distribution Guidelines*.

2.3.3. SYSTEM BUS AGTL+ DECOUPLING

The Pentium II Xeon processor contains high frequency decoupling capacitance on the processor substrate; bulk decoupling must be provided for by the system motherboard for proper AGTL+ bus operation. High frequency decoupling may be necessary at the **SC330 connector** to further

improve signal integrity if noise is picked up at the connector interface. See the *Pentium® II Xeon™ Processor Power Distribution Guidelines*.

2.4. System Bus Clock and Processor Clocking

The BCLK input directly controls the operating speed of the system bus interface. All system bus timing parameters are specified with respect to the rising edge of the BCLK input, measured at the processor core. The Pentium II Xeon processor core frequency must be configured during Reset by using the A20M#, IGNNE#, LINT[1]/NMI, and LINT[0]/INTR pins (see Table 1). The value on these pins during Reset determines the multiplier that the Phase Lock Loop (PLL) will use for the internal core clock. See the *Pentium® Pro Processor Family Developer's Manual* for the definition of these pins during reset and the operation of the pins after reset.

NOTE

The frequency multipliers supported are shown in Table 1; other combinations will not be validated nor supported by Intel. Also, each multiplier is only valid for use on the product of the frequency indicated in Table 1.

Clock multiplying within the processor is provided by the internal PLL, requiring a constant frequency BCLK input. The BCLK frequency ratio cannot be changed dynamically during normal operation or any low power modes. The BCLK frequency ratio can be changed when RESET# is active, assuming that all Reset specifications are met.

Table 1. Core Frequency to System Bus Multiplier Configuration

Multiplication of Processor Core Frequency to System Bus Frequency	Product Supported on	LINT[1]	LINT[0]	A20M#	IGNNE#
1/2	Reset only	L	L	L	L
1/3	Not Supported	L	L	L	H
1/4	400, 450 MHz	L	L	H	L
1/5	Not Supported	L	L	H	H
2/5	Not Supported	L	H	L	L
2/7	Not Supported	L	H	L	H
2/9	450 MHz	L	H	H	L
2/11	Not Supported	L	H	H	H
1/6	Not Supported	H	L	L	L
1/7	Not Supported	H	L	L	H
1/8	Not Supported	H	L	H	L
Reserved	Not Supported	H	L	H	H
2/13	Not Supported	H	H	L	L
2/15	Not Supported	H	H	L	H
2/3	Not Supported	H	H	H	L
1/2	Reset Only	H	H	H	H

See Figure 1 for the timing relationship between the system bus multiplier signals, RESET#, and normal processor operation. Using CRESET# (CMOS Reset) and the timing shown in Figure 1, the circuit in Figure 2 can be used to share these configuration signals. The component used as the multiplexer must not have outputs that drive higher than 2.5 V in order to meet the processor's 2.5 V tolerant buffer specifications. The multiplexer output current should be limited to 200 mA maximum, in case the V_{CC}CORE supply to the processor ever fails.

As shown in Figure 2, the pull-up resistors between the multiplexer and the processor (1kΩ) force a "safe" ratio into the processor in the event that the processor powers up before the multiplexer and/or core logic. This prevents the processor from ever seeing a ratio higher than the final ratio.

If the multiplexer were powered by V_{CC}2.5, a pull-down resistor could be used on CRESET# instead of the four pull-up resistors between the multiplexer and the Pentium II Xeon processors. In this case, the multiplexer must be designed such that the compatibility inputs are truly ignored, as their state is unknown.

In any case, the compatibility inputs to the multiplexer must meet the input specifications of the multiplexer. This may require a level translation before the multiplexer inputs unless the inputs and the signals driving them are already compatible.

For FRC mode operation, these inputs to the processor must be synchronized using BCLK to meet setup and hold times to the processors. This may require the use of high-speed programmable logic.

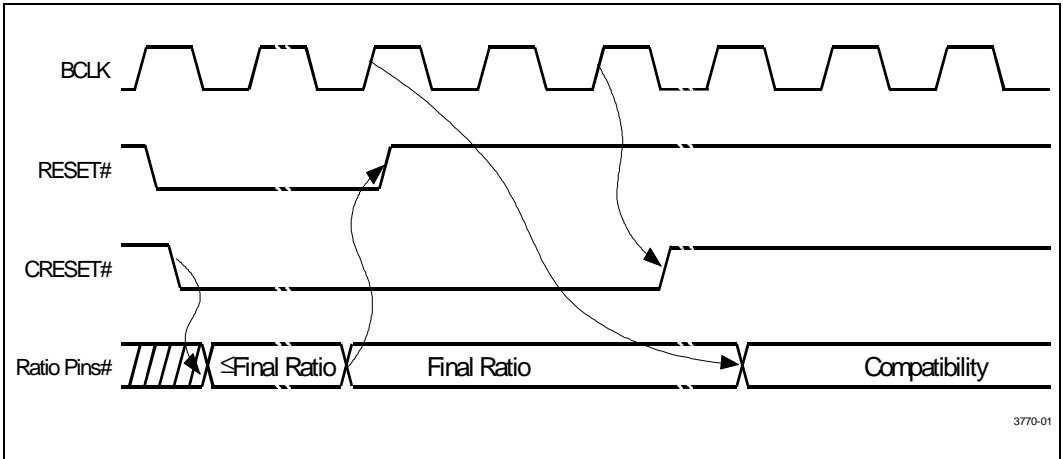
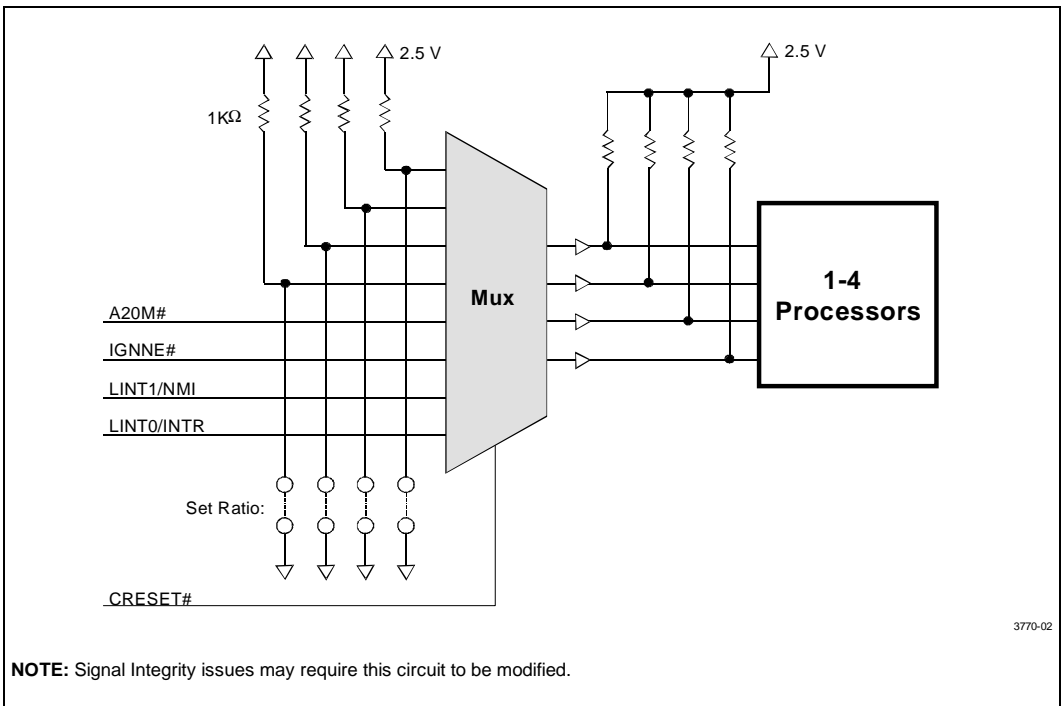


Figure 1. Timing Diagram of Clock Ratio Signals



NOTE: Signal Integrity issues may require this circuit to be modified.

Figure 2. Logical Schematic for Clock Ratio Pin Sharing

2.4.1. MIXING PROCESSORS OF DIFFERENT FREQUENCIES AND CACHE SIZES

Mixing components of different internal clock frequencies is not supported and has not been validated by Intel. Operating system support for MP with mixed frequency components should also be considered.

Also, Intel does not support or validate operation of processors with different cache sizes. Intel only supports and validates multiprocessor configurations where all processors operate with the same system bus and core frequencies and have the same L1 and L2 cache sizes.

2.5. Voltage Identification

The Pentium II Xeon processor contains five voltage identification pins for core voltage selection and five voltage identification pins for L2 cache voltage selection. These pins may be used to support automatic selection of both power supply voltages. VID_CORE[4:0] controls the voltage supply to the processor core and VID_L2[4:0] controls the voltage supply to the L2 cache. Both use the same encoding as shown in Table 2. They are not driven *signals*, but

are either an open circuit or a short circuit to V_{SS} . The combination of opens and shorts defines the voltage required by the processor core and L2 cache. The VID pins support variations in processor core voltage specifications and in L2 cache implementations among processors in the Pentium II Xeon processor family. Table 2 shows the recommended range of values to support for both the processor core and the L2 cache. A '1' in this table refers to an open pin and '0' refers to a short to ground. The definition provided below is a superset of the definition previously defined for the Pentium Pro processor (VID4 was not used by the Pentium Pro processor) and is common to both the Pentium II and Pentium II Xeon processors. **The power supply must supply the voltage that is requested or it must disable itself.**

To ensure the system is ready for all Pentium II Xeon processors, a system should support those voltages indicated with a bold **x** in Table 2. Supporting a smaller range will risk the ability of the system to migrate to possible higher performance processors in the future. Support for a wider range provides more flexibility and is acceptable.

Table 2. Core and L2 Voltage Identification Definition^{1,2}

Processor Pins							
VID4	VID3	VID2	VID1	VID0	V _{CC}	Core ³	L2 ³
00110b - 01111b					Reserved		
0	0	1	0	1	1.80	x	x
0	0	1	0	0	1.85	x	x
0	0	0	1	1	1.90	x	x
0	0	0	1	0	1.95	x	x
0	0	0	0	1	2.00	x	x
0	0	0	0	0	2.05	x	x
1	1	1	1	0	2.1	x	x
1	1	1	0	1	2.2		x
1	1	1	0	0	2.3		x
1	1	0	1	1	2.4		x
1	1	0	1	0	2.5		x
1	1	0	0	1	2.6		x
1	1	0	0	0	2.7		x
1	0	1	1	1	2.8		x
1	0	1	1	0	2.9		
1	0	1	0	1	3.0		
1	0	1	0	0	3.1		
1	0	0	1	1	3.2		
1	0	0	1	0	3.3		
1	0	0	0	1	3.4		
1	0	0	0	0	3.5		
1	1	1	1	1	no core		

NOTES:

- 0 = Processor pin connected to V_{SS}, 1 = Open on processor; may be pulled up to TTL V_{IH} on motherboard. See the *VRM 8.2 DC-DC Converter Design Guidelines* and/or the *VRM 8.3 DC-DC Converter Design Guidelines*.
- VRM output should be disabled for V_{CCCORE} values less than 1.80 V.
- x = Required

Note that the '11111' (all opens) ID can be used to detect the absence of a processor core in a given slot as long as the power supply used does not affect these lines. Detection logic and pull-ups should not affect VID inputs at the power source. (See Section 9.0.)

The VID pins should be pulled up to a TTL-compatible level with external resistors to the power source of the regulator only if required by the regulator or external logic monitoring the VID[4:0] signals. The power source chosen must be guaranteed to be stable whenever the supply to the voltage regulator is stable. This will prevent the possibility of the processor supply going above V_{CCCORE} in the event of a failure in the supply for the VID lines. In the case of a DC-to-DC converter, this can be accomplished by using the input voltage to the converter for the VID line pull-ups. A resistor of greater than or equal to 10k Ω may be used to connect the VID signals to the converter input. See the *VRM 8.2 DC-DC Converter Design Guidelines* and/or *VRM 8.3 DC-DC Converter Design Guidelines* for further information.

2.6. System Bus Unused Pins and Test Pins

All RESERVED_XXX pins must remain unconnected. Connection of RESERVED_XXX pins to V_{CCCORE} , V_{CCL2} , V_{SS} , V_{TT} , to each other, or to any other signal can result in component malfunction or incompatibility with future members of the Pentium II Xeon processor family. See Section 6.0. for a pin listing of the processor edge connector for the location of each reserved pin.

The TEST_25_A62 pin must be connected to 2.5 V via a pull-up resistor of between 1k Ω and 10k Ω . TEST_VCC_CORE must each be connected individually to V_{CCCORE} through a ~10k Ω (approximately) resistor. TEST_VTT pins must each be connected individually to V_{TT} with a ~150 Ω resistor. TEST_VSS pins must each be connected individually to V_{SS} with a ~1k Ω resistor.

PICCLK must always be driven with a valid clock input. and the PICD[1:0] lines must be pulled-up to 2.5 V even when the APIC will not be used. A separate pull-up resistor to 2.5 V (keep trace short) is required for each PICD line.

For reliable operation, always connect unused inputs to an appropriate signal level. Unused AGTL+ inputs should be left as no connects; AGTL+ termination on the processor provides a high level. Unused active low CMOS inputs should be connected to 2.5 V with a ~10k Ω resistor. Unused active high CMOS inputs should be connected to ground (V_{SS}). Unused outputs may be left unconnected. A resistor must be used when tying bi-directional signals to power or ground. When tying any signal to power or ground, a resistor will also allow for system testability. For correct operation when using a logic analyzer interface, refer to Section 8.0. for design considerations.

2.7. System Bus Signal Groups

In order to simplify the following discussion, the system bus signals have been combined into groups by buffer type. *All system bus outputs should be treated as open drain* and require a hi-level source provided externally by the termination or pull-up resistor.

AGTL+ input signals have differential input buffers, which use $2/3 V_{TT}$ as a reference level. AGTL+ output signals require termination to 1.5 V. In this document, the term "AGTL+ Input" refers to the AGTL+ input group as well as the AGTL+ I/O group when receiving. Similarly, "AGTL+ Output" refers to the AGTL+ output group as well as the AGTL+ I/O group when driving. The AGTL+ buffers employ active negation for one clock cycle after assertion to improve rise times.

The CMOS, Clock, APIC, and TAP inputs can each be driven from ground to 2.5 V. The CMOS, APIC, and TAP outputs are open drain and should be pulled high to 2.5 V. This ensures not only correct operation for current Pentium II Xeon processors, but compatibility for future Pentium II Xeon processor products as well. There is no active negation on CMOS outputs. ~150 Ω resistors are expected on the PICD[1:0] lines. Timings are specified into the load resistance as defined in the AC timing tables. See Section 8.0. for design considerations for debug equipment.

The SMBus signals should be driven using standard 3.3 V CMOS logic levels.

Table 3. Pentium® II Xeon™ Processor System Pin Groups

Group Name	Signals
AGTL+ Input	BPRI#, BR[3:1]#1, DEFER#, RESET#, RS[2:0]#, RSP#, TRDY#
AGTL+ Output	PRDY#
AGTL+ I/O	A[35:03]#, ADS#, AERR#, AP[1:0]#, BERR#, BINIT#, BNR#, BP[3:2]#, BPM[1:0]#, BR0#1, D[63:00]#, DBSY#, DEP[7:0]#, DRDY#, FRCERR, HIT#, HITM#, LOCK#, REQ[4:0]#, RP#
CMOS Input	A20M#, FLUSH#, IGNNE#, INIT#, LINT0/INTR, LINT1/NMI, PREQ#, PWRGOOD2, SMI#, SLP#2, STPCLK#
CMOS Output	FERR#, IERR#, THERMTRIP#2
System Bus Clock	BCLK
APIC Clock	PICCLK
APIC I/O ³	PICD[1:0]
TAP Input	TCK, TDI, TMS, TRST#
TAP Output ³	TDO
SMBus Interface	SMBDAT, SMBCLK, SMBALERT#, WP
Power/Other ⁴	V _{CC} CORE, V _{CC} L2, V _{CC} TAP, V _{CC} SMBUS, VID_L2[4:0], VID_CORE[4:0], V _{TT} , V _{SS} , TEST_25_A62, TEST_VCC_CORE, TEST_VSS, PWR_EN[1:0] ² , RESERVED_XXX, SA[2:0], SELFSB0

NOTES:

1. The BR0# pin is the only BREQ# signal that is bi-directional. The internal BREQ# signals are mapped onto BR# pins based on a processor's agent ID. See Section 9.0. for more information.
2. For information on these signals, see Section 9.0.
3. These signals are specified for 2.5 V operation.
4. V_{CC}CORE is the power supply for the Pentium® II Xeon™ processor core.
V_{CC}L2 is the power supply for the L2 cache memory.
VID_CORE[4:0], and VID_L2[4:0] pins are described in Table 2.
V_{TT} is used for the AGTL+ termination.
V_{SS} is system ground.
V_{CC}TAP is the TAP supply.
V_{CC}SMBUS is the SM bus supply.
Reserved pins must be left unconnected. Do not connect to each other.
Test Pins are described in Section 2.6.
Other signals are described in Section 9.0.

2.7.1. ASYNCHRONOUS VS. SYNCHRONOUS FOR SYSTEM BUS SIGNALS

All AGTL+ signals are synchronous to BCLK. All of the CMOS, Clock, APIC, and TAP signals can be applied asynchronously to BCLK, except when running two processors as an FRC pair. Synchronization logic is required on signals going to both processors in order to run in FRC mode. The TAP logic can not be used while a processor is running in an FRC pair, and the TAP signals should therefore be at the appropriate inactive levels for FRC operation.

Also note the timing requirements for FRC mode operation. With FRC enabled, PICCLK must be 1/4 the frequency of BCLK, synchronized with respect to BCLK, and must always lag BCLK as specified in Table 15 and Figure 8.

All APIC signals are synchronous to PICCLK. All TAP signals are synchronous to TCK. All SMBus signals are synchronous to SMBCLK. TCK and SMBCLK may always be asynchronous to all other clocks.

2.8. Test Access Port (TAP) Connection

Depending on the voltage levels supported by other components in the Test Access Port (TAP) logic, it is recommended that the Pentium II Xeon processors be first in the TAP chain and followed by any other components within the system. A voltage translation buffer should be used to drive the next device in the chain unless a 3.3 V or 5 V component is used that is capable of accepting a 2.5 V input. Similar considerations must be made for TCK, TMS, and TRST#. Multiple copies of each TAP signal may be

required if multiple voltage levels are needed within a system.

NOTE

TDI is pulled up to $V_{CC_{TAP}}$ with $\sim 150\Omega$ on the Pentium II Xeon processor cartridge. An open drain signal driving this pin must be able to deliver sufficient current to drive the signal low. Also, no resistor should exist in the system design on this pin as it would be in parallel with this resistor.

A Debug Port is described in Section 8.0. The Debug Port must be placed at the start and end of the TAP chain with TDI to the first component coming from the Debug Port and TDO from the last component going to the Debug Port. In an MP system, be cautious when including an empty SC330 connector in the scan chain. All connectors in the scan chain must have a processor or termination card installed to complete the chain between TDI and TDO or the system must support a method to bypass the empty connectors; SC330 terminator substrates should tie TDI directly to TDO. (See Section 5.0. for more details.)

2.9. Maximum Ratings

Table 4 contains Pentium II Xeon processor stress ratings. Functional operation at the absolute maximum and minimum is not implied nor guaranteed. The processor should not receive a clock while subjected to these conditions. Functional operating conditions are given in the AC and DC tables. Extended exposure to the maximum ratings may affect device reliability. Furthermore, although the processor contains protective circuitry to resist damage from static electric discharge, one should always take precautions to avoid high static voltages or electric fields.

Table 4. Pentium® II Xeon™ Processor Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Unit	Notes
T _{STORAGE}	Processor storage temperature	-40	85	°C	
V _{CCCORE}	Processor core supply voltage with respect to V _{SS}	-0.5	Operating voltage + 1.0	V	1
V _{CCL2}	Any processor L2 supply voltage with respect to V _{SS}	-0.5	Operating voltage + 1.0	V	1
V _{SMBus}	Any processor SM supply voltage with respect to V _{SS}	-0.3	Operating voltage + 1.0	V	
V _{CCTAP}	Any processor TAP supply voltage with respect to V _{SS}	-0.3	3.3	V	1
V _{CCL2} - V _{CCCORE}	L2 supply voltage with respect to core voltage.	-(Core Operating Voltage)	L2 Operating Voltage	V	1, 2
V _{inGTL}	AGTL+ buffer DC input voltage with respect to V _{SS}	-0.3	V _{CCCORE} + 0.7	V	
V _{inCMOS}	CMOS & APIC buffer DC input voltage with respect to V _{SS}	-0.3	3.3	V	
V _{inSMBus}	SMBus buffer DC input voltage with respect to V _{SS}	-0.1	6.0	V	
I _{PWR_EN}	Max PWR_EN[1:0] pin current		100	mA	
I _{VID}	Max VID pin current		5	mA	

NOTES:

1. Operating voltage is the voltage to which the component is designed to operate. See Table 5.
2. This parameter specifies that the processor will not be immediately damaged by either supply being disabled.

2.10. Processor DC Specifications

The voltage and current specifications provided in Table 5 and Table 6 are defined at the processor edge fingers. The processor signal DC specifications in Table 7, Table 8, and Table 9 are defined at the Pentium II Xeon processor core. Each signal trace between the processor edge finger and the processor core carries a small amount of current and has a finite resistance. The current produces a voltage drop between the processor edge finger and the core. Simulations should therefore be run versus these specifications to the processor core.

See Section 9.0. for the processor edge finger signal definitions and Table 3 for the signal grouping.

Most of the signals on the Pentium II Xeon processor system bus are in the AGTL+ signal group. These signals are specified to be terminated to V_{TT}. The DC specifications for these signals are listed in Table 7.

To ease connection with other devices, the Clock, CMOS, APIC, SMBus and TAP signals are designed to interface at non-AGTL+ levels. The DC specifications for these pins are listed in Table 8 and Table 9.

NOTE

Unless otherwise noted, each specification applies to all Pentium II Xeon processors. Where differences exist between Pentium II Xeon processors, look for the table entries identified by "FMB" in order to design a

Flexible Mother Board (FMB) capable of accepting all types of Pentium II Xeon processors.

Specifications are only valid while meeting specifications for case temperature, clock frequency and input voltages. **Care should be taken to read all notes associated with each parameter.**

Table 5. Voltage Specifications¹

Symbol	Parameter	Min	Typ	Max	Unit	Notes
V _{CCCORE}	V _{CC} for processor core FMB¹ All products		1.8-2.1 2.00		V	2, 3, 4
V _{CCCORE} Tolerance, Static	Processor core voltage static tolerance at edge fingers	-0.085		0.085	V	7
V _{CCCORE} Tolerance, Transient	Processor core voltage transient tolerance at edge fingers	-0.130		0.130	V	7
V _{CCL2}	V _{CC} for second level cache FMB¹ 400 MHz 450 MHz		1.8-2.8 2.5 2.7		V	3, 5
V _{CCL2} Tolerance, Static	Static tolerance at edge fingers of second level cache supply	-0.085		0.085	V	7
V _{CCL2} Tolerance, Transient	Transient tolerance at edge fingers of second level cache supply	-0.125		0.125	V	7
V _{TT}	AGTL+ bus termination voltage	1.365	1.50	1.635	V	6
V _{CCSMBus}	SMBus supply voltage	3.135	3.3	3.465	V	3.3 V±5%
V _{CCTAP}	TAP supply voltage	2.375	2.50	2.625	V	2.5 V±5%

NOTES:

1. Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes. "FMB" is a suggested design guideline for flexible motherboard design.
2. V_{CCCORE} supplies the processor core. FMB refers to the range of possible set points to expect for future Pentium® II Xeon™ processors.
3. These voltages are targets only. A variable voltage source should exist on systems in the event that a different voltage is required. See Section 2.5. for more information.
4. Use the Typical Voltage specification along with the Tolerance specifications to provide correct voltage regulation to the processor.
5. V_{CCL2} supplies the L2 cache. Unless otherwise noted, this specification applies to all Pentium II Xeon processor frequencies and cache sizes. This parameter is measured at the processor edge fingers.
6. V_{TT} must be held to 1.5 V ±9%. It is recommended that V_{TT} be held to 1.5 V ±3% while the Pentium II Xeon processor system bus is idle. This parameter is measured at the processor edge fingers. The SC330 connector is specified to have a pin self-inductance of 6.0 nH maximum, a pin-to-pin capacitance of 2 pF (maximum at 1 MHz), and an average contact resistance over the 6 V_{TT} pins of 15mΩ maximum.
7. These are the tolerance requirements, across a 20 MHz bandwidth, **at the processor edge fingers**. The requirements at the processor edge fingers account for voltage drops (and impedance discontinuities) at the processor edge fingers and to the processor core. Voltage must return to within the static voltage specification within 100 us after the transient event. The SC330 connector is specified to have a pin self-inductance of 6.0 nH maximum, a pin-to-pin capacitance of 2 pF (maximum at 1 MHz), and an average contact resistance of 15mΩ maximum in order to function with the Intel specified voltage regulator module (VRM 8.2 or VRM 8.3). Contact Intel for testing details of these parameters. Not 100% tested. Specified by design characterization.

Table 6. Current Specifications¹

Symbol	Parameter	Min	Typ	Max	Unit	Notes
I _{CC} CORE	I _{CC} for processor core FMB¹ 400 MHz 450 MHz			16.0 12.5 14.0	A	2, 5, 6, 7
I _{CC} L2	I _{CC} for second level cache FMB¹ 400 MHz, 512 KB 400 MHz, 1 MB 450 MHz, 512 KB 450 MHz 1 MB 450MHz 2 MB			9.4 3.0 6.0 3.4 6.8 8.4	A	3, 6, 7
I _{VTT}	Termination voltage supply current	0	0.3	1.2	A	8
I _{SGnt}	I _{CC} Stop Grant for processor core			0.8	A	6, 9
I _{CC} SLP	I _{CC} Sleep for processor core	0		0.2	A	6
dI _{CC} CORE/dt	Core I _{CC} slew rate (at the SC330 connector pins)			20	A/μs	10, 11
dI _{CC} L2/dt	Second level cache I _{CC} slew rate (at the SC330 connector pins)			5	A/μs	10, 11
dI _{CC} V _{TT} /dt	Termination current slew rate (at the SC330 connector pins)			5	A/μs	4, 11
I _{CC} TAP	I _{CC} for TAP power supply			100	mA	
I _{CC} SMBus	I _{CC} for SMBus power supply		3	10	mA	

NOTES:

- Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes. "FMB" is a suggested design guideline for flexible motherboard design.
- I_{CC}CORE supplies the processor core.
- Use the Typical Voltage specification with the Tolerance specifications to provide correct voltage regulation to the processor.
- V_{TT} must be held to 1.5 V ±9%. It is recommended that V_{TT} be held to 1.5 V ±3% while the Pentium® II Xeon™ processor system bus is idle. This is measured at the processor edge fingers.
- The typical I_{CC}CORE measurements are an average current draw during the execution of Winstone® 96 under the Windows® 95 operating system. These numbers are meant as a guideline only, not a guaranteed specification. Actual measurements will vary based upon system environmental conditions and configuration.
- Max I_{CC} measurements are measured at V_{CC} nominal voltage under maximum signal loading conditions.
- Voltage regulators may be designed with a minimum equivalent internal resistance to ensure that the output voltage, at maximum current output, is no greater than the nominal (i.e., typical) voltage level of V_{CC}CORE (V_{CC}CORE_{TYP}). In this case, the maximum current level for the regulator, I_{CC}CORE_{REG}, can be reduced from the specified maximum current I_{CC}CORE_{MAX} and is calculated by the equation:

$$I_{CC}CORE_{REG} = I_{CC}CORE_{MAX} \times V_{CC}CORE_{TYP} / (V_{CC}CORE_{TYP} + V_{CC}CORE_{static\ tolerance})$$
- This is the current required for a single Pentium II Xeon processor. A similar current is drawn through the termination resistors of each load on the AGTL+ bus. V_{TT} is decoupled on the S.E.C. cartridge such that negative current flow due to the active pull-up to V_{CC}CORE in the Pentium II Xeon processor will not be seen at the processor fingers.
- The current specified is also for AutoHALT state.
- Maximum values are specified by design/characterization at nominal V_{CC} and at the SC330 connector pins.
- Based on simulation and averaged over the duration of any change in current. Use to compute the maximum inductance tolerable and reaction time of the voltage regulator. This parameter is not tested.

Table 7. AGTL+ Signal Groups, DC Specifications at the Processor Core

Symbol	Parameter	Min	Max	Unit	Notes
V _{IL}	Input Low Voltage	-0.3	2/3 V _{TT} -0.1 V	V	5
V _{IH}	Input High Voltage	2/3 V _{TT} +0.1 V	V _{CCCORE}	V	1, 2, 5
R _{ONN}	nMOS On Resistance		12.5	Ω	6, 7
R _{ONP}	pMOS On Resistance		85	Ω	6
V _{OHTS}	Output High Voltage Tri-state		V _{TT}	V	1, 5
I _L	Leakage Current		±100	μA	3
I _{LO}	Output Leakage Current		±15	μA	4

NOTES:

1. Processor core parameter correlated into a 25Ω resistor to a V_{TT} of 1.5 V.
2. Excursions above V_{TT} to V_{CCCORE} are allowed.
3. (0 ≤ V_{IN} ≤ V_{CCCORE} + 5%).
4. (0 ≤ V_{OUT} ≤ V_{CCCORE} + 5%).
5. The processor core drives high for only one clock cycle. It then drives low or tri-states its outputs. V_{TT} is specified in Table 5.
6. Not 100% tested. Specified by design characterization.
7. This R_{ON} specification corresponds to a V_{OL_MAX} of 0.49 V when taken into an effective 25 ohm load to V_{TT} of 1.5 V.

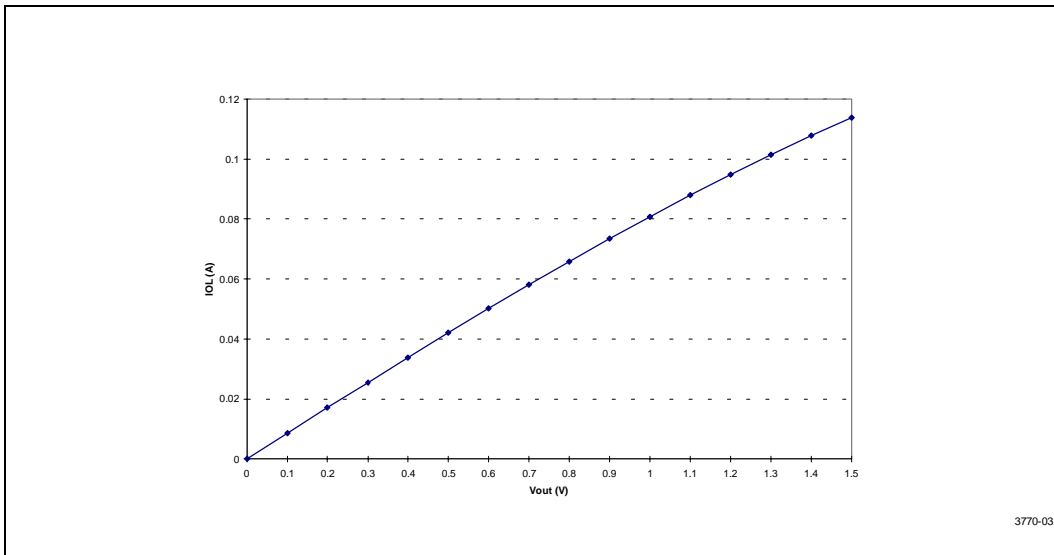


Figure 3. I-V Curve for nMOS Device

Table 8. CMOS, TAP, Clock and APIC Signal Groups, DC Specifications at the Processor Core

Symbol	Parameter	Min	Max	Unit	Notes
V _{IL}	Input Low Voltage	-0.3	0.7	V	
V _{IH}	Input High Voltage	1.7	2.625	V	2.5 V + 5% maximum
V _{OL}	Output Low Voltage		0.5	V	Measured at 24mA
V _{OH}	Output High Voltage		2.625	V	All outputs are open-drain to 2.5 V + 5%
I _{OL}	Output Low Current		24	mA	
I _{LI}	Input Leakage Current		±100	µA	1
I _{LO}	Output Leakage Current		±15	µA	2

NOTES:

1. ($0 \leq V_{IN} \leq 2.625$ V).
2. ($0 \leq V_{OUT} \leq 2.625$ V).

Table 9. SMBus Signal Group, DC Specifications at the Processor Core

Symbol	Parameter	Min	Max	Unit	Notes
V _{IL}	Input Low Voltage	-0.3	$0.3 \times V_{CCSMBus}$	V	
V _{IH}	Input High Voltage	$0.7 \times V_{CCSMBus}$	3.465	V	3.3 V + 5% maximum
V _{OL}	Output Low Voltage		0.4	V	
I _{OL}	Output Low Current		3	mA	Except SMBALERT#
I _{OL2}	Output Low Current	6		mA	SMBALERT# 1
I _{LI}	Input Leakage Current		10	µA	
I _{LO}	Output Leakage Current		10	µA	

NOTE:

1. SMBALERT# is an open drain signal.

2.11. AGTL+ System Bus Specifications

Table 10 below lists parameters controlled within the Pentium II Xeon processor to be taken into consideration during simulation. The valid high and low levels are determined by the input buffers using a reference voltage (V_{REF}) which is generated internally in the processor cartridge from V_{TT}. V_{REF} should be set to the same level for other AGTL+ logic

using a voltage divider on the motherboard. It is important that the motherboard impedance be specified and held to a ±10% tolerance, and that the intrinsic trace capacitance for the AGTL+ signal group traces is known and well-controlled. For more details on AGTL+, see the *Pentium® II Processor Developer's Manual*, the *100 MHz 2-Way SMP Pentium® II Xeon™ Processor/Intel® 440GX AGPset AGTL+ Layout Guidelines* and *Pentium® II Xeon™ Processor/Intel® 450NX PCIset AGTL+ Layout Guidelines*.



Table 10. Pentium® II Xeon™ Processor Internal Parameters for the AGTL+ Bus

Symbol	Parameter	Min	Typ	Max	Units	Notes
R _{TT}	Termination Resistor		150		Ω	1
V _{REF}	Bus Reference Voltage		2/3 V _{TT}		V	2

NOTES:

1. The Pentium® II Xeon™ processor contains 1% AGTL+ termination resistors at the end of the signal trace on the processor substrate.
2. V_{REF} is generated on the processor substrate.

2.12. System Bus AC Specifications

The system bus timings specified in this section are defined at the Pentium II Xeon processor core pins unless otherwise noted. Timings are tested at the processor core during manufacturing. Timings at the processor edge fingers are specified by design characterization. Information regarding signal characteristics between the processor core pins and the processor edge fingers is found in the *Pentium® II Xeon™ Processor I/O Buffer Models*, Quad Format.

See Section 9.0. for the Pentium II Xeon processor edge connector signal definitions.

NOTE

Timing specifications T45-T49 are reserved for future use.

All system bus AC specifications for the AGTL+ signal group are relative to the rising edge of the BCLK input at 1.25 V. All AGTL+ timings are referenced to 2/3 V_{TT} for both '0' and '1' logic levels unless otherwise specified.

Table 11. System Bus AC Specifications (Clock) at the Processor Core

T#	Parameter	Min	Nom	Max	Unit	Figure	Notes
	System Bus Frequency	90.00		100.00	MHz		1, 2
T1:	BCLK Period	10.0		11.11	ns	4	3
T2:	BCLK Period Stability			150	ps	4	4, 5, 6
T3:	BCLK High Time	2.5			ns	4	@>2.0 V
T4:	BCLK Low Time	2.5			ns	4	@<0.5 V
T5:	BCLK Rise Time	0.5		1.5	ns	4	(0.5 V–2.0 V) ⁷
T6:	BCLK Fall Time	0.5		1.5	ns	4	(2.0 V–0.5 V) ⁷

NOTES:

1. Table 1 shows the supported ratios for each processor.
2. Minimum System Bus Frequency is not 100% tested. Specified by design characterization to allow lower speed system bus operation for up to 6 load systems.
3. The BCLK period allows a +0.3 ns tolerance for clock driver and routing variation. BCLK must be within specification whenever PWRGOOD is asserted.
4. It is recommended that a clock driver be used that is designed to meet the period stability specification into a test load of 10 to 20 pF. Cycle-to-cycle jitter should be measured on adjacent rising edges of BCLK crossing 1.25 V at the processor core. This cycle-to-cycle jitter present must be accounted for as a component of flight time between the processor(s) and/or core logic components. Positive or negative jitter of up to 150 ps is allowed between adjacent cycles. Positive or negative jitter of up to 250 ps is tolerated, but will result in up to 100 ps of AGTL+ I/O and CMOS timing degradation (i.e., timing parameters T7-9 and T11-13 will all increase by 100 ps). Thus a system with jitter of 250 ps would need flight times that are 300 ps (100 ps additional jitter + 100 ps I/O timing degradation for both the source and receiver) better than a system with jitter of 150 ps.
5. The clock driver's closed loop jitter bandwidth should be less than 500 kHz (at -20dB). The bandwidth must be set low to allow cascade connected PLL-based devices to track clock drivers with the specified jitter. Therefore the bandwidth of the clock driver's output frequency-attenuation plot should be less than 500 kHz measured at the -20 dB attenuation point. The test load should be 10 to 20 pF.
6. See the *100 MHz 2-Way SMP Pentium® II Xeon™ Processor/Intel® 440GX AGPset AGTL+ Layout Guidelines* or the *Pentium® II Xeon™ Processor/Intel® 450NX PCIset AGTL+ Layout Guidelines* for additional recommendations.
7. Not 100% tested. Specified by design characterization as a clock driver requirement.

Table 12. AGTL+ Signal Groups, System Bus AC Specifications at the Processor Core¹

R _L = 25Ω Terminated to 1.5 V						
T#	Parameter	Min	Max	Unit	Figure	Notes
T7:	AGTL+ Output Valid Delay	0.2	2.7	ns	6	2
T8:	AGTL+ Input Setup Time	1.75		ns	7	3, 4, 5
T9:	AGTL+ Input Hold Time	0.62		ns	7	5
T10:	RESET# Pulse Width	1.00		ms	10	6

NOTES:

1. These specifications are tested during manufacturing.
2. Valid delay timings for these signals at the processor core are correlated into 25Ω termination to 1.5 V and with V_{TT} set to 1.5 V.
3. A minimum of 3 clocks must be guaranteed between two active-to-inactive transitions of TRDY#.
4. RESET# can be asserted (active) asynchronously, but must be deasserted synchronously.
5. The signal at the processor core must transition monotonically through the overdrive region (2/3 V_{TT} ± 200mV).
6. After the bus ratio on A20M#, IGNNE# and LINT[1:0] are stable, V_{CC}CORE, V_{CC}L2 and BCLK are within specification, and PWRGOOD is asserted. See Figure 10.

Table 13. CMOS, TAP, Clock and APIC Signal Groups, AC Specifications at the Processor Core^{1, 2}

T#	Parameter	Min	Max	Unit	Figure	Notes
T11:	CMOS Output Valid Delay	1	8	ns	6	3
T12:	CMOS Input Setup Time	4		ns	7	4, 5
T13:	CMOS Input Hold Time	1		ns	7	4
T14:	CMOS Input Pulse Width, except PWRGOOD and LINT[1:0]	2		BCLKs	6	Active and Inactive states
T14B:	LINT[1:0] Input Pulse Width	6		BCLKs	5	6
T15:	PWRGOOD Inactive Pulse Width	10		BCLKs	6 11	7, 8

NOTES:

1. These specifications are tested during manufacturing.
2. These signals may be driven asynchronously but must be driven synchronously in FRC mode.
3. Valid delay timings for these signals are specified into 100Ω to 2.5 V.
4. To ensure recognition on a specific clock, the setup and hold times with respect to BCLK must be met.
5. INTR and NMI are only valid when the local APIC is disabled. LINT[1:0] are only valid when the local APIC is enabled.
6. This specification only applies when the APIC is enabled and the LINT1 or LINT0 pin is configured as an edge triggered interrupt with fixed delivery, otherwise specification T14 applies.
7. When driven inactive or after V_{CC}CORE, V_{CC}L2 and BCLK become stable. PWRGOOD must remain below V_{IL}_MAX from Table 8 until all the voltage planes meet the voltage tolerance specifications in Table 5 and BCLK has met the BCLK AC specifications in Table 11 for at least 10 clock cycles. PWRGOOD must rise glitch-free and monotonically to 2.5 V.
8. If the BCLK signal meets its AC specification within 150 ns of turning on then the PWRGOOD Inactive Pulse Width specification is waived and BCLK may start after PWRGOOD is asserted. PWRGOOD must still remain below V_{IL}_MAX until all the voltage planes meet the voltage tolerance specifications.

Table 14. System Bus AC Specifications (Reset Conditions)

T#	Parameter	Min	Max	Unit	Figure	Notes
T16:	Reset Configuration Signals (A[14:05]#, BR0#, FLUSH#, INIT#) Setup Time	4		BCLKs	10	Before deassertion of RESET
T17:	Reset Configuration Signals (A[14:05]#, BR0#, FLUSH#, INIT#) Hold Time	2	20	BCLKs	10	After clock that deasserts RESET#
T18:	Reset Configuration Signals (A20M#, IGNNE#, LINT[1:0]) Setup Time	1		ms	10	Before deassertion of RESET#
T19:	Reset Configuration Signals (A20M#, IGNNE#, LINT[1:0]) Delay Time		5	BCLKs	10	After assertion of RESET# 1
T20:	Reset Configuration Signals (A20M#, IGNNE#, LINT[1:0]#) Hold Time	2	20	BCLKs	10 11	After clock that deasserts RESET#

NOTE:

1. For a Reset, the clock ratio defined by these signals must be a safe value (their final or lower multiplier) within this delay unless PWRGOOD is being driven inactive.

Table 15. System Bus AC Specifications (APIC Clock and APIC I/O) at the Processor Core¹

T#	Parameter	Min	Max	Unit	Figure	Notes
T21:	PICCLK Frequency	2.0	33.3	MHz		2
T21B:	FRC Mode BCLK to PICCLK Offset	1.0	4.0	ns	8	2
T22:	PICCLK Period	30.0	500.0	ns	4	
T23:	PICCLK High Time	12.0		ns	4	
T24:	PICCLK Low Time	12.0		ns	4	
T25:	PICCLK Rise Time	0.25	3.0	ns	4	
T26:	PICCLK Fall Time	0.25	3.0	ns	4	
T27:	PICD[1:0] Setup Time	8.0		ns	7	3
T28:	PICD[1:0] Hold Time	2.5		ns	7	3
T29:	PICD[1:0] Valid Delay	1.5	10.0	ns	6	3, 4, 5

NOTES:

1. These specifications are tested during manufacturing.
2. With FRC enabled PICCLK must be 1/4 of BCLK and synchronized with respect to BCLK.
3. Referenced to PICCLK rising edge.
4. For open drain signals, valid delay is synonymous with float delay.
5. Valid delay timings for these signals are specified to 2.5 V.



Table 16. System Bus AC Specifications (TAP Connection) at the Processor Core¹

T#	Parameter	Min	Max	Unit	Figure	Notes
T30:	TCK Frequency		16.667	MHz		
T31:	TCK Period	60.0		ns	4	
T32:	TCK High Time	25.0		ns	4	@1.7 V ²
T33:	TCK Low Time	25.0		ns	4	@0.7 V ²
T34:	TCK Rise Time	3.0	5.0	ns	4	(0.7 V–1.7 V) ^{2, 3}
T35:	TCK Fall Time	3.0	5.0	ns	4	(1.7 V–0.7 V) ^{2, 3}
T36:	TRST# Pulse Width	40.0		ns	12	Asynchronous ²
T37:	TDI, TMS Setup Time	5.0		ns	11	4
T38:	TDI, TMS Hold Time	14.0		ns	11	4
T39:	TDO Valid Delay	1.0	10.0	ns	11	5, 6
T40:	TDO Float Delay		25.0	ns	11	2, 5, 6
T41:	All Non-Test Outputs Valid Delay	2.0	25.0	ns	11	5, 7, 8
T42:	All Non-Test Inputs Setup Time		25.0	ns	11	2, 5, 7, 8
T43:	All Non-Test Inputs Setup Time	5.0		ns	11	4, 7, 8
T44:	All Non-Test Inputs Hold Time	13.0		ns	11	4, 7, 8

NOTES:

1. Unless otherwise noted, these specifications are tested during manufacturing.
2. Not 100% tested. Specified by design characterization.
3. 1 ns can be added to the maximum TCK rise and fall times for every 1 MHz below 16.667 MHz.
4. Referenced to TCK rising edge.
5. Referenced to TCK falling edge.
6. Valid delay timing for this signal is specified to 2.5 V.
7. Non-Test Outputs and Inputs are the normal output or input signals (besides TCK, TRST#, TDI, TDO and TMS). These timings correspond to the response of these signals due to TAP operations.
8. During Debug Port operation, use the normal specified timings rather than the TAP signal timings.

Table 17. SMBus Signal Group, AC Specifications at the Edge Fingers

T#	Parameter	Min	Max	Unit	Figure	Notes
T50:	SMBCLK Frequency		100	kHz		
T51:	SMBCLK Period	10		μs	5	
T52:	SMBCLK High Time	4.0		μs	5	
T53:	SMBCLK Low Time	4.7		μs	5	
T54:	SMBCLK Rise Time		1.0	μs	5	
T55:	SMBCLK Fall Time		0.3	μs	5	
T56:	SMBus Output Valid Delay		1.0	μs	6	
T57:	SMBus Input Setup Time	250		ns	7	
T58:	SMBus Input Hold Time	0		ns	7	
T59:	Bus Free Time	4.7		μs		1

NOTE:

1. Minimum time allowed between request cycles.

Figure 4 through Figure 12 are to be used in conjunction with the DC specification and AC timings tables.

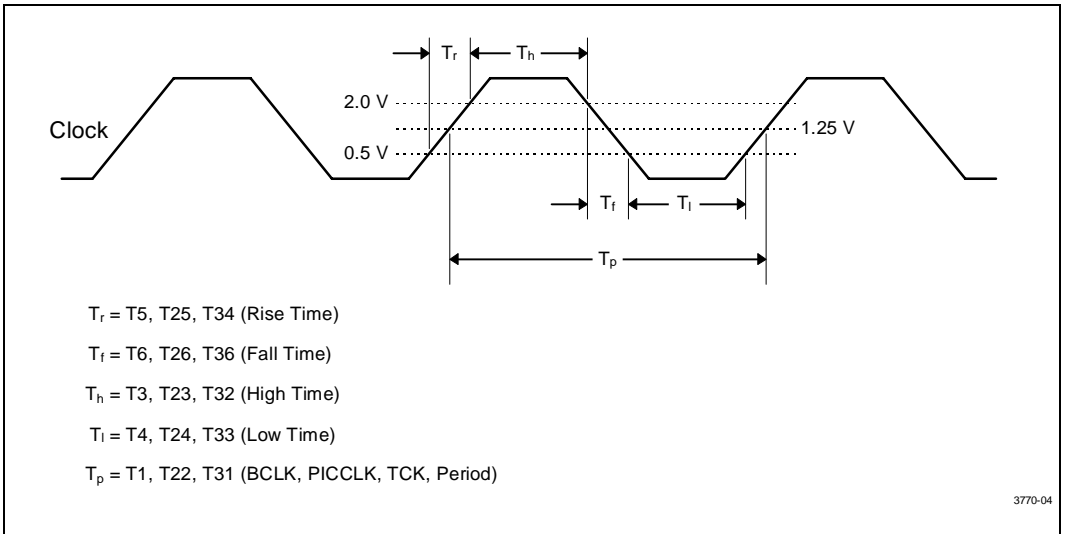


Figure 4. BCLK, PICCLK, TCK Generic Clock Waveform

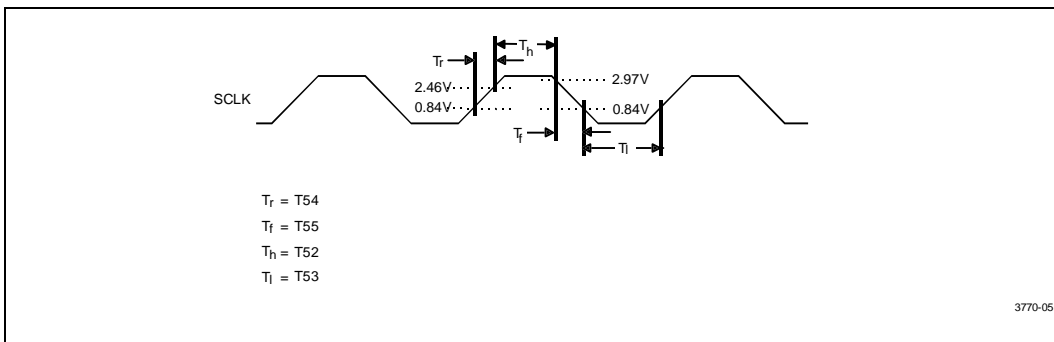


Figure 5. SMBCLK Clock Waveform

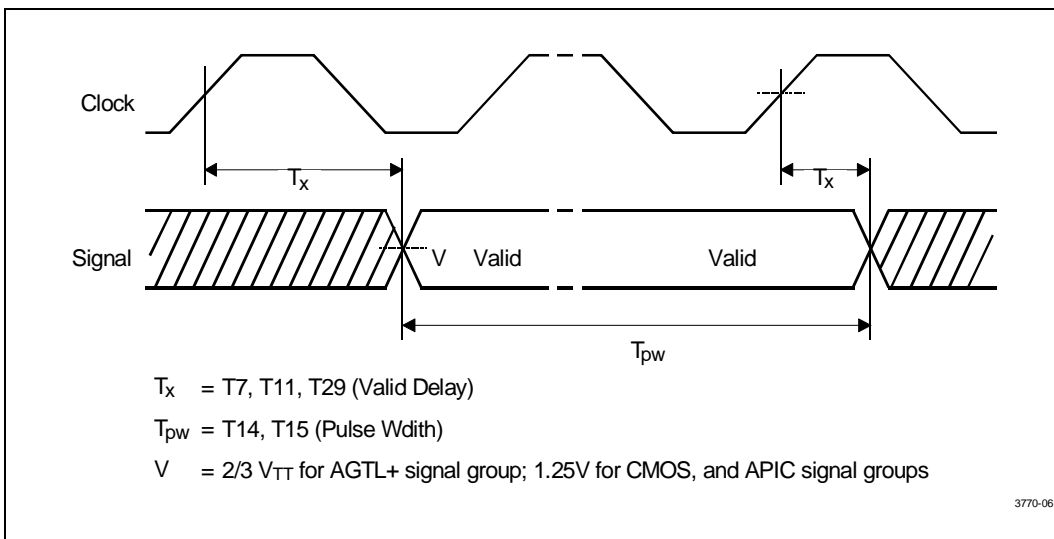


Figure 6. Valid Delay Timings

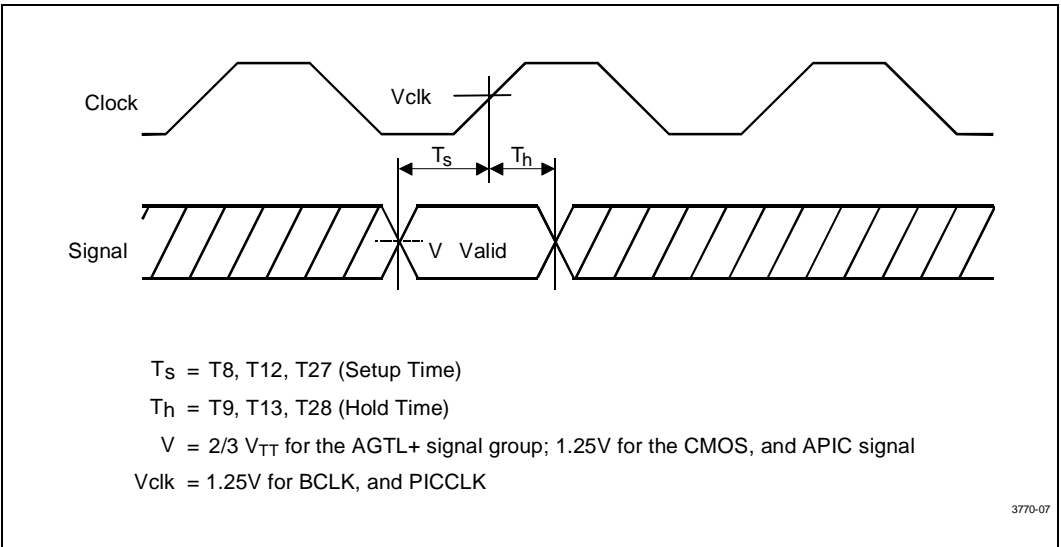


Figure 7. Setup and Hold Timings

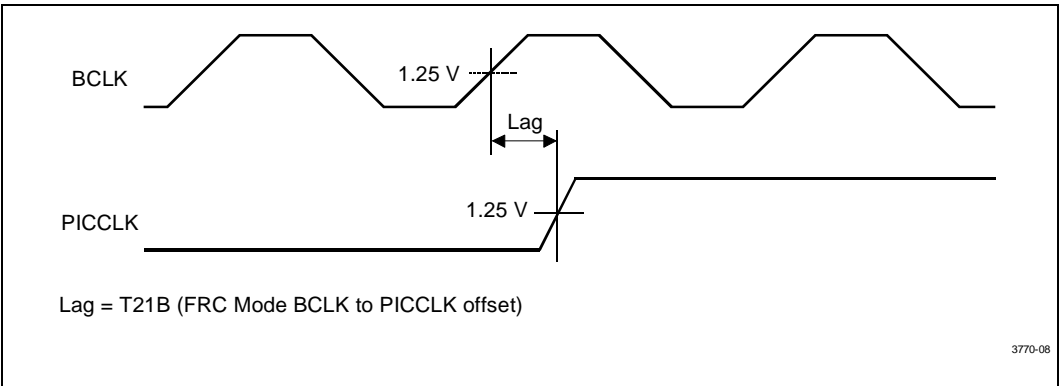


Figure 8. FRC Mode BCLK to PICCLK Timing

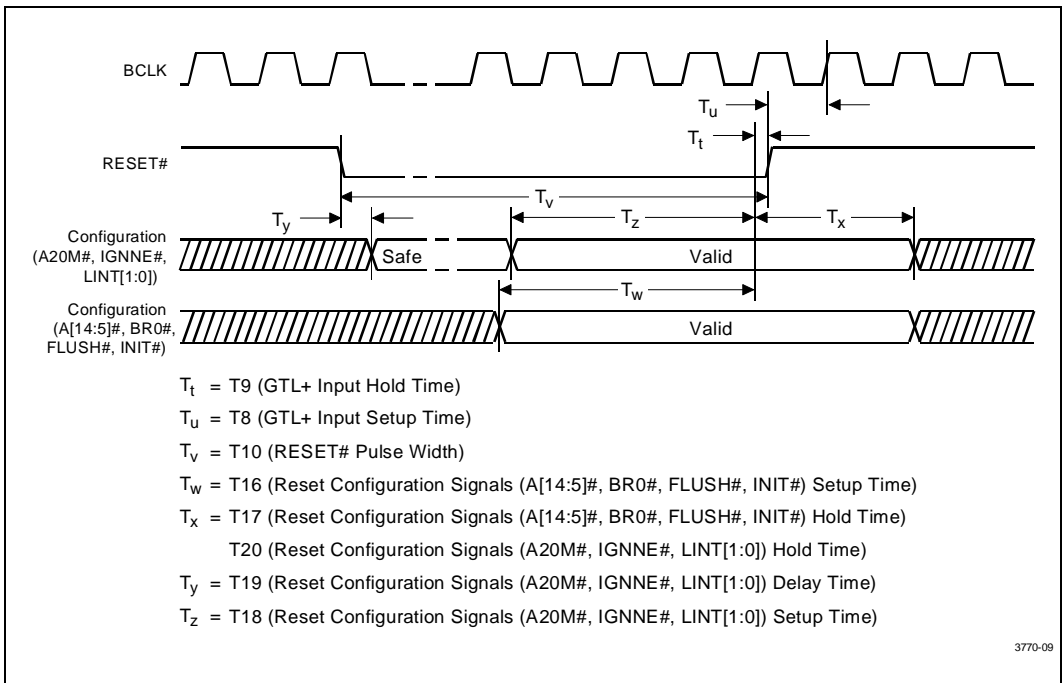


Figure 9. System Bus Reset and Configuration Timings

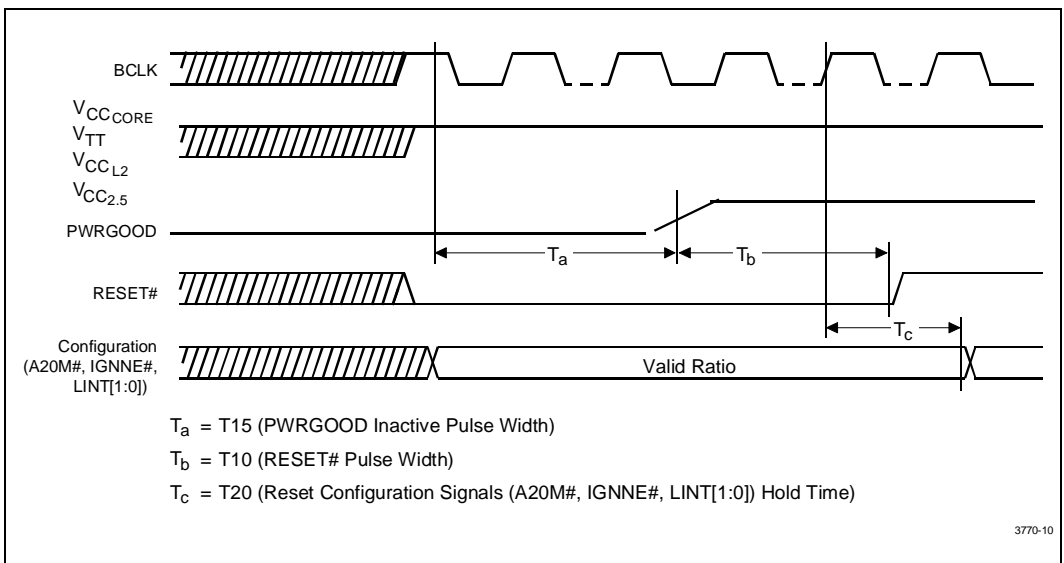


Figure 10. Power-On Reset and Configuration Timings

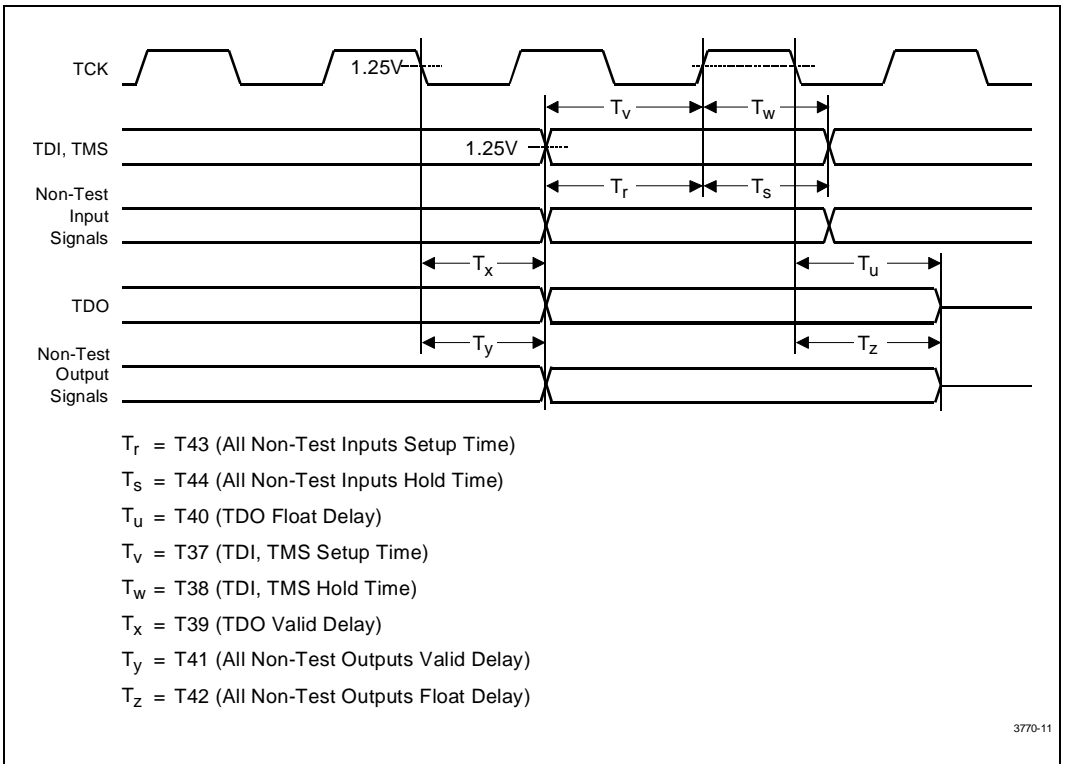


Figure 11. Test Timings (Boundary Scan)

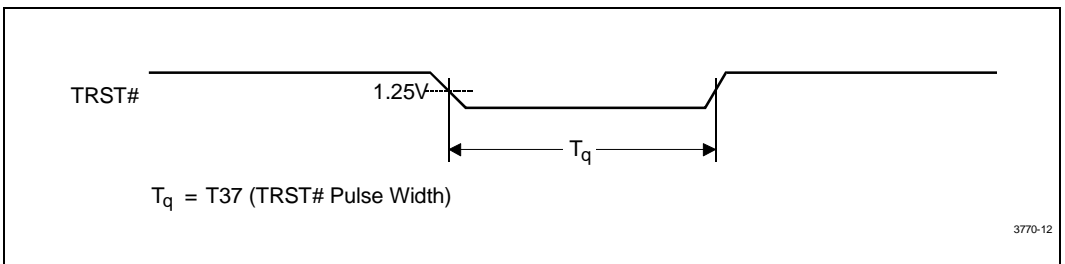


Figure 12. Test Reset Timings

3.0. SIGNAL QUALITY

Signals driven on the Pentium II Xeon processor system bus should meet signal quality specifications to ensure that the components read data properly and to ensure that incoming signals do not affect the

long term reliability of the component. Specifications are provided for simulation at the processor core. Meeting the specifications at the processor core in Table 18 through Table 22 ensures that signal quality effects will not adversely affect processor operation.

3.1. System Bus Clock Signal Quality Specifications

processor system bus clock (BCLK) signal. Figure 13 shows the signal quality waveform for the system bus clock at the processor core pads. Please see Table 11 for the definition of T numbers and Table 18 for the definition of V numbers.

Table 18 describes the signal quality specifications at the processor core pad for the Pentium II Xeon

Table 18. BCLK Signal Quality Specifications for Simulation at the Processor Core¹

V#	Parameter	Min	Nom	Max	Unit	Figure	Notes
V1:	BCLK V_{IL}			0.7	V	13	
V2:	BCLK V_{IH}	1.7			V	13	
V3:	V_{IN} Absolute Voltage Range	-0.7		3.3	V	13	
V4:	Rising Edge Ringback	1.7			V	13	2
V5:	Falling Edge Ringback			0.7	V	13	2

NOTES:

1. Unless otherwise noted, all specifications in this table apply to all Pentium® II Xeon™ processor frequencies and cache sizes.
2. The rising and falling edge ringback voltage specified is the minimum (rising) or maximum (falling) absolute voltage the BCLK signal can dip back to after passing the V_{IH} (rising) or V_{IL} (falling) voltage limits. This specification is an absolute value.

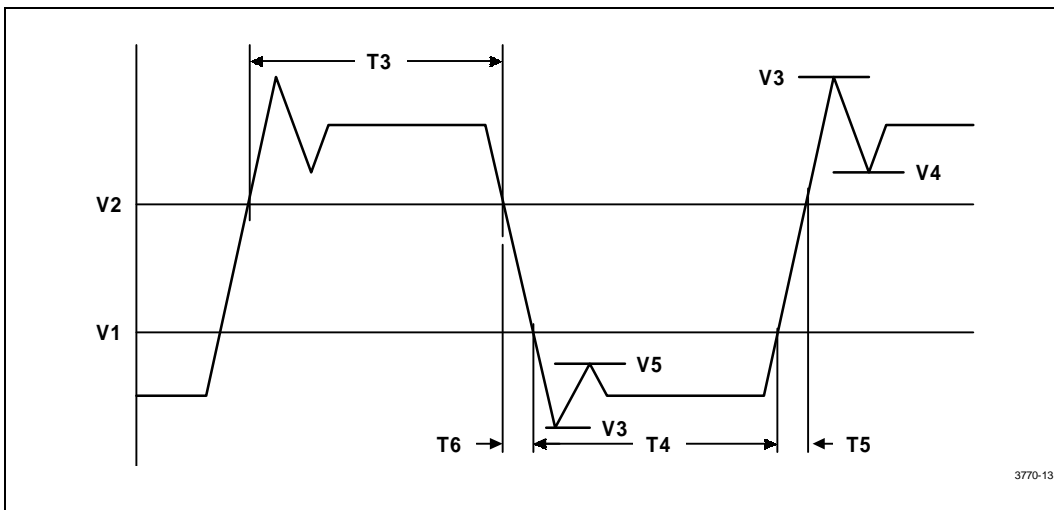


Figure 13. BCLK, TCK, PICCLK Generic Clock Waveform at the Processor Core Pins

3.2. AGTL+ Signal Quality Specifications

Many scenarios have been simulated to generate a set of AGTL+ layout guidelines which are available in the *100 MHz 2-Way SMP Pentium® II Xeon™ Processor/Intel® 440GX AGPset AGTL+ Layout Guidelines* and *Pentium® II Xeon™ Processor/Intel® 450NX PCIset AGTL+ Layout Guidelines*. Also refer to the *Pentium® II Processor Developer's Manual* for the specification for GTL+.

3.2.1. AGTL+ RINGBACK TOLERANCE SPECIFICATIONS

Table 19 provides the AGTL+ signal quality specifications for Pentium II Xeon processors for use in simulating signal quality at the processor core pads. Figure 14 describes the signal quality waveform for AGTL+ signals at the processor core pads. For more information on the AGTL+ interface, see the *Pentium® II Processor Developer's Manual*.

Table 19. AGTL+ Signal Groups Ringback Tolerance Specifications at the Processor Core^{1, 2, 3}

T#	Parameter	Min	Unit	Figure	Notes
α :	Overshoot	100	mV	14	
τ :	Minimum Time at High	0.50	ns	14	
ρ :	Amplitude of Ringback	-20	mV	14	4, 5
ϕ :	Final Settling Voltage	20	mV	14	
δ :	Duration of Squarewave Ringback	N/A	ns	14	

NOTES:

1. Unless otherwise noted, all specifications in this table apply to all Pentium® II Xeon™ processor frequencies and cache sizes.
2. Specifications are for the edge rate of 0.3 - 0.8 V/ns.
3. All values specified by design characterization.
4. Ringback below $2/3 V_{TT} + 20$ mV is not supported.
5. Intel recommends performing simulations using a ρ (rho) of -100 mV to allow margin for other sources of system noise.

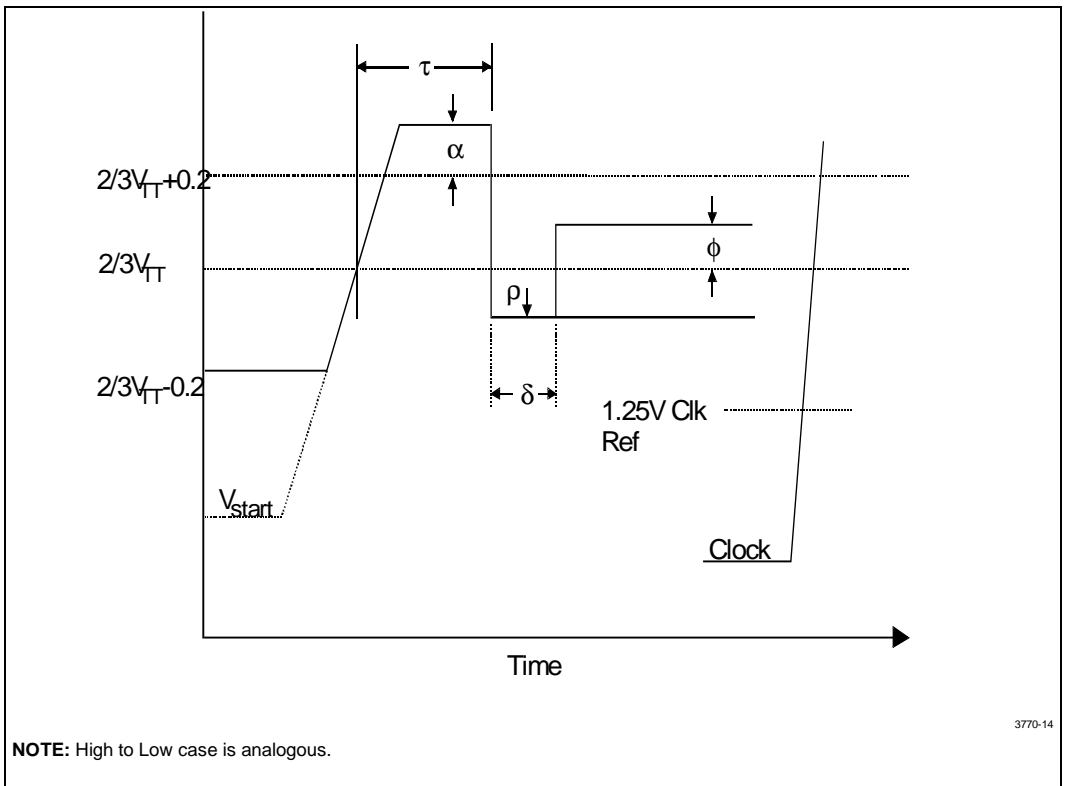


Figure 14. Low to High AGTL+ Receiver Ringback Tolerance

3.2.2. AGTL+ OVERSHOOT/UNDERSHOOT GUIDELINES

The overshoot/undershoot guideline limits transitions beyond V_{CC} or V_{SS} due to fast signal edge rates.

(Overshoot shown in Figure 15 for non-AGTL+ signals can also be applied to AGTL+ signals.) The processor can be damaged by repeated overshoot or undershoot events if great enough. The overshoot/undershoot guideline is shown in Table 20.

Table 20. AGTL+ Overshoot/Undershoot Guidelines at the Processor Core

Guideline	Transition	Signal Must Maintain	Unit	Figure
Overshoot	0 → 1	< 2.7	V	15
Undershoot	1 → 0	> -0.7	V	15

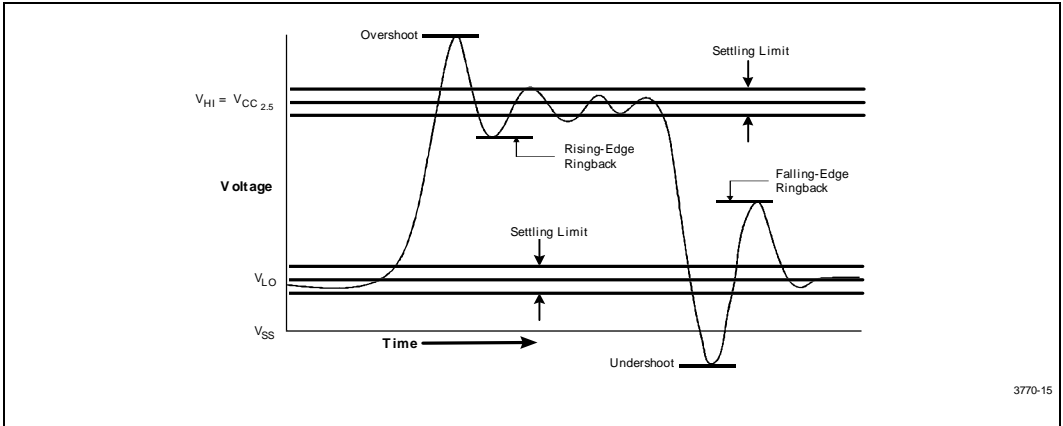


Figure 15. Non-AGTL+ Overshoot/Undershoot, Settling Limit, and Ringback

3.3. Non-AGTL+ Signal Quality Specifications

There are three signal quality parameters defined for non-AGTL+ signals: overshoot/undershoot, ringback, and settling limit. All three signal quality parameters are shown in Figure 15 for the non-AGTL+ signal group at the processor core pads.

3.3.1. 2.5 V TOLERANT BUFFER OVERSHOOT/UNDERSHOOT GUIDELINES

The overshoot/undershoot guideline limits transitions beyond V_{CC} or V_{SS} due to fast signal edge rates. (See Figure 15 for non-AGTL+ signals.) The processor can be damaged by repeated overshoot or undershoot events on 2.5 V tolerant buffers if great enough. The overshoot/undershoot guideline is shown in Table 21.

Table 21. 2.5 V Tolerant Signal Overshoot/Undershoot Guidelines at the Processor Core

Guideline	Transition	Signal Must Maintain	Unit	Figure
Overshoot	0 → 1	< 3.2	V	15
Undershoot	1 → 0	> -0.3	V	15

Table 22. Signal Ringback Specifications for 2.5 V Tolerant Signal Simulation at the Processor Core

Input Signal Group	Transition	Maximum Ringback (with Input Diodes Present)	Unit	Figure
Non-AGTL+ Signals	0 → 1	1.7	V	15
Non-AGTL+ Signals	1 → 0	0.7	V	15

3.3.2. 2.5 V TOLERANT BUFFER RINGBACK SPECIFICATION

The ringback specification is *the voltage at a receiving pin that a signal rings back to after achieving its maximum absolute value.* (See Figure 15 for an illustration of ringback.) Excessive ringback can cause false signal detection or extend the propagation delay. Violations of the signal ringback specification are not allowed for 2.5 V tolerant signals.

Table 22 shows signal ringback specifications for the 2.5 V tolerant signals to be used for simulations at the processor core.

3.3.3. 2.5 V TOLERANT BUFFER SETTLING LIMIT GUIDELINE

Settling limit defines the maximum amount of ringing at the receiving pin that a signal must reach before its next transition. The amount allowed is 10% of the total signal swing ($V_{HI} - V_{LO}$) above and below its final value. A signal should be within the settling limits of its final value, when either in its high state or low state, before it transitions again.

Violation of the settling limit guideline is acceptable if simulations of 5 to 10 successive transitions do not show the amplitude of the ringing increasing in the subsequent transitions.

4.0. PROCESSOR FEATURES

4.1. Functional Redundancy Checking Mode

Two Pentium II Xeon processor agents may be configured as an FRC (functional redundancy checking) pair. In this configuration, one processor acts as the master and the other acts as a checker, and the pair operates as a single processor. If the checker agent detects a mismatch between its internally sampled outputs and the master processor's outputs, the checker asserts FRCERR. FRCERR observation can be enabled at the master processor with software. The master enters machine check on an FRCERR provided that Machine Check Execution is enabled.

Processors configured as FRC pairs must be of the same frequency, stepping, and cache size.

ITP operation is not supported in FRC mode.

Systems configured to implement FRC mode must write all of the processors' internal MSRs to deterministic values before performing either a read or read-modify-write operation using these registers. The following is a list of MSRs that are not initialized by the processors' reset sequences.

1. All fixed and variable MTRRs,
2. All Machine Check Architecture (MCA) status registers,

3. Microcode Update signature register, and
4. All L2 Cache initialization MSRs.

4.2. Low Power States and Clock Control

The Pentium II Xeon processor allows the use of Auto HALT, Stop-Grant, and Sleep states to reduce power consumption by stopping the clock to specific internal sections of the processor, depending on each particular state. There is no Deep Sleep state on the Pentium II Xeon processor. Refer to for the following sections on low power states for the Pentium II Xeon processor.

For the processor to fully realize the low current consumption of the Stop Grant, and Sleep states, an MSR bit must be set. For the MSR at 02AH (Hex), bit 26 must be set to a '1' (power on default is a '0') for the processor to stop all internal clocks during these modes. For more information, see the *Pentium® Pro Processor Family Developer's Manual*.

Due to not being able to recognize bus transactions during Sleep state, SMP systems are not allowed to have one or more processors in Sleep state and other processors in Normal or Stop Grant states simultaneously.

4.2.1. NORMAL STATE—STATE 1

This is the normal operating state for the processor.

4.2.2. AUTO HALT POWER DOWN STATE—STATE 2

Auto HALT is a low power state entered when the Pentium II Xeon processor executes the HALT instruction. The processor will issue a normal HALT bus cycle on BE[7:0]# and REQ[4:0]# when entering this state. The processor will transition to the Normal state upon the occurrence of SMI#, BINIT#, INIT#, or LINT[1:0] (NMI, INTR). RESET# will cause the processor to immediately initialize itself.

SMI# will cause the processor to execute the SMI handler. The return from the SMI handler can be to either Normal Mode or the Auto HALT Power Down state. See Chapter 11 in the *Intel Architecture Software Developer's Manual, Volume III: System Programming Guide*.

FLUSH# will be serviced during Auto HALT state. The on-chip first level caches and external second level cache will be flushed and the processor will return to the Auto HALT state.

A20M# will be serviced during Auto HALT state; the processor will mask physical address bit 20 (A20#) before any look-up in either the on-chip first level caches or external second level cache, and before a read/write transaction is driven on the bus.

The system can generate a STPCLK# while the processor is in the Auto HALT Power Down state. The processor will generate a Stop Grant bus cycle when it enters the Stop Grant state from the HALT state. If the processor enters the Stop Grant state from the Auto HALT state, the STPCLK# signal must be deasserted before any interrupts are serviced (see below). When the system deasserts the STPCLK# interrupt signal, the processor will return execution to the HALT state. The processor will not generate a new HALT bus cycle when it re-enters the HALT state from the Stop Grant state.

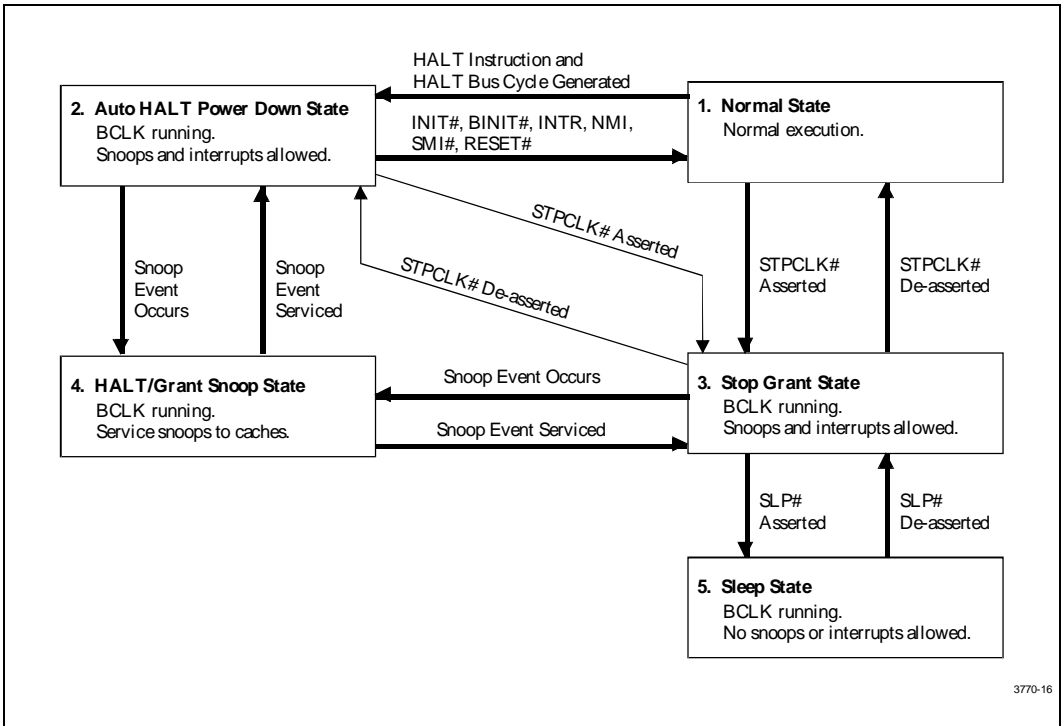


Figure 16. Stop Clock State Machine

4.2.3. STOP-GRANT STATE—STATE 3

The Stop-Grant state on the Pentium II Xeon processor is entered when the STPCLK# signal is asserted. The Pentium II Xeon processor will issue a Stop-Grant Transaction Cycle. Exit latency from this mode is 10 BCLK periods after the STPCLK# signal is deasserted.

Since the AGTL+ signal pins receive power from the system bus, these pins should not be driven (allowing the level to return to V_{TT}) for minimum power drawn by the termination resistors in this state. In addition, all other input pins on the system bus should be driven to the inactive state.

BINIT# will not be serviced while the processor is in Stop-Grant state. The event will be latched and can be serviced by software upon exit from Stop-Grant state.

FLUSH# will not be serviced during Stop Grant state.

RESET# will cause the processor to immediately initialize itself; but the processor will stay in Stop Grant state. A transition back to the Normal state will occur with the deassertion of the STPCLK# signal.

A transition to the HALT/Grant Snoop state will occur when the processor detects a snoop phase on the system bus. A transition to the Sleep state will occur with the assertion of the SLP# signal.

While in the Stop Grant State, all other interrupts will be latched by the Pentium II Xeon processor, and only serviced when the processor returns to the Normal State.

4.2.4. HALT/GRANT SNOOP STATE—STATE 4

The Pentium II Xeon processor will respond to snoop phase transactions (initiated by ADS#) on the system

bus while in Stop-Grant state or in Auto HALT Power Down state. When a snoop transaction is presented upon the system bus, the processor will enter the HALT/Grant Snoop state. The processor will stay in this state until the snoop on the system bus has been serviced (whether by the processor or another agent on the system bus). After the snoop is serviced, the processor will return to the Stop-Grant state or Auto HALT Power Down state, as appropriate.

4.2.5. SLEEP STATE—STATE 5

The Sleep state is a very low power state in which the processor maintains its context, maintains the PLL, and has stopped all internal clocks. The Sleep state can only be entered from Stop-Grant state. Once in the Stop-Grant state (verified by the termination of the Stop-Grant Bus transaction cycle), the SLP# pin can be asserted, causing the Pentium II Xeon processor to enter the Sleep state. The system must wait 100 BCLK cycles after the completion of the Stop-Grant Bus cycle before SLP# is asserted. For an MP system, all processors must complete the Stop Grant bus cycle before the subsequent 100 BCLK wait and assertion of SLP# can occur. The processor is in Sleep state 10 BCLKs after the assertion of the SLP# pin. The latency to exit the Sleep state is 10 BCLK cycles. The SLP# pin is not recognized in the Normal, or Auto HALT States.

Snoop events that occur during a transition into or out of Sleep state will cause unpredictable behavior. Therefore, transactions should be blocked by system logic during these transitions.

In the Sleep state, the processor is incapable of responding to snoop transactions or latching interrupt signals immediately after the assertion of the SLP# pin (one exception is RESET# which causes the processor to re-initialize itself). The system core logic must detect these events and deassert the SLP# signal (and subsequently deassert the STPCLK# signal for interrupts) for the processor to correctly interpret any bus transaction or signal transition. Once in the Sleep state, the SLP# pin can be deasserted if another asynchronous event occurs.

No transitions or assertions of signals are allowed on the system bus while the Pentium II Xeon processor is in Sleep state. Any transition on an input signal (with the exception of SLP# or RESET#) before the processor has returned to Stop Grant state will result in unpredictable behavior.

If RESET# is driven active while the processor is in the Sleep state, and held active as specified in the RESET# pin specification, then the processor will reset itself, ignoring the transition through Stop Grant State. If RESET# is driven active while the processor is in the Sleep State and normal operation is desired, the SLP# and STPCLK# should be deasserted immediately after RESET# is asserted.

4.2.6. CLOCK CONTROL

The Pentium II Xeon processor provides the clock signal to the L2 Cache. The processor does not stop this clock to the second level cache during Auto HALT Power Down or Stop-Grant states. During Auto HALT Power Down and Stop-Grant states, the processor will continue to process the snoop phase of a system bus cycle. The PICCLK signal should not be removed during the Auto HALT Power Down or Stop-Grant states.

When the processor is in the Sleep state, it will not respond to interrupts or snoop transactions. PICCLK can be removed during the Sleep state.

The processor will not enter any low power states until all internal queues for the second level cache are empty. When re-entering Normal state, the processor will resume processing external cache requests as soon as new requests are encountered.

4.3. System Management Bus (SMBus) Interface

The Pentium II Xeon processor includes an SMBus interface which allows access to several processor features, including two memory components (referred to as the Processor Information ROM and the Scratch EEPROM) and a thermal sensor on the Pentium II Xeon processor substrate. These devices and their features are described below.

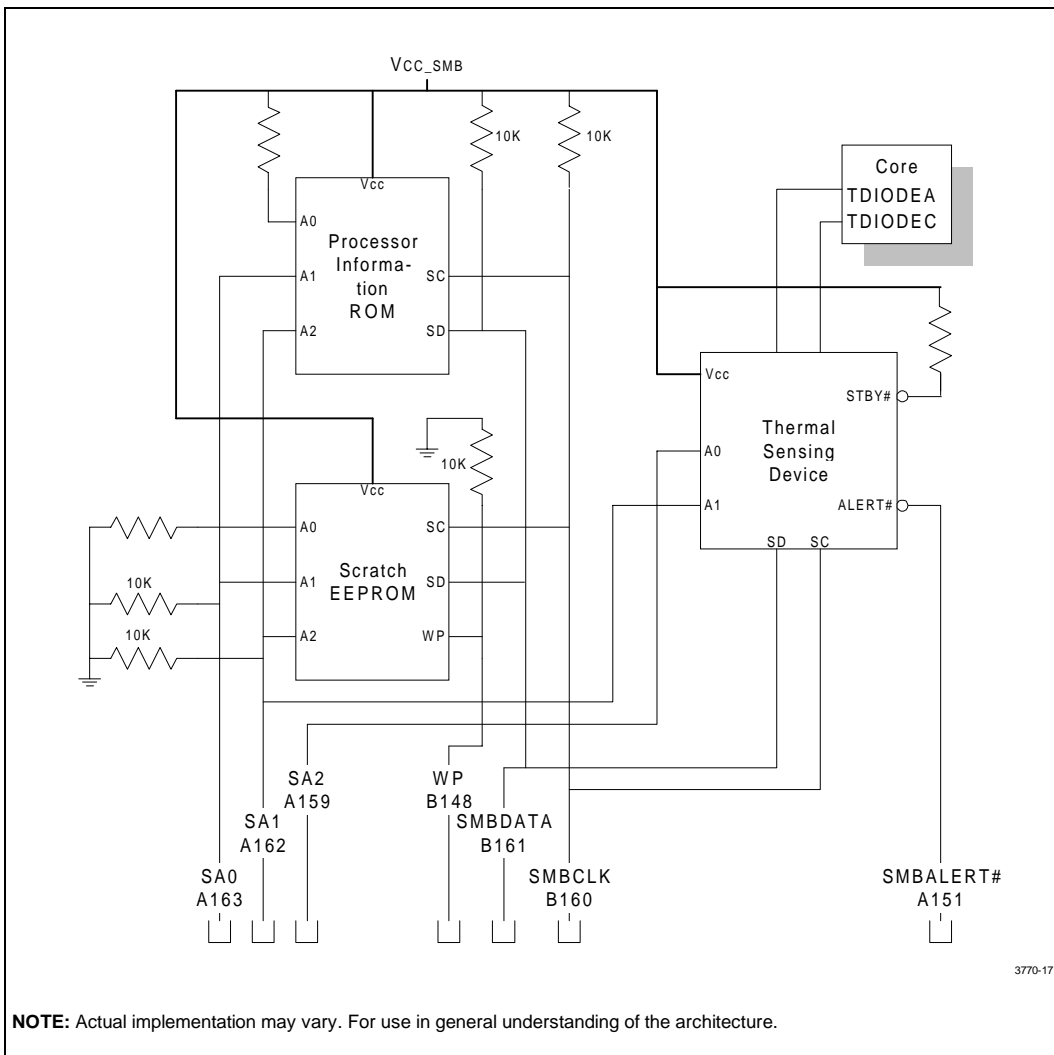


Figure 17. Logical Schematic of SMBus Circuitry

The Pentium II Xeon processor SMBus implementation uses the clock and data signals of the SMBus specification. It does not implement the SMBSUS# signals.

4.3.1. PROCESSOR INFORMATION ROM

An electrically programmed read-only memory with information about the Pentium II Xeon processor is provided on the processor substrate. This information is permanently write-protected. Table 23 shows the data fields and formats provided in the memory.

Table 23. Processor Information ROM Format

Offset/Section	# of Bits	Function	Notes
HEADER: 00h	8	Data Format Revision	Two 4-bit hex digits
01h	16	EEPROM Size	Size in bytes (MSB first)
03h	8	Processor Data Address	Byte pointer, 00h if not present
04h	8	Processor Core Data Address	Byte pointer, 00h if not present
05h	8	L2 Cache Data Address	Byte pointer, 00h if not present
06h	8	SEC Cartridge Data Address	Byte pointer, 00h if not present
07h	8	Part Number Data Address	Byte pointer, 00h if not present
08h	8	Thermal Reference Data Address	Byte pointer, 00h if not present
09h	8	Feature Data Address	Byte pointer, 00h if not present
0Ah	8	Other Data Address	Byte pointer, 00h if not present
0Bh	16	Reserved	Reserved for future use
0Dh	8	Checksum	1 byte checksum
PROCESSOR: 0Eh	48	S-spec/QDF Number	Six 8-bit ASCII characters
	2	Sample/Production	00b = Sample only
	6	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
CORE: 16h	2	Processor Core Type	From CPUID
	4	Processor Core Family	From CPUID
	4	Processor Core Model	From CPUID
	4	Processor Core Stepping	From CPUID
	42	Reserved	Reserved for future use
	16	Maximum Core Frequency	16-bit binary number (in MHz)
	16	Core Voltage ID	Voltage in mV
	8	Core Voltage Tolerance, High	Edge finger tolerance in mV, +



Table 23. Processor Information ROM Format (Continued)

	8	Core Voltage Tolerance, Low	Edge finger tolerance in mV, -
	8	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
L2 CACHE: 25h	32	Reserved	Reserved for future use
	16	L2 Cache Size	16-bit binary number (in Kbytes)
	4	Number of SRAM Components	One 4-bit hex digit
	4	Reserved	Reserved for future use
	16	L2 Cache Voltage ID	Voltage in mV
	8	L2 Cache Voltage Tolerance, High	Edge finger tolerance in mV, +
	8	L2 Cache Voltage Tolerance, Low	Edge finger tolerance in mV, -
	4	Cache/Tag Stepping ID	One 4-bit hex digit
	4	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
CARTRIDGE: 32h	32	Cartridge Revision	Four 8-bit ASCII characters
	2	Substrate Rev. Software ID	2-bit revision number
	6	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
PART NUMBERS: 38h	56	Processor Part Number	Seven 8-bit ASCII characters
	112	Processor BOM ID	Fourteen 8-bit ASCII characters
	64	Processor Electronic Signature	64-bit processor number
	208	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
THERMAL REF.: 70h	8	Thermal Reference Byte	See below
	16	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
FEATURES: 74h	32	Processor Core Feature Flags	From CPUID

Table 23. Processor Information ROM Format (Continued)

	32	Cartridge Feature Flags	[6] = Serial Signature [5] = Electronic Signature Present [4] = Thermal Sense Device Present [3] = Thermal Reference Byte Present [2] = OEM EEPROM Present [1] = Core VID Present [0] = L2 Cache VID Present
	4	Number of Devices in TAP Chain	One 4-bit hex digit
	4	Reserved	Reserved for future use
	8	Checksum	1 byte checksum
OTHER: 7Eh	16	Reserved	Reserved for future use

4.3.2. SCRATCH EEPROM

Also available on the SMBus is an EEPROM which may be used for other data at the system or processor vendor’s discretion. The data in this EEPROM, once programmed, can be write-protected by asserting the active-high WP signal. This signal has a weak pull-down (10kΩ) to allow the EEPROM to be programmed in systems with no implementation of this signal. The Scratch EEPROM is a 1024 bit part.

4.3.3. PROCESSOR INFORMATION ROM AND SCRATCH EEPROM SUPPORTED SMBUS TRANSACTIONS

The Processor Information ROM responds to three SMBus packet types: current address read, random address read, and sequential read. The Scratch EEPROM responds to two additional packet types: byte write and page write. Table 24 diagrams the current address read. The internal address counter keeps track of the address accessed during the last read or write operation, incremented by one. Address “roll over” during reads is from the last byte of the last eight byte page to the first byte of the first page. “Roll over” during writes is from the last byte of the current eight byte page to the first byte of the same page. Table 25 diagrams the random read. The write with no data loads the address desired to be read.

Sequential reads may begin with a current address read or a random address read. After the SMBus host controller receives the data word it responds with an acknowledge. This will continue until the SMBus host controller responds with a negative acknowledge and a stop. Table 26 diagrams the byte write. The page write operates the same way as the byte write except that the SMBus host controller does not send a stop after the first data byte and acknowledge. The Scratch EEPROM internally increments its address. The SMBus host controller continues to transmit data bytes until it terminates the sequence with a stop. All data bytes will result in an acknowledge from the Scratch EEPROM. If more than eight bytes are written the internal address will “roll over” and the previous data will be overwritten. In the tables, ‘S’ represents the SMBus start bit, ‘P’ represents a stop bit, ‘R’ represents a read bit, ‘W’ represents a write bit, ‘A’ represents an acknowledge, and ‘///’ represents a negative acknowledge. The shaded bits are transmitted by the Processor Information ROM or Scratch EEPROM and the bits that aren’t shaded are transmitted by the SMBus host controller. In the tables the data addresses indicate 8 bits. The SMBus host controller should transmit 8 bits, but as there are only 128 addresses, the most significant bit is a don’t care.



Table 24. Current Address Read SMBus Packet

S	Device Address	R	A	Data	///	P
1	7 bits	1	1	8 bits	1	1

Table 25. Random Address Read SMBus Packet

S	Device Address	W	A	Data Address	A	S	Device Address	R	A	Data	///	P
1	7 bits	1	1	8 bits	1	1	7 bits	1	1	8 bits	1	1

Table 26. Byte Write SMBus Packet

S	Device Address	W	A	Data Address	A	Data	A	P
1	7 bits	1	1	8 bits	1	8 bits	1	1

4.3.4. THERMAL SENSOR

The Pentium II Xeon processor's thermal sensor provides a means of acquiring thermal data from the processor with an exceptional degree of precision. The thermal sensor is composed of control logic, SMBus interface logic, a precision analog-to-digital converter, and a precision current source. The thermal sensor drives a small current through the p-n junction of a thermal diode located on the same silicon die as the processor core. The forward bias voltage generated across the thermal diode is sensed and the precision A/D converter derives a single byte of thermal reference data, or a "thermal byte reading." System management software running on the processor or on a microcontroller can acquire the data from the thermal sensor to thermally manage the system.

Upper and lower thermal reference thresholds can be individually programmed for the thermal diode. Comparator circuits sample the register where the single byte of thermal data (thermal byte reading) is stored. These circuits compare the single byte result against programmable threshold bytes. The alert signal on the Pentium II Xeon processor SMBus (SMBALERT#) will assert when either threshold is crossed.

To increase the usefulness of the thermal diode and thermal sensor, Intel has added a new procedure to the manufacturing and test flow of the Pentium II Xeon processor. This procedure determines the Thermal Reference Byte and programs it into the Processor Information ROM. The Thermal Reference Byte is uniquely determined for each unit. The procedure causes each unit to dissipate its maximum power (which can vary from unit to unit) while at the same time maintaining the thermal plate at its maximum specified operating temperature. Correctly used, this feature permits an efficient thermal solution while preserving data integrity.

The thermal byte reading can be used in conjunction with the Thermal Reference Byte in the Processor Information ROM. Byte 9 of the Processor Information ROM contains the address in the ROM of this byte, described in more detail in Section 4.3.1. The thermal byte reading from the thermal sensor can be compared to this Thermal Reference Byte to provide an indication of the difference between the temperature of the processor core at the instant of the thermal byte reading and the temperature of the processor core under the steady state conditions of high power and maximum T_{PLATE} specifications. The nominal precision of the least significant bit of a thermal byte is 1 °C.

Reading the thermal sensor is explained in Section 4.3.5. See the *Pentium® II Xeon™ Processor SMBus Thermal Reference Guidelines* for more details and further recommendations on the use of this feature in Pentium II Xeon processor-based systems.

The thermal sensor feature in the processor cannot be used to measure T_{PLATE} . The T_{PLATE} specification in Section 5.0. must be met regardless of the reading of the processor's thermal sensor in order to ensure adequate cooling for the entire Pentium II Xeon processor. The thermal sensor feature is only available while V_{CCCORE} and $V_{CCSMBus}$ are at valid levels and the processor is not in a low-power state.

4.3.5. THERMAL SENSOR SUPPORTED SMBUS TRANSACTIONS

The thermal sensor responds to five of the SMBus packet types: write byte, read byte, send byte, receive byte, and ARA (Alert Response Address). The send byte packet is used for sending one-shot commands only. The receive byte packet accesses the register commanded by the last read byte packet. If a receive byte packet was preceded by a write byte or send byte packet more recently than a read byte packet, then the behavior is undefined. Table 27 through Table 31 diagram the five packet types. In these figures, 'S' represents the SMBus start bit, 'P' represents a stop bit, 'Ack' represents an acknowledge, and '///' represents a negative acknowledge. The shaded bits are transmitted by the thermal sensor and the bits that aren't shaded are transmitted by the SMBus host controller. Table 32 shows the encoding of the command byte.

Table 27. Write Byte SMBus Packet

S	Address	Write	Ack	Command	Ack	Data	Ack	P
1	7 bits	1	1	8 bits	1	8 bits	1	1

Table 28. Read Byte SMBus Packet

S	Address	Write	Ack	Command	Ack	S	Address	Read	Ack	Data	///	P
1	7 bits	1	1	8 bits	1	1	7 bits	1	1	8 bits	1	1

Table 29. Send Byte SMBus Packet

S	Address	Write	Ack	Command	Ack	P
1	7 bits	1	1	8 bits	1	1

Table 30. Receive Byte SMBus Packet

S	Address	Read	Ack	Data	///	P
1	7 bits	1	1	8 bits	1	1

Table 31. ARA SMBus Packet

S	ARA	Read	Ack	Address	///	P
1	0001 100	1	1	Device Address ¹	1	1

NOTE:

1. This is an 8-bit field. The device which sent the alert will respond to the ARA Packet with its address in the seven most significant bits. The least significant bit is undefined and may return as a '1' or '0'. See Section 4.3.7. for details on the Thermal Sensor Device addressing.

Table 32. Command Byte Bit Assignments

Register	Command	Reset State	Function
RESERVED	00h	N/A	Reserved for future use
RRT	01h	N/A	Read processor core thermal data
RS	02h	N/A	Read status byte (flags, busy signal)
RC	03h	0000 0000	Read configuration byte
RCR	04h	0000 0010	Read conversion rate byte
RESERVED	05h	0111 1111	Reserved for future use
RESERVED	06h	1100 1001	Reserved for future use
RRHL	07h	0111 1111	Read processor core thermal diode T _{HIGH} limit
RRLl	08h	1100 1001	Read processor core thermal diode T _{LOW} limit
WC	09h	N/A	Write configuration byte
WCR	0Ah	N/A	Write conversion rate byte
RESERVED	0Bh	N/A	Reserved for future use
RESERVED	0Ch	N/A	Reserved for future use
WRHL	0Dh	N/A	Write processor core thermal diode T _{HIGH} limit
WRLL	0Eh	N/A	Write processor core thermal diode T _{LOW} limit
OSHT	0Fh	N/A	One shot command (use send byte packet)
RESERVED	10h - FFh	N/A	Reserved for future use

All of the commands are for reading or writing registers in the thermal sensor except the one-shot command (OSHT). The one-shot command forces the immediate start of a new conversion cycle. If a conversion is in progress when the one-shot command is received, then the command is ignored. If the thermal sensor is in standby mode when the one-shot command is received, a conversion is performed and the sensor returns to standby mode.

The one-shot command is not supported when the thermal sensor is in auto-convert mode.

The default command after reset is to reserved value (00h). After reset, receive byte packets will return invalid data until another command is sent to the thermal sensor.

4.3.6. THERMAL SENSORS REGISTERS

4.3.6.3. Status Register

4.3.6.1. Thermal Reference Registers

The processor core and thermal sensor internal thermal reference registers contain the thermal reference value of the thermal sensor and the processor core thermal diodes. This value ranges from +127 to -128 decimal and is expressed as a two's complement, eight-bit number. These registers are saturating, i.e., values above 127 are represented at 127 decimal, and values below -128 are represented as -128 decimal.

The status register shown in Table 33 indicates which (if any) thermal value thresholds have been exceeded. It also indicates if a conversion is in progress or if an open circuit has been detected in the processor core thermal diode connection. Once set, alarm bits stay set until they are cleared by a status register read. A successful read to the status register will clear any alarm bits that may have been set, unless the alarm condition persists.

4.3.6.2. Thermal Limit Registers

The thermal sensor has two thermal limit registers; they define high and low limits for the processor core thermal diode. The encoding for these registers is the same as for the thermal reference registers. If the diode thermal value equals or exceeds one of its limits, then its alarm bit in the Status Register is triggered.

4.3.6.4. Configuration Register

The configuration register controls the operating mode (standby vs. auto-convert) of the thermal sensor. Table 34 shows the format of the configuration register. If the RUN/STOP bit is set (high) then the thermal sensor immediately stops converting and enters standby mode. The thermal sensor will still perform analog to digital conversions in standby mode when it receives a one-shot command. If the RUN/STOP bit is clear (low) then the thermal sensor enters auto-conversion mode.

Table 33. Thermal Sensor Status Register

Bit	Name	Function
7 (MSB)	BUSY	A one indicates that the device's analog to digital converter is busy converting.
6	RESERVED	Reserved for future use.
5	RESERVED	Reserved for future use.
4	RHIGH	A one indicates that the processor core thermal diode high temperature alarm has activated.
3	RLOW	A one indicates that the processor core thermal diode low temperature alarm has activated.
2	OPEN	A one indicates an open fault in the connection to the processor core diode.
1	RESERVED	Reserved for future use.
0 (LSB)	RESERVED	Reserved for future use.



Table 34. Thermal Sensor Configuration Register

Bit	Name	Reset State	Function
7 (MSB)	RESERVED	0	Reserved for future use.
6	RUN/STOP	0	Standby mode control bit. If high, the device immediately stops converting, and enters standby mode. If low, the device converts in either one-shot mode or automatically updates on a timed basis..
5-0	RESERVED	0	Reserved for future use.

Table 35. Thermal Sensor Conversion Rate Register

Register Contents	Conversion Rate (Hz)
00h	0.0625
01h	0.125
02h	0.25
03h	0.5
04h	1
05h	2
06h	4
07h	8
08h to FFh	Reserved for future use

4.3.6.5. Conversion Rate Register

The contents of the conversion rate register determine the nominal rate at which analog to digital conversions happen when the thermal sensor is in auto-convert mode. Table 35 shows the mapping between conversion rate register values and the conversion rate. As indicated in Table 32, the conversion rate register is set to its default state of 02h (0.25 Hz nominally) when the thermal sensor is powered up. There is a ±25% error tolerance between the conversion rate indicated in the conversion rate register and the actual conversion rate.

4.3.7. SMBUS DEVICE ADDRESSING

Of the addresses broadcast across the SMBus, the memory components claim those of the form “1010XXYZb”. The “XX” and “Y” bits are used to enable the devices on the cartridge at adjacent

addresses. The Y bit is hard-wired on the cartridge to V_{SS} (‘0’) for the Scratch EEPROM and pulled to V_{CCSMBus} (‘1’) for the Processor Information ROM. The “XX” bits are defined by the processor slot via the SA0 and SA1 pins on the SC330 connector. These address pins are pulled down weakly (10kΩ) to ensure that the memory components are in a known state in systems which do not support the SMBus, or only support a partial implementation. The “Z” bit is the read/write bit for the serial bus transaction.

The thermal sensor internally decodes 1 of 3 upper address patterns from the bus of the form “0011XXXZb”, “1001XXXZb” or “0101XXXZb”. The device’s addressing, as implemented, uses SA2 and SA1 and includes a Hi-Z state for the SA2 address pin. Therefore the thermal sensor supports 6 unique resulting addresses. To set the Hi-Z state for SA2, the pin must be left floating. The system should drive SA1 and SA0, and will be pulled low (if not driven) by the 10kΩ pull-down resistor on the processor

substrate. Attempting to drive either of these signals to a Hi-Z state would cause ambiguity in the memory device address decode, possibly resulting in the devices not responding, thus timing out or hanging the SMBus. As before, the “Z” bit is the read/write bit for the serial bus transaction.

Note that addresses of the form “0000XXXb” are Reserved and should not be generated by an SMBus master.

Figure 17 shows a logical diagram of the pin connections. Table 36 and Table 37 describe the address pin connections and how they affect the addressing of the devices.

Note that system management software must be aware of the slot number-dependent changes in the address for the thermal sensor.

Table 36. Thermal Sensor SMBus Addressing on the Pentium® II Xeon™ Processor

Address (Hex)	Upper Address ¹	Slot Select		8-bit Address Word on Serial Bus
		SA1	SA2	b[7:0]
3Xh	0011	0	0	0011000Xb
	0011	1	0	0011010Xb
5Xh	0101	0	Z ²	0101001Xb
	0101	1	Z ²	0101011Xb
9Xh	1001	0	1	1001100Xb
	1001	1	1	1001110Xb

NOTES:

1. Upper address bits are decoded in conjunction with the select pins.
2. A tri-state or “Z” state on this pin is achieved by leaving this pin unconnected.

Table 37. Memory Device SMBus Addressing on the Pentium® II Xeon™ Processor

Address (Hex)	Upper Address	Slot Select		Memory Device Select	R/W	Device Addressed
		(SA1) bit 3	(SA0) bit 2	bit 1	bit 0	
A0h/A1h	1010	0	0	0	X	Scratch EEPROM 1
A2h/A3h	1010	0	0	1	X	Processor Information ROM 1
A4h/A5h	1010	0	1	0	X	Scratch EEPROM 2
A6h/A7h	1010	0	1	1	X	Processor Information ROM 2
A8h/A9h	1010	1	0	0	X	Scratch EEPROM 3
AAh/ABh	1010	1	0	1	X	Processor Information ROM 3
ACH/ADh	1010	1	1	0	X	Scratch EEPROM 4
AEh/AFh	1010	1	1	1	X	Processor Information ROM 4

Though this addressing scheme is targeted for up to 4-way MP systems, more processors can be supported by using a multiplexed (or separate) SMBus implementation.

thermal solutions. This chapter will provide the necessary data for a thermal solution to be developed. See Figure 18 for thermal plate location.

5.0. THERMAL SPECIFICATIONS AND DESIGN CONSIDERATIONS

The Pentium II Xeon processor will use a thermal plate for heatsink attachment. The thermal plate interface is intended to provide for multiple types of

5.1. Thermal Specifications

This section provides power dissipation specifications for each variation of the Pentium II Xeon processor. The thermal plate flatness is also specified for the S.E.C. cartridge.

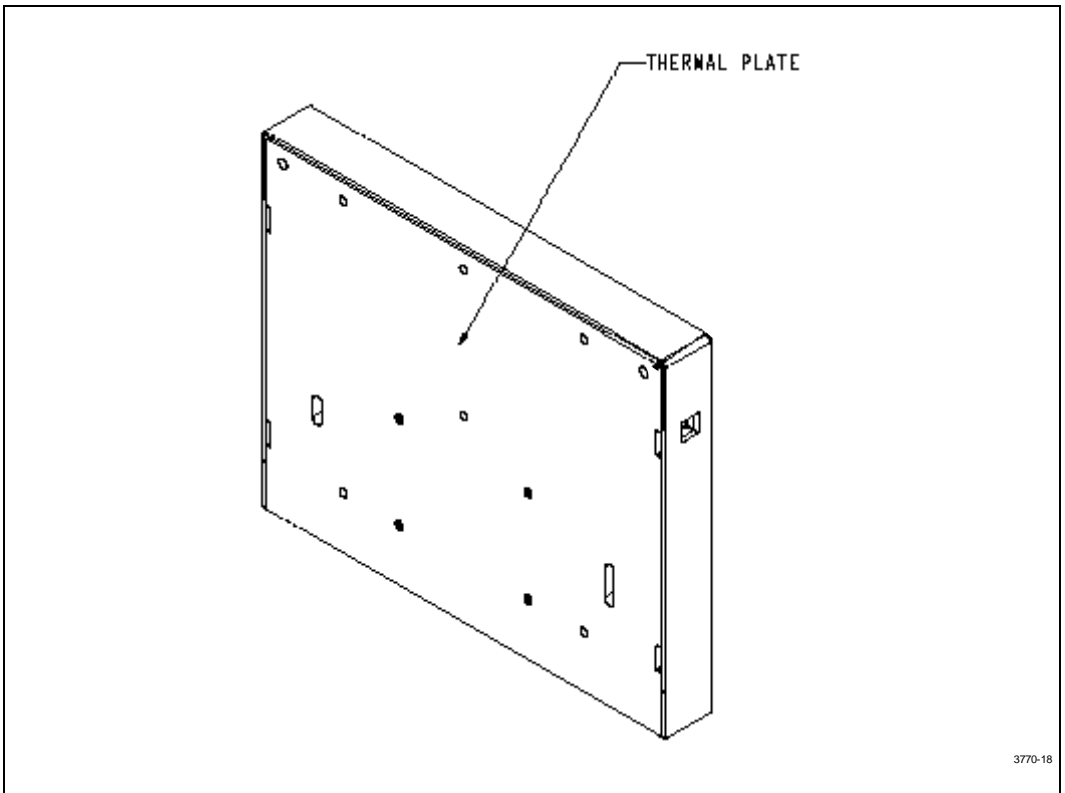


Figure 18. Thermal Plate View

Table 38. Thermal Design Power¹

Processor Core Frequency (MHz)	L2 Cache Size	Core Power (W)	L2 Power (W)	AGTL+ Power ⁴ (W)	Processor Power ² (W)	Thermal Plate Power ³ (W)	Min T _{PLATE} (°C)	Max T _{PLATE} (°C)	Min T _{COVER} (°C)	Max T _{COVER} (°C)
FMB ⁵	-	35.2	21.0	2	50.0	50.0	0	75	0	75
400	512K	23.3	7.5	2	30.8	30.8	0	75	0	75
400	1M	23.3	15.0	2	38.1	38.1	0	75	0	75
450	512K	26.2	8.5	2	34.5	34.5	0	75	0	75
450	1M	26.2	17.0	2	42.8	42.8	0	75	0	75
450	2M	26.2	21.0	2	46.7	46.7	0	75	0	75

NOTES:

1. These values are specified at nominal V_{CC}CORE for the processor core and nominal V_{CC}L2 = 2.5 V for the L2 cache.
2. Processor power indicates the worst case power that can be dissipated by the entire processor. This value will be determined after the product has been characterized. It is not possible for the AGTL+ bus, the L2 cache and the processor core to all be at full power simultaneously.
3. The combined power that dissipates through the thermal plate is the thermal plate power. This value will be determined after the product has been characterized. The value shown follows the expectation that virtually all of the power will dissipate through the thermal plate.
4. AGTL+ power is the worst case power dissipated in the termination resistors for the AGTL+ bus.
5. "FMB" is a suggested design guideline for a flexible motherboard design. Notice that worst case L2 power and worst case processor power do not occur on the same processor.

5.1.1. POWER DISSIPATION

Table 38 provides the thermal design power dissipation for Pentium II Xeon processors. While the processor core dissipates the majority of the thermal power, the system designer should also be aware of the thermal power dissipated by the second level cache. Systems should design for the highest possible thermal power, even if a processor with lower frequency or smaller second level cache is planned. The thermal plate is the attach location for all thermal solutions. The maximum temperature for the entire thermal plate surface is shown in Table 38.

The processor power is dissipated through the thermal plate and other paths. The power dissipation is a combination of power from the processor core, the second level cache and the AGTL+ bus termination resistors. The overall system thermal design must comprehend the total processor power. The combined power from the processor core and the second level cache that dissipates through the thermal plate is the thermal plate power. The heatsink should be designed to dissipate the thermal plate power.

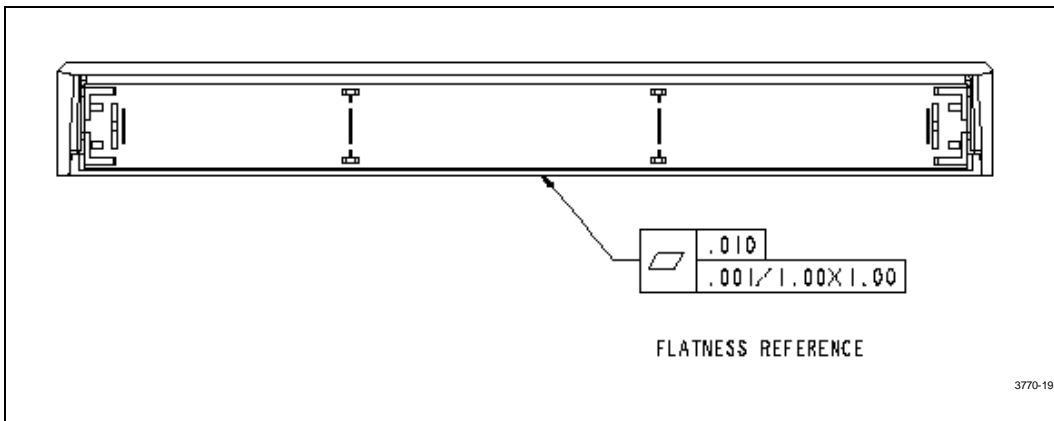


Figure 19. Plate Flatness Reference

The thermal sensor feature of the processor cannot be used to measure T_{PLATE} . The T_{PLATE} specification must be met regardless of the reading of the processor's thermal sensor in order to ensure adequate cooling for the entire Pentium II Xeon processor.

5.1.2. PLATE FLATNESS SPECIFICATION

The thermal plate flatness for the Pentium II Xeon processor is specified to 0.010" across the entire thermal plate surface, with no more than a 0.001" step anywhere on the surface of the plate, as shown in Figure 19.

5.2. Processor Thermal Analysis

5.2.1. THERMAL SOLUTION PERFORMANCE

Processor cooling solutions should attach to the thermal plate. The processor cover is not designed for thermal solution attachment.

The complete thermal solution must adequately control the thermal plate and cover temperatures below the maximum and above the minimum specified in Table 38. The performance of any thermal solution is defined as the thermal resistance between the thermal plate and the ambient air around the processor ($\Theta_{\text{thermal plate to ambient}}$). The lower the thermal resistance between the thermal plate and the ambient air, the more efficient the thermal solution is. The required $\Theta_{\text{thermal plate to ambient}}$ is dependent upon the maximum allowed thermal plate temperature (T_{PLATE}), the local ambient temperature (T_{LA}) and the thermal plate power (P_{PLATE}).

$$\Theta_{\text{thermal plate to ambient}} = (T_{\text{PLATE}} - T_{\text{LA}}) / P_{\text{PLATE}}$$

The maximum T_{PLATE} and the thermal plate power are listed in Table 38. T_{LA} is a function of the system design. Table 39 provides the resultant thermal solution performance for a 450-MHz Pentium II Xeon processor at different ambient air temperatures around the processor.

Table 39. Example Thermal Solution Performance at Thermal Plate Power of 50 Watts

Thermal Solution Performance	Local Ambient Temperature (T _{LA})		
Θ _{thermal plate to ambient}	35 °C	40 °C	45 °C
(°C/watt)	0.8	0.7	0.6

The Θ_{thermal plate to ambient} value is made up of two primary components: the thermal resistance between the thermal plate and heatsink (Θ_{thermal plate to heatsink}) and the thermal resistance between the heatsink and ambient air around the processor (Θ_{heatsink to air}). A critical, but controllable factor to decrease the resultant value of Θ_{thermal plate to heatsink} is management of the thermal interface between the thermal plate and heatsink. The other controllable factor (Θ_{heatsink to air}) is determined by the design of the heatsink and airflow around the heatsink. General information on thermal interfaces and heatsink

design constraints can be found in AP-586, *Pentium® II Processor Thermal Design Guidelines*.

5.2.2. THERMAL PLATE TO COOLING SOLUTION INTERFACE MANAGEMENT GUIDE

Figure 20 shows suggested interface agent dispensing areas when using either Intel suggested interface agent. Actual user area and interface agent selections will be determined by system issues in meeting the T_{PLATE} requirements.

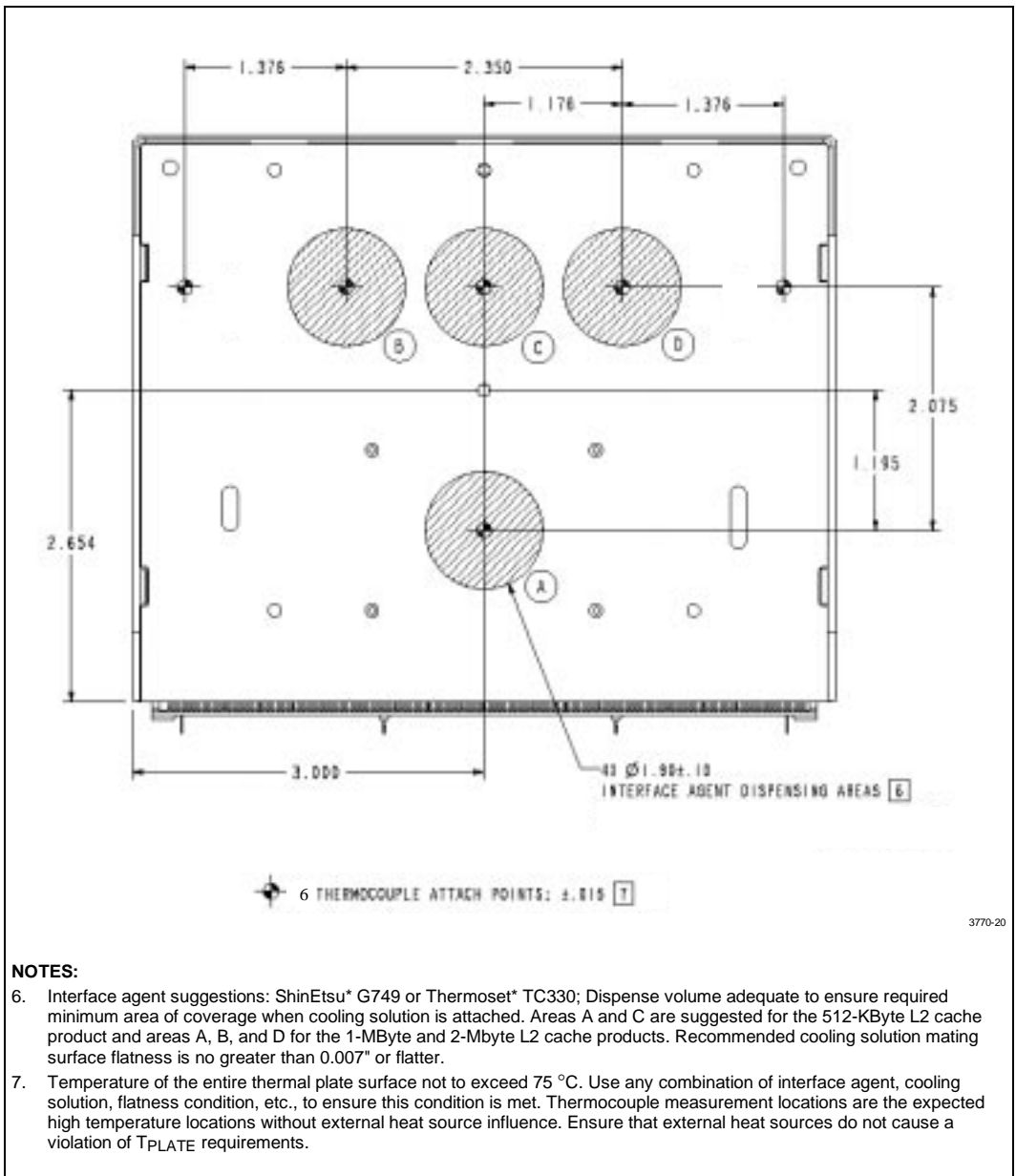


Figure 20. Interface Agent Dispensing Areas and Thermal Plate Temperature Measurement Points

5.2.3. MEASUREMENTS FOR THERMAL SPECIFICATIONS

5.2.3.1. Thermal Plate Temperature Measurement

To ensure functional and reliable processor operation, the processor's thermal plate temperature (T_{PLATE}) must be maintained at or below the maximum T_{PLATE} and at or above the minimum T_{PLATE} specified in Table 38. Power from the processor core and L2 cache is transferred to the thermal plate at 2 locations on the 512-Kbyte L2 cache product, 3 locations on the 1-Mbyte L2 cache products, and 5 locations on the 2-Mbyte L2 cache products. Figure 20 shows the locations for T_{PLATE} measurement directly above these transfer locations. Figure 23 shows the 4 locations for T_{COVER} measurement, directly above component locations on the back side of the processor substrate.

Thermocouples are used to measure T_{PLATE} and special care is required to ensure an accurate temperature measurement. Before taking any temperature measurements, the thermocouples must be calibrated. When measuring the temperature of a surface, errors can be introduced in the measurement if not handled properly. Such measurement errors can be due to a poor thermal contact between the thermocouple junction and the measured surface, conduction through thermocouple leads, heat loss by radiation and convection, or by contact between the thermocouple cement and the

heatsink base. To minimize these errors, the following approach is recommended:

- Use 36 gauge or finer diameter K, T, or J type thermocouples. Intel's laboratory testing was done using a thermocouple made by Omega* (part number: 5TC-TTK-36-36).
- Attach each thermocouple bead or junction to the top surface of the thermal plate at the locations specified in Figure 20 using high thermal conductivity cements.
- A thermocouple should be attached at a 0° angle if no heatsink is attached to the thermal plate. If a heatsink is attached to the thermal plate but the heatsink does not cover the location specified for T_{PLATE} measurement, the thermocouple should be attached at a 0° angle (refer to Figure 21).
- The thermocouple should be attached at a 90° angle if a heatsink is attached to the thermal plate and the heatsink covers the location specified for T_{PLATE} measurement (refer to Figure 22).
- The hole size through the heatsink base to route the thermocouple wires out should be smaller than 0.150" in diameter.
- Make sure there is no contact between the thermocouple cement and heatsink base. This contact will affect the thermocouple reading.

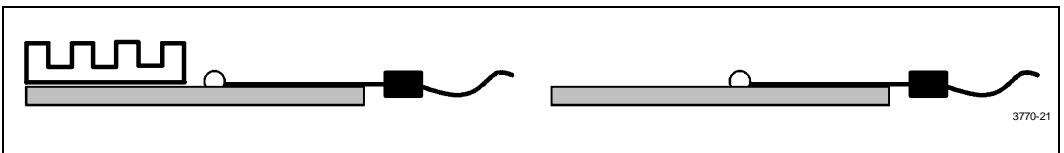


Figure 21. Technique for Measuring T_{PLATE} with 0° Angle Attachment

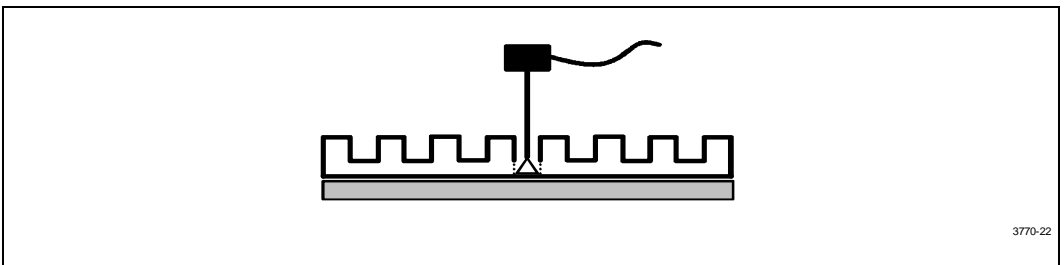


Figure 22. Technique for Measuring T_{PLATE} with 90° Angle Attachment

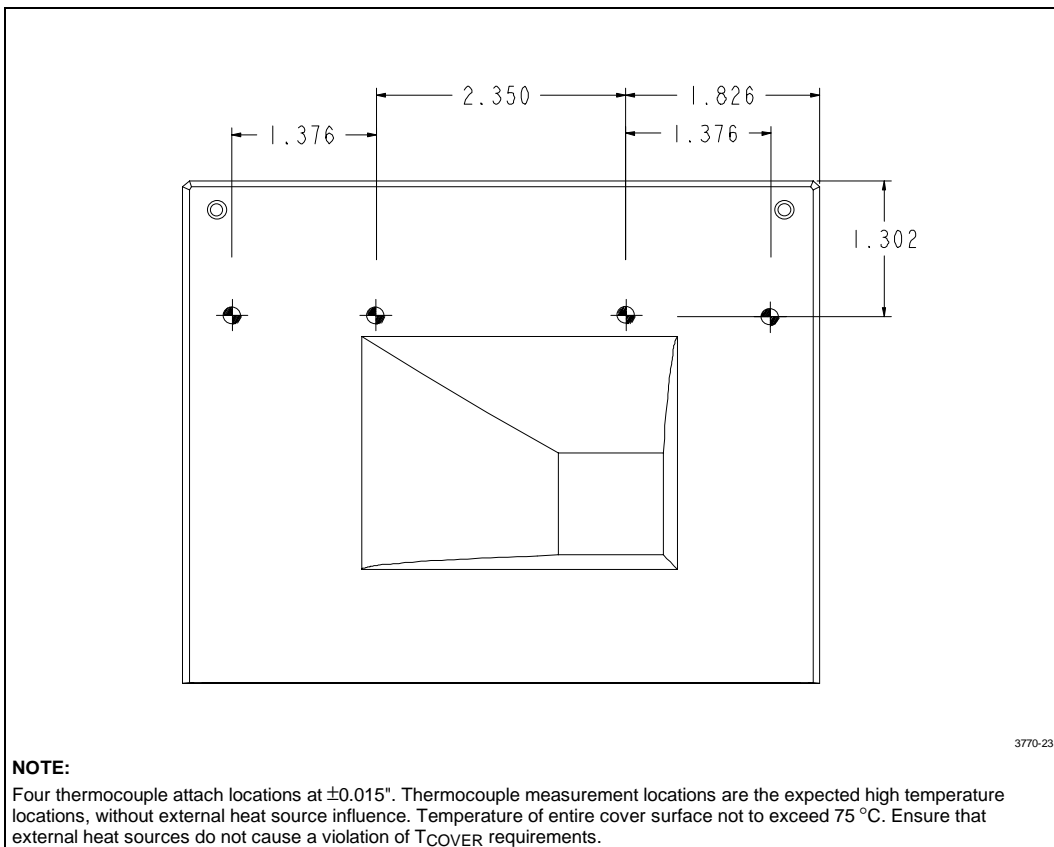


Figure 23. Guideline Locations for Cover Temperature (T_{COVER}) Thermocouple Placement

5.2.3.2. Cover Temperature Measurement Guideline

The maximum and minimum S.E.C. cartridge cover temperature (T_{COVER}) for Pentium II Xeon processors are specified in Table 38. Meeting this temperature specification is required to ensure correct and reliable operation of the processor. In the design of a system, other sources of heat convection, conduction or radiation should be evaluated for any possible effect on the cartridge cover temperature. In a system free from such external sources of heat, the higher temperature areas on the cover have been characterized and are illustrated in Figure 23. If no external heat sources are present, T_{COVER} thermal measurements should

be made at these points. The cover is not designed for thermal solution attachment.

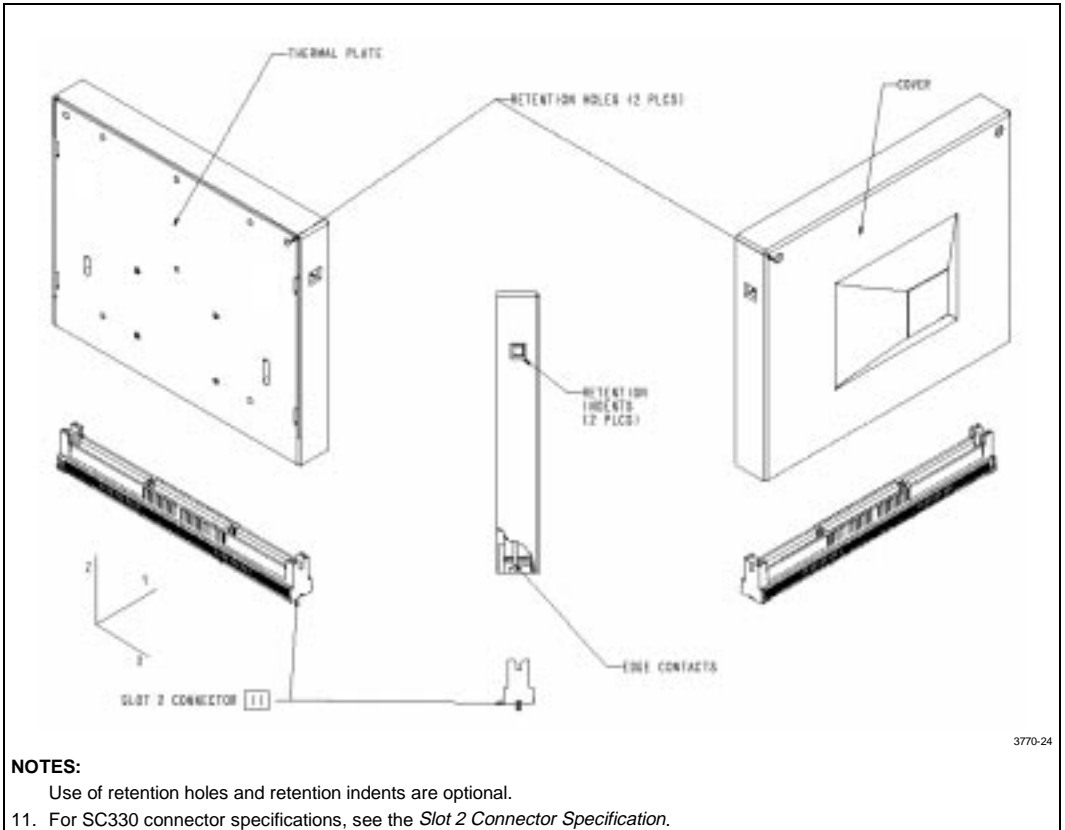
6.0. MECHANICAL SPECIFICATIONS

Pentium II Xeon processors use S.E.C. cartridge package technology. The S.E.C. cartridge contains the processor core, L2 cache and other components. The S.E.C. cartridge package connects to the motherboard through an edge connector. Mechanical specifications for the processor are given in this section. See Section 1.1.1. for a complete terminology listing.

Figure 24 shows the thermal plate side view and the cover side view of the Pentium II Xeon processor.

Figure 25 shows the Pentium II Xeon S.E.C. cartridge cooling solution attachment feature details on the thermal plate and depict package form factor dimensions and retention enabling features of the S.E.C. cartridge. The processor edge connector defined in this document is referred to as SC330 connector. See the SC330 connector specifications for further details on the edge connector.

Table 40 and Table 41 provide the edge finger and SC330 connector signal definitions for Pentium II Xeon processors. The signal locations on the SC330 edge connector are to be used for signal routing, simulation and component placement on the motherboard.



NOTES:

Use of retention holes and retention indents are optional.

11. For SC330 connector specifications, see the *Slot 2 Connector Specification*.

Figure 24. Isometric View of Pentium® II Xeon™ Processor S.E.C. Cartridge

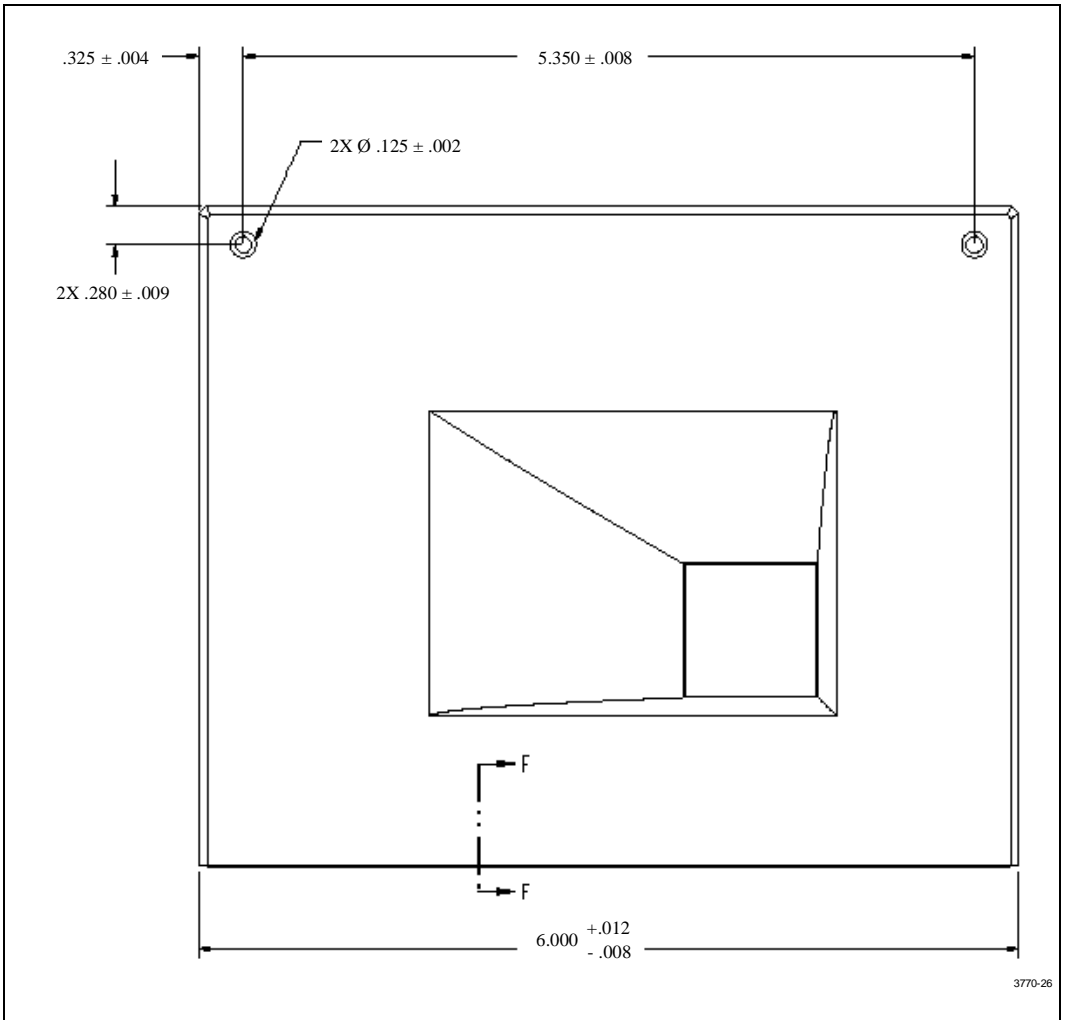


Figure 26. S.E.C. Cartridge Retention Enabling Details
(Notes follow Figure 27)

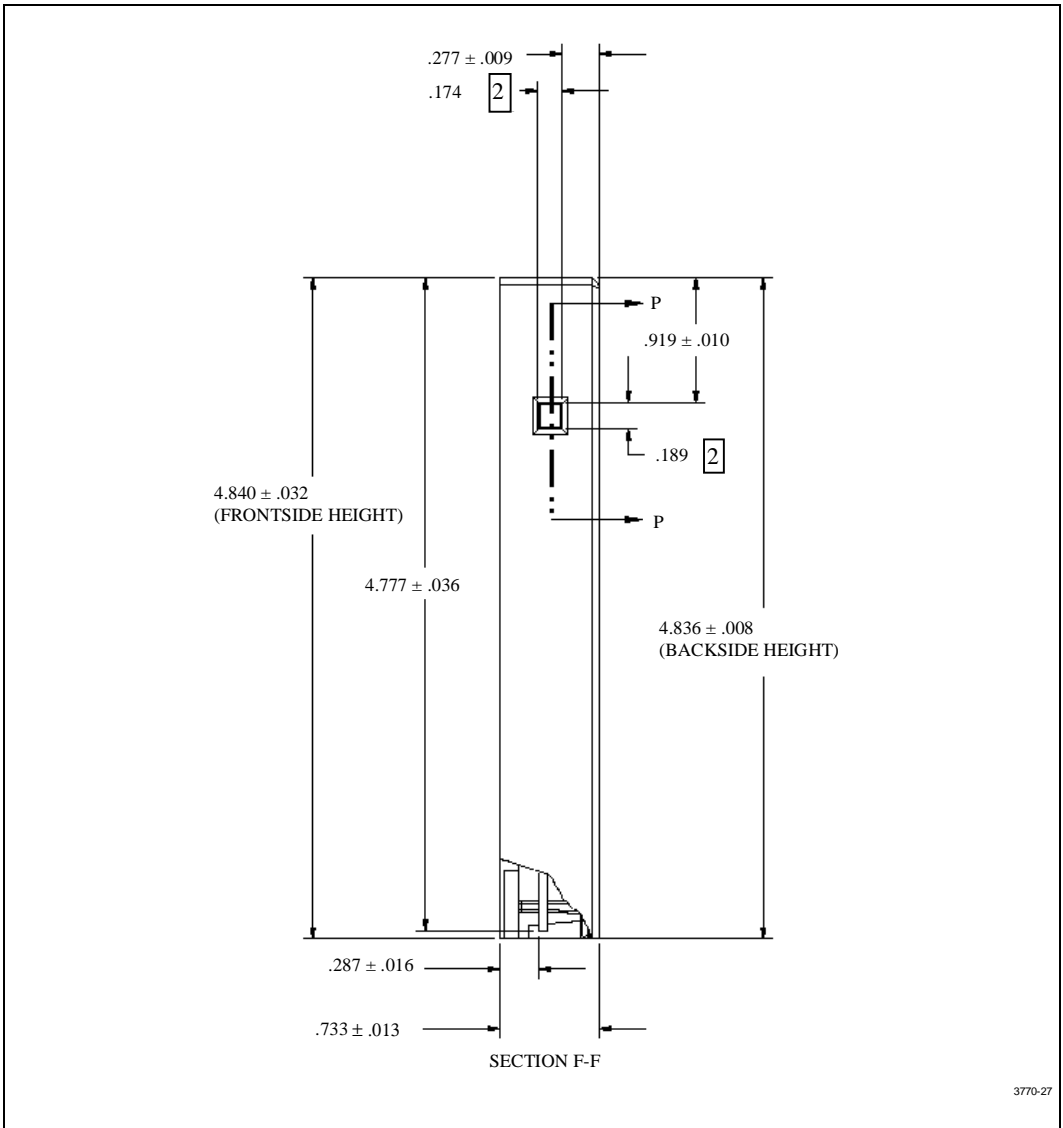


Figure 27. SEC Cartridge Retention Enabling Details

NOTES:

1. Maximum protrusion of the mechanical heatsink attach media into cartridge during assembly or in an installed condition not to exceed 0.160" from external face of thermal plate.
2. Specified cover retention indent dimension is at the external end of the indent. Indent walls have 0.5 degree draft, with the wider section on the external end.
3. Clip extension on internal surface of retention slots should be as little as possible and not to exceed 0.040".
12. Tapped holes for cooling solution attach. Max torque recommendation for a screw in tapped hole is 8±1 inch-lb.

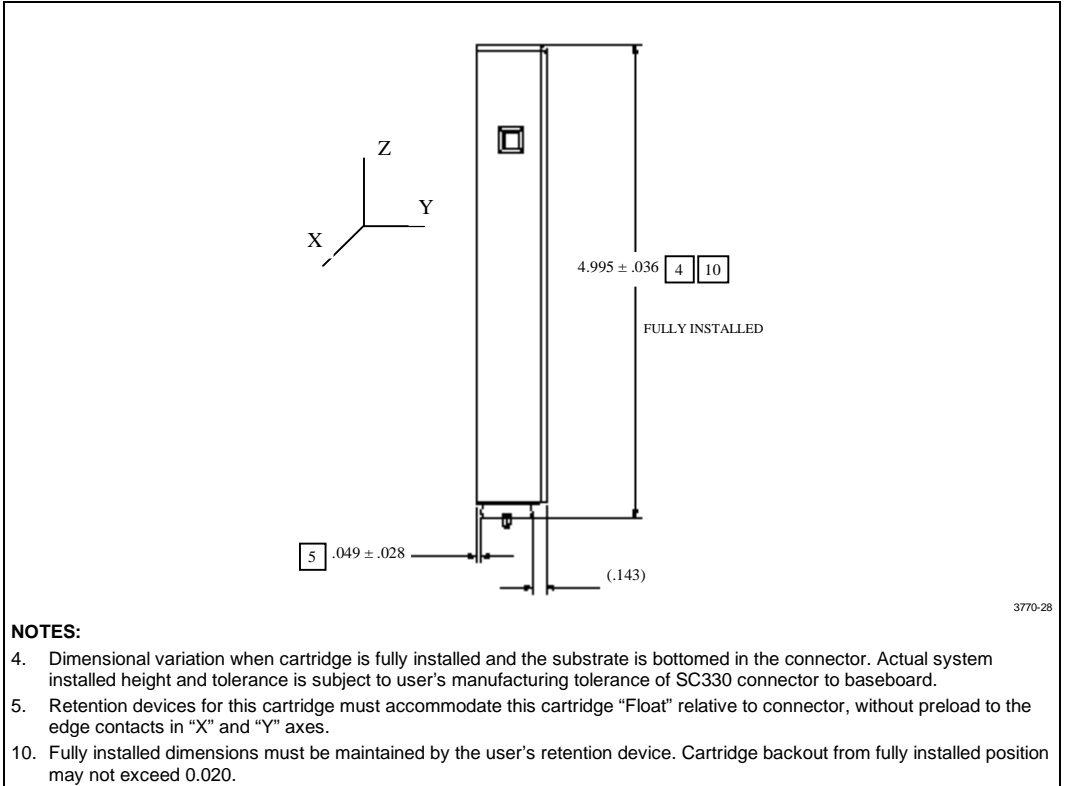


Figure 28. Side View of Connector Mating Details

6.1. Weight

The maximum weight of a Pentium II Xeon processor is approximately 500 grams.

6.2. Cartridge to Connector Mating Details

The staggered edge connector layout of the Pentium II Xeon processor makes the processor susceptible to damage from hot socketing (inserting the cartridge while power is applied to the connector). Extra care should be taken to ensure hot socketing does not occur. The electrical and mechanical integrity of the processor edge fingers are specified for up to 50 insertion/extraction cycles.

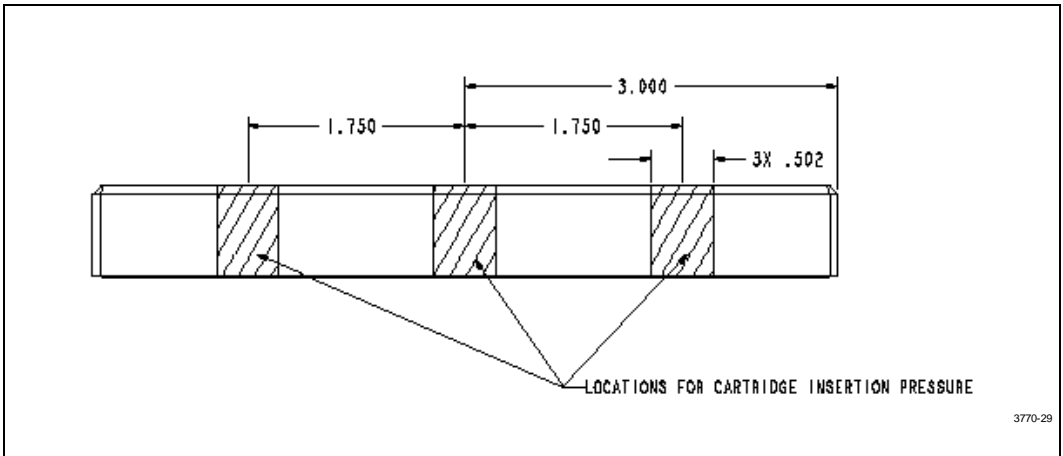
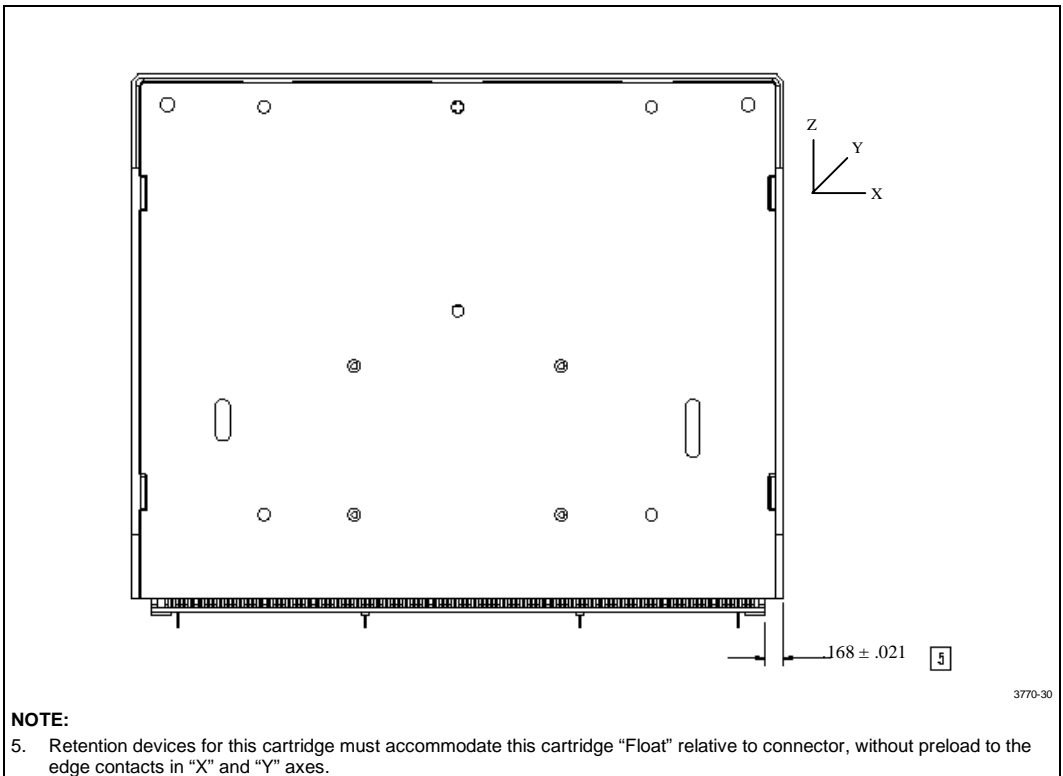


Figure 29. Top View of Cartridge Insertion Pressure Points



NOTE:

5. Retention devices for this cartridge must accommodate this cartridge "Float" relative to connector, without preload to the edge contacts in "X" and "Y" axes.

Figure 30. Front View of Connector Mating Details

6.3. Pentium® II Xeon™ Processor Substrate Edge Finger Signal Listing

Table 40 is the Pentium II Xeon processor substrate edge finger listing in order by pin number. Table 41 is the Pentium II Xeon processor substrate edge connector listing in order by pin name.

Table 40. Signal Listing in Order by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Pin No.	Pin Name	Signal Buffer Type
A1	EMI	Connect to V _{SS}	B1	PWR_EN[1]	Short to PWR_EN[0]
A2	VCC_TAP	TAP Supply	B2	VCC_CORE	CPU Core V _{CC}
A3	EMI	Connect to V _{SS}	B3	RESERVED_B3	DO NOT CONNECT
A4	VSS	Ground	B4	TEST_VSS_B4	Pull down to V _{SS}
A5	VTT	AGTL+ V _{TT} Supply	B5	VCC_CORE	CPU Core V _{CC}
A6	VTT	AGTL+ V _{TT} Supply	B6	VTT	AGTL+ V _{TT} Supply
A7	VSS	Ground	B7	VTT	AGTL+ V _{TT} Supply
A8	VSS	Ground	B8	VCC_CORE	CPU Core V _{CC}
A9	SELFSB0	CMOS I/O	B9	RESERVED_B9	DO NOT CONNECT
A10	VSS	Ground	B10	FLUSH#	CMOS Input
A11	TEST_VSS_A11	Pull down to V _{SS}	B11	VCC_CORE	CPU Core V _{CC}
A12	IERR#	CMOS Output	B12	SMI#	CMOS Input
A13	VSS	Ground	B13	INIT#	CMOS Input
A14	A20M#	CMOS Input	B14	VCC_CORE	CPU Core V _{CC}
A15	FERR#	CMOS Output	B15	STPCLK#	CMOS Input
A16	VSS	Ground	B16	TCK	TAP Clock
A17	IGNNE#	CMOS Input	B17	VCC_CORE	CPU Core V _{CC}
A18	TDI	TAP Input	B18	SLP#	CMOS Input
A19	VSS	Ground	B19	TMS	TAP Input
A20	TDO	TAP Output	B20	VCC_CORE	CPU Core V _{CC}
A21	PWRGOOD	CMOS Input	B21	TRST#	TAP Input
A22	VSS	Ground	B22	RESERVED_B22	DO NOT CONNECT
A23	TEST_VCC_CORE_A23	Pull up to VCC_CORE	B23	VCC_CORE	CPU Core V _{CC}
A24	THERMTRIP#	CMOS Output	B24	RESERVED_B24	DO NOT CONNECT
A25	VSS	Ground	B25	RESERVED_B25	DO NOT CONNECT
A26	RESERVED_A26	DO NOT CONNECT	B26	VCC_CORE	CPU Core V _{CC}
A27	LINT[0]	CMOS Input	B27	TEST_VCC_CORE_B27	Pull up to VCC_CORE
A28	VSS	Ground	B28	LINT[1]	CMOS Input
A29	PICD[0]	CMOS I/O	B29	VCC_CORE	CPU Core V _{CC}
A30	PREQ#	CMOS Input	B30	PICCLK	APIC Clock Input
A31	VSS	Ground	B31	PICD[1]	CMOS I/O
A32	BP#[3]	AGTL+ I/O	B32	VCC_CORE	CPU Core V _{CC}
A33	BPM#[0]	AGTL+ I/O	B33	BP#[2]	AGTL+ I/O



Table 40. Signal Listing in Order by Pin Number (Continued)

Pin No.	Pin Name	Signal Buffer Type	Pin No.	Pin Name	Signal Buffer Type
A34	VSS	Ground	B34	RESERVED_B34	DO NOT CONNECT
A35	BINIT#	AGTL+ I/O	B35	VCC_CORE	CPU Core V _{CC}
A36	DEP#[0]	AGTL+ I/O	B36	PRDY#	AGTL+ Output
A37	VSS	Ground	B37	BPM#[1]	AGTL+ I/O
A38	DEP#[1]	AGTL+ I/O	B38	VCC_CORE	CPU Core V _{CC}
A39	DEP#[3]	AGTL+ I/O	B39	DEP#[2]	AGTL+ I/O
A40	VSS	Ground	B40	DEP#[4]	AGTL+ I/O
A41	DEP#[5]	AGTL+ I/O	B41	VCC_CORE	CPU Core V _{CC}
A42	DEP#[6]	AGTL+ I/O	B42	DEP#[7]	AGTL+ I/O
A43	VSS	Ground	B43	D#[62]	AGTL+ I/O
A44	D#[61]	AGTL+ I/O	B44	VCC_CORE	CPU Core V _{CC}
A45	D#[55]	AGTL+ I/O	B45	D#[58]	AGTL+ I/O
A46	VSS	Ground	B46	D#[63]	AGTL+ I/O
A47	D#[60]	AGTL+ I/O	B47	VCC_CORE	CPU Core V _{CC}
A48	D#[53]	AGTL+ I/O	B48	D#[56]	AGTL+ I/O
A49	VSS	Ground	B49	D#[50]	AGTL+ I/O
A50	D#[57]	AGTL+ I/O	B50	VCC_CORE	CPU Core V _{CC}
A51	D#[46]	AGTL+ I/O	B51	D#[54]	AGTL+ I/O
A52	VSS	Ground	B52	D#[59]	AGTL+ I/O
A53	D#[49]	AGTL+ I/O	B53	VCC_CORE	CPU Core V _{CC}
A54	D#[51]	AGTL+ I/O	B54	D#[48]	AGTL+ I/O
A55	VSS	Ground	B55	D#[52]	AGTL+ I/O
A56	RESERVED_A56	DO NOT CONNECT	B56	VCC_CORE	CPU Core V _{CC}
A57	VSS	Ground	B57	RESERVED_B57	DO NOT CONNECT
A58	D#[42]	AGTL+ I/O	B58	VCC_CORE	CPU Core V _{CC}
A59	D#[45]	AGTL+ I/O	B59	D#[41]	AGTL+ I/O
A60	VSS	Ground	B60	D#[47]	AGTL+ I/O
A61	D#[39]	AGTL+ I/O	B61	VCC_CORE	CPU Core V _{CC}
A62	TEST_25_A62	Pull up to 2.5 V	B62	D#[44]	AGTL+ I/O
A63	VSS	Ground	B63	D#[36]	AGTL+ I/O
A64	D#[43]	AGTL+ I/O	B64	VCC_CORE	CPU Core V _{CC}
A65	D#[37]	AGTL+ I/O	B65	D#[40]	AGTL+ I/O
A66	VSS	Ground	B66	D#[34]	AGTL+ I/O
A67	D#[33]	AGTL+ I/O	B67	VCC_CORE	CPU Core V _{CC}
A68	D#[35]	AGTL+ I/O	B68	D#[38]	AGTL+ I/O
A69	VSS	Ground	B69	D#[32]	AGTL+ I/O
A70	D#[31]	AGTL+ I/O	B70	VCC_CORE	CPU Core V _{CC}

Table 40. Signal Listing in Order by Pin Number (Continued)

Pin No.	Pin Name	Signal Buffer Type	Pin No.	Pin Name	Signal Buffer Type
A71	D#[30]	AGTL+ I/O	B71	D#[28]	AGTL+ I/O
A72	VSS	Ground	B72	D#[29]	AGTL+ I/O
A73	D#[27]	AGTL+ I/O	B73	VCC_CORE	CPU Core V _{CC}
A74	D#[24]	AGTL+ I/O	B74	D#[26]	AGTL+ I/O
A75	VSS	Ground	B75	D#[25]	AGTL+ I/O
A76	D#[23]	AGTL+ I/O	B76	VCC_CORE	CPU Core V _{CC}
A77	D#[21]	AGTL+ I/O	B77	D#[22]	AGTL+ I/O
A78	VSS	Ground	B78	D#[19]	AGTL+ I/O
A79	D#[16]	AGTL+ I/O	B79	VCC_CORE	CPU Core V _{CC}
A80	D#[13]	AGTL+ I/O	B80	D#[18]	AGTL+ I/O
A81	VSS	Ground	B81	D#[20]	AGTL+ I/O
A82	TEST_VTT_A82	Pull up to V _{TT}	B82	VCC_CORE	CPU Core V _{CC}
A83	RESERVED_A83	DO NOT CONNECT	B83	RESERVED_B83	DO NOT CONNECT
A84	VSS	Ground	B84	RESERVED_B84	DO NOT CONNECT
A85	D#[11]	AGTL+ I/O	B85	VCC_CORE	CPU Core V _{CC}
A86	D#[10]	AGTL+ I/O	B86	D#[17]	AGTL+ I/O
A87	VSS	Ground	B87	D#[15]	AGTL+ I/O
A88	D#[14]	AGTL+ I/O	B88	VCC_CORE	CPU Core V _{CC}
A89	D#[09]	AGTL+ I/O	B89	D#[12]	AGTL+ I/O
A90	VSS	Ground	B90	D#[07]	AGTL+ I/O
A91	D#[08]	AGTL+ I/O	B91	VCC_CORE	CPU Core V _{CC}
A92	D#[05]	AGTL+ I/O	B92	D#[06]	AGTL+ I/O
A93	VSS	Ground	B93	D#[04]	AGTL+ I/O
A94	D#[03]	AGTL+ I/O	B94	VCC_CORE	CPU Core V _{CC}
A95	D#[01]	AGTL+ I/O	B95	D#[02]	AGTL+ I/O
A96	VSS	Ground	B96	D#[00]	AGTL+ I/O
A97	BCLK	System Bus Clock	B97	VCC_CORE	CPU Core V _{CC}
A98	TEST_VSS_A98	Pull down to V _{SS}	B98	RESET#	AGTL+ Input
A99	VSS	Ground	B99	FRCERR	AGTL+ I/O
A100	BERR#	AGTL+ I/O	B100	VCC_CORE	CPU Core V _{CC}
A101	A#[33]	AGTL+ I/O	B101	A#[35]	AGTL+ I/O
A102	VSS	Ground	B102	A#[32]	AGTL+ I/O
A103	A#[34]	AGTL+ I/O	B103	VCC_CORE	CPU Core V _{CC}
A104	A#[30]	AGTL+ I/O	B104	A#[29]	AGTL+ I/O
A105	VSS	Ground	B105	A#[26]	AGTL+ I/O
A106	A#[31]	AGTL+ I/O	B106	VCC_L2	L2 Cache V _{CC}



Table 40. Signal Listing in Order by Pin Number (Continued)

Pin No.	Pin Name	Signal Buffer Type	Pin No.	Pin Name	Signal Buffer Type
A107	A#[27]	AGTL+ I/O	B107	A#[24]	AGTL+ I/O
A108	VSS	Ground	B108	A#[28]	AGTL+ I/O
A109	A#[22]	AGTL+ I/O	B109	VCC_L2	L2 Cache V _{CC}
A110	A#[23]	AGTL+ I/O	B110	A#[20]	AGTL+ I/O
A111	VSS	Ground	B111	A#[21]	AGTL+ I/O
A112	A#[19]	AGTL+ I/O	B112	VCC_L2	L2 Cache V _{CC}
A113	A#[18]	AGTL+ I/O	B113	A#[25]	AGTL+ I/O
A114	VSS	Ground	B114	A#[15]	AGTL+ I/O
A115	A#[16]	AGTL+ I/O	B115	VCC_L2	L2 Cache V _{CC}
A116	A#[13]	AGTL+ I/O	B116	A#[17]	AGTL+ I/O
A117	VSS	Ground	B117	A#[11]	AGTL+ I/O
A118	A#[14]	AGTL+ I/O	B118	VCC_L2	L2 Cache V _{CC}
A119	VSS	Ground	B119	A#[12]	AGTL+ I/O
A120	A#[10]	AGTL+ I/O	B120	VCC_L2	L2 Cache V _{CC}
A121	A#[05]	AGTL+ I/O	B121	A#[08]	AGTL+ I/O
A122	VSS	Ground	B122	A#[07]	AGTL+ I/O
A123	A#[09]	AGTL+ I/O	B123	VCC_L2	L2 Cache V _{CC}
A124	A#[04]	AGTL+ I/O	B124	A#[03]	AGTL+ I/O
A125	VSS	Ground	B125	A#[06]	AGTL+ I/O
A126	RESERVED_A126	DO NOT CONNECT	B126	VCC_L2	L2 Cache V _{CC}
A127	BNR#	AGTL+ I/O	B127	AERR#	AGTL+ I/O
A128	VSS	Ground	B128	REQ#[0]	AGTL+ I/O
A129	BPRI#	AGTL+ Input	B129	VCC_L2	L2 Cache V _{CC}
A130	TRDY#	AGTL+ Input	B130	REQ#[1]	AGTL+ I/O
A131	VSS	Ground	B131	REQ#[4]	AGTL+ I/O
A132	DEFER#	AGTL+ Input	B132	VCC_L2	L2 Cache V _{CC}
A133	REQ#[2]	AGTL+ I/O	B133	LOCK#	AGTL+ I/O
A134	VSS	Ground	B134	DRDY#	AGTL+ I/O
A135	REQ#[3]	AGTL+ I/O	B135	VCC_L2	L2 Cache V _{CC}
A136	HITM#	AGTL+ I/O	B136	RS#[0]	AGTL+ Input
A137	VSS	Ground	B137	HIT#	AGTL+ I/O
A138	DBSY#	AGTL+ I/O	B138	VCC_L2	L2 Cache V _{CC}
A139	RS#[1]	AGTL+ Input	B139	RS#[2]	AGTL+ Input
A140	VSS	Ground	B140	RP#	AGTL+ I/O
A141	BR2#	AGTL+ Input	B141	VCC_L2	L2 Cache V _{CC}
A142	BR0#	AGTL+ I/O	B142	BR3#	AGTL+ Input

Table 40. Signal Listing in Order by Pin Number (Continued)

Pin No.	Pin Name	Signal Buffer Type	Pin No.	Pin Name	Signal Buffer Type
A143	VSS	Ground	B143	BR1#	AGTL+ Input
A144	ADS#	AGTL+ I/O	B144	VCC_L2	L2 Cache V _{CC}
A145	AP#[0]	AGTL+ I/O	B145	RSP#	AGTL+ Input
A146	VSS	Ground	B146	AP#[1]	AGTL+ I/O
A147	VID_CORE[2]	Open or Short to V _{SS}	B147	VCC_L2	L2 Cache V _{CC}
A148	VID_CORE[1]	Open or Short to V _{SS}	B148	WP	SMBus Input
A149	VSS	Ground	B149	VID_CORE[3]	Open or Short to V _{SS}
A150	VID_CORE[4]	Open or Short to V _{SS}	B150	VCC_L2	L2 Cache V _{CC}
A151	SMBALERT#	SMBus Alert	B151	VID_CORE[0]	Open or Short to V _{SS}
A152	VSS	Ground	B152	VID_L2[0]	Open or Short to V _{SS}
A153	VID_L2[2]	Open or Short to V _{SS}	B153	VCC_L2	L2 Cache V _{CC}
A154	VID_L2[1]	Open or Short to V _{SS}	B154	VID_L2[4]	Open or Short to V _{SS}
A155	VSS	Ground	B155	VID_L2[3]	Open or Short to V _{SS}
A156	V _{TT}	AGTL+ V _{TT} Supply	B156	VCC_L2	L2 Cache V _{CC}
A157	V _{TT}	AGTL+ V _{TT} Supply	B157	V _{TT}	AGTL+ V _{TT} Supply
A158	VSS	Ground	B158	V _{TT}	AGTL+ V _{TT} Supply
A159	SA2	SMBus Input	B159	VCC_L2	L2 Cache V _{CC}
A160	VCC_SM	SMBus Supply	B160	SMBCLK	SMBus Clock
A161	VSS	Ground	B161	SMBDAT	SMBus Data
A162	SA1	SMBus Input	B162	VCC_L2	L2 Cache V _{CC}
A163	SA0	SMBus Input	B163	RESERVED_B163	DO NOT CONNECT
A164	VSS	Ground	B164	EMI	Connect to V _{SS}
A165	PWR_EN[0]	Short to PWR_EN[1]	B165	EMI	Connect to V _{SS}



Table 41. Signal Listing in Order by Pin Name

Pin No.	Pin Name	Signal Buffer Type
B124	A#[03]	AGTL+ I/O
A124	A#[04]	AGTL+ I/O
A121	A#[05]	AGTL+ I/O
B125	A#[06]	AGTL+ I/O
B122	A#[07]	AGTL+ I/O
B121	A#[08]	AGTL+ I/O
A123	A#[09]	AGTL+ I/O
A120	A#[10]	AGTL+ I/O
B117	A#[11]	AGTL+ I/O
B119	A#[12]	AGTL+ I/O
A116	A#[13]	AGTL+ I/O
A118	A#[14]	AGTL+ I/O
B114	A#[15]	AGTL+ I/O
A115	A#[16]	AGTL+ I/O
B116	A#[17]	AGTL+ I/O
A113	A#[18]	AGTL+ I/O
A112	A#[19]	AGTL+ I/O
B110	A#[20]	AGTL+ I/O
B111	A#[21]	AGTL+ I/O
A109	A#[22]	AGTL+ I/O
A110	A#[23]	AGTL+ I/O
B107	A#[24]	AGTL+ I/O
B113	A#[25]	AGTL+ I/O
B105	A#[26]	AGTL+ I/O
A107	A#[27]	AGTL+ I/O
B108	A#[28]	AGTL+ I/O
B104	A#[29]	AGTL+ I/O
A104	A#[30]	AGTL+ I/O
A106	A#[31]	AGTL+ I/O
B102	A#[32]	AGTL+ I/O
A101	A#[33]	AGTL+ I/O
A103	A#[34]	AGTL+ I/O
B101	A#[35]	AGTL+ I/O
A14	A20M#	CMOS Input
A144	ADS#	AGTL+ I/O

Pin No.	Pin Name	Signal Buffer Type
B127	AERR#	AGTL+ I/O
A145	AP#[0]	AGTL+ I/O
B146	AP#[1]	AGTL+ I/O
A97	BCLK	System Bus Clock
A100	BERR#	AGTL+ I/O
A35	BINIT#	AGTL+ I/O
A127	BNR#	AGTL+ I/O
B33	BP#[2]	AGTL+ I/O
A32	BP#[3]	AGTL+ I/O
A33	BPM#[0]	AGTL+ I/O
B37	BPM#[1]	AGTL+ I/O
A129	BPRI#	AGTL+ Input
A142	BR0#	AGTL+ I/O
B143	BR1#	AGTL+ Input
A141	BR2#	AGTL+ Input
B142	BR3#	AGTL+ Input
B96	D#[00]	AGTL+ I/O
A95	D#[01]	AGTL+ I/O
B95	D#[02]	AGTL+ I/O
A94	D#[03]	AGTL+ I/O
B93	D#[04]	AGTL+ I/O
A92	D#[05]	AGTL+ I/O
B92	D#[06]	AGTL+ I/O
B90	D#[07]	AGTL+ I/O
A91	D#[08]	AGTL+ I/O
A89	D#[09]	AGTL+ I/O
A86	D#[10]	AGTL+ I/O
A85	D#[11]	AGTL+ I/O
B89	D#[12]	AGTL+ I/O
A80	D#[13]	AGTL+ I/O
A88	D#[14]	AGTL+ I/O
B87	D#[15]	AGTL+ I/O
A79	D#[16]	AGTL+ I/O
B86	D#[17]	AGTL+ I/O
B80	D#[18]	AGTL+ I/O

Table 41. Signal Listing in Order by Pin Name
 (Continued)

Pin No.	Pin Name	Signal Buffer Type
B78	D#[19]	AGTL+ I/O
B81	D#[20]	AGTL+ I/O
A77	D#[21]	AGTL+ I/O
B77	D#[22]	AGTL+ I/O
A76	D#[23]	AGTL+ I/O
A74	D#[24]	AGTL+ I/O
A71	D#[30]	AGTL+ I/O
A70	D#[31]	AGTL+ I/O
B69	D#[32]	AGTL+ I/O
A67	D#[33]	AGTL+ I/O
B66	D#[34]	AGTL+ I/O
A68	D#[35]	AGTL+ I/O
B63	D#[36]	AGTL+ I/O
A65	D#[37]	AGTL+ I/O
B68	D#[38]	AGTL+ I/O
A61	D#[39]	AGTL+ I/O
B65	D#[40]	AGTL+ I/O
B59	D#[41]	AGTL+ I/O
A58	D#[42]	AGTL+ I/O
A64	D#[43]	AGTL+ I/O
B62	D#[44]	AGTL+ I/O
A59	D#[45]	AGTL+ I/O
A51	D#[46]	AGTL+ I/O
B60	D#[47]	AGTL+ I/O
B54	D#[48]	AGTL+ I/O
A53	D#[49]	AGTL+ I/O
B49	D#[50]	AGTL+ I/O
A54	D#[51]	AGTL+ I/O
B55	D#[52]	AGTL+ I/O
A48	D#[53]	AGTL+ I/O
B51	D#[54]	AGTL+ I/O
A45	D#[55]	AGTL+ I/O
B48	D#[56]	AGTL+ I/O
A50	D#[57]	AGTL+ I/O
B45	D#[58]	AGTL+ I/O
B52	D#[59]	AGTL+ I/O
A47	D#[60]	AGTL+ I/O

Pin No.	Pin Name	Signal Buffer Type
A44	D#[61]	AGTL+ I/O
B43	D#[62]	AGTL+ I/O
A138	DBSY#	AGTL+ I/O
A132	DEFER#	AGTL+ Input
A36	DEP#[0]	AGTL+ I/O
A38	DEP#[1]	AGTL+ I/O
B39	DEP#[2]	AGTL+ I/O
A39	DEP#[3]	AGTL+ I/O
B40	DEP#[4]	AGTL+ I/O
A41	DEP#[5]	AGTL+ I/O
A42	DEP#[6]	AGTL+ I/O
B42	DEP#[7]	AGTL+ I/O
B134	DRDY#	AGTL+ I/O
A1	EMI	Connect to V _{SS}
A3	EMI	Connect to V _{SS}
B164	EMI	Connect to V _{SS}
B165	EMI	Connect to V _{SS}
A15	FERR#	CMOS Output
B10	FLUSH#	CMOS Input
B99	FRCERR	AGTL+ I/O
B137	HIT#	AGTL+ I/O
A136	HITM#	AGTL+ I/O
A12	IERR#	CMOS Output
A17	IGNNE#	CMOS Input
B13	INIT#	CMOS Input
A27	LINT[0]	CMOS Input
B28	LINT[1]	CMOS Input
B133	LOCK#	AGTL+ I/O
B30	PICCLK	APIC Clock Input
A29	PICD[0]	CMOS I/O
B31	PICD[1]	CMOS I/O
B36	PRDY#	AGTL+ Output
A30	PREQ#	CMOS Input
A165	PWR_EN[0]	Short to PWR_EN[1]
B1	PWR_EN[1]	Short to PWR_EN[0]
A21	PWRGOOD	CMOS Input
B128	REQ#[0]	AGTL+ I/O



Table 41. Signal Listing in Order by Pin Name
(Continued)

Pin No.	Pin Name	Signal Buffer Type
B130	REQ#[1]	AGTL+ I/O
A133	REQ#[2]	AGTL+ I/O
A135	REQ#[3]	AGTL+ I/O
B131	REQ#[4]	AGTL+ I/O
A126	RESERVED_A126	DO NOT CONNECT
A26	RESERVED_A26	DO NOT CONNECT
A56	RESERVED_A56	DO NOT CONNECT
A83	RESERVED_A83	DO NOT CONNECT
B163	RESERVED_B163	DO NOT CONNECT
B22	RESERVED_B22	DO NOT CONNECT
B24	RESERVED_B24	DO NOT CONNECT
B25	RESERVED_B25	DO NOT CONNECT
B3	RESERVED_B3	DO NOT CONNECT
B34	RESERVED_B34	DO NOT CONNECT
B57	RESERVED_B57	DO NOT CONNECT
B83	RESERVED_B83	DO NOT CONNECT
B84	RESERVED_B84	DO NOT CONNECT
B9	RESERVED_B9	DO NOT CONNECT
B98	RESET#	AGTL+ Input
B140	RP#	AGTL+ I/O
B136	RS#[0]	AGTL+ Input
A139	RS#[1]	AGTL+ Input
B139	RS#[2]	AGTL+ Input
B145	RSP#	AGTL+ Input
A163	SA0	SMBus Input
A162	SA1	SMBus Input
A159	SA2	SMBus Input
A9	SELFSB0	CMOS I/O
B18	SLP#	CMOS Input
A151	SMBALERT#	SMBus Alert
B160	SMBCLK	SMBus Clock
B161	SMBDAT	SMBus I/O
B12	SMI#	CMOS Input
B15	STPCLK#	CMOS Input
B16	TCK	TAP Clock
A18	TDI	TAP Input
A20	TDO	TAP Output

Pin No.	Pin Name	Signal Buffer Type
A62	TEST_25_A62	Pull up to 2.5 V
A23	TEST_VCC_CORE_A23	Pull up to VCC_CORE
B27	TEST_VCC_CORE_B27	Pull up to VCC_CORE
A11	TEST_VSS_A11	Pull down to V _{SS}
A98	TEST_VSS_A98	Pull down to V _{SS}
B4	TEST_VSS_B4	Pull down to V _{SS}
A82	TEST_VTT_A82	Pull up to V _{TT}
A24	THERMTRIP#	CMOS Output
B19	TMS	TAP Input
A130	TRDY#	AGTL+ Input
B21	TRST#	TAP Input
B100	VCC_CORE	CPU Core V _{CC}
B103	VCC_CORE	CPU Core V _{CC}
B11	VCC_CORE	CPU Core V _{CC}
B14	VCC_CORE	CPU Core V _{CC}
B17	VCC_CORE	CPU Core V _{CC}
B2	VCC_CORE	CPU Core V _{CC}
B20	VCC_CORE	CPU Core V _{CC}
B23	VCC_CORE	CPU Core V _{CC}
B26	VCC_CORE	CPU Core V _{CC}
B29	VCC_CORE	CPU Core V _{CC}
B32	VCC_CORE	CPU Core V _{CC}
B35	VCC_CORE	CPU Core V _{CC}
B38	VCC_CORE	CPU Core V _{CC}
B41	VCC_CORE	CPU Core V _{CC}
B44	VCC_CORE	CPU Core V _{CC}
B47	VCC_CORE	CPU Core V _{CC}
B5	VCC_CORE	CPU Core V _{CC}
B50	VCC_CORE	CPU Core V _{CC}
B53	VCC_CORE	CPU Core V _{CC}
B56	VCC_CORE	CPU Core V _{CC}
B58	VCC_CORE	CPU Core V _{CC}
B61	VCC_CORE	CPU Core V _{CC}
B64	VCC_CORE	CPU Core V _{CC}
B67	VCC_CORE	CPU Core V _{CC}
B70	VCC_CORE	CPU Core V _{CC}
B73	VCC_CORE	CPU Core V _{CC}

Table 41. Signal Listing in Order by Pin Name
 (Continued)

Pin No.	Pin Name	Signal Buffer Type
B76	VCC_CORE	CPU Core V _{CC}
B79	VCC_CORE	CPU Core V _{CC}
B8	VCC_CORE	CPU Core V _{CC}
B82	VCC_CORE	CPU Core V _{CC}
B85	VCC_CORE	CPU Core V _{CC}
B88	VCC_CORE	CPU Core V _{CC}
B91	VCC_CORE	CPU Core V _{CC}
B94	VCC_CORE	CPU Core V _{CC}
B97	VCC_CORE	CPU Core V _{CC}
B106	VCC_L2	L2 Cache V _{CC}
B109	VCC_L2	L2 Cache V _{CC}
B112	VCC_L2	L2 Cache V _{CC}
B115	VCC_L2	L2 Cache V _{CC}
B118	VCC_L2	L2 Cache V _{CC}
B120	VCC_L2	L2 Cache V _{CC}
B123	VCC_L2	L2 Cache V _{CC}
B126	VCC_L2	L2 Cache V _{CC}
B129	VCC_L2	L2 Cache V _{CC}
B132	VCC_L2	L2 Cache V _{CC}
B135	VCC_L2	L2 Cache V _{CC}
B138	VCC_L2	L2 Cache V _{CC}
B141	VCC_L2	L2 Cache V _{CC}
B144	VCC_L2	L2 Cache V _{CC}
B147	VCC_L2	L2 Cache V _{CC}
B150	VCC_L2	L2 Cache V _{CC}
B153	VCC_L2	L2 Cache V _{CC}
B156	VCC_L2	L2 Cache V _{CC}
B159	VCC_L2	L2 Cache V _{CC}
B162	VCC_L2	L2 Cache V _{CC}
A160	VCC_SM	SMBus Supply
A2	VCC_TAP	TAP Supply
B151	VID_CORE[0]	Open or Short to V _{SS}
A148	VID_CORE[1]	Open or Short to V _{SS}
A147	VID_CORE[2]	Open or Short to V _{SS}
B149	VID_CORE[3]	Open or Short to V _{SS}
A150	VID_CORE[4]	Open or Short to V _{SS}
B152	VID_L2[0]	Open or Short to V _{SS}

Pin No.	Pin Name	Signal Buffer Type
A154	VID_L2[1]	Open or Short to V _{SS}
A153	VID_L2[2]	Open or Short to V _{SS}
B155	VID_L2[3]	Open or Short to V _{SS}
B154	VID_L2[4]	Open or Short to V _{SS}
A10	VSS	Ground
A102	VSS	Ground
A105	VSS	Ground
A108	VSS	Ground
A111	VSS	Ground
A114	VSS	Ground
A117	VSS	Ground
A119	VSS	Ground
A122	VSS	Ground
A125	VSS	Ground
A128	VSS	Ground
A13	VSS	Ground
A131	VSS	Ground
A134	VSS	Ground
A137	VSS	Ground
A140	VSS	Ground
A143	VSS	Ground
A146	VSS	Ground
A149	VSS	Ground
A152	VSS	Ground
A155	VSS	Ground
A158	VSS	Ground
A16	VSS	Ground
A161	VSS	Ground
A164	VSS	Ground
A19	VSS	Ground
A22	VSS	Ground
A25	VSS	Ground
A28	VSS	Ground
A31	VSS	Ground
A34	VSS	Ground
A37	VSS	Ground
A4	VSS	Ground



Table 41. Signal Listing in Order by Pin Name
(Continued)

Pin No.	Pin Name	Signal Buffer Type
A40	VSS	Ground
A43	VSS	Ground
A46	VSS	Ground
A49	VSS	Ground
A52	VSS	Ground
A55	VSS	Ground
A57	VSS	Ground
A60	VSS	Ground
A63	VSS	Ground
A66	VSS	Ground
A69	VSS	Ground
A7	VSS	Ground
A72	VSS	Ground
A75	VSS	Ground
A78	VSS	Ground
A8	VSS	Ground
A81	VSS	Ground
A84	VSS	Ground
A87	VSS	Ground
A90	VSS	Ground
A93	VSS	Ground
A96	VSS	Ground
A99	VSS	Ground
A156	VTT	AGTL+ V _{TT} Supply
A157	VTT	AGTL+ V _{TT} Supply
A5	VTT	AGTL+ V _{TT} Supply
A6	VTT	AGTL+ V _{TT} Supply
B157	VTT	AGTL+ V _{TT} Supply
B158	VTT	AGTL+ V _{TT} Supply
B6	VTT	AGTL+ V _{TT} Supply
B7	VTT	AGTL+ V _{TT} Supply
B148	WP	SMBus Input

7.0. BOXED PROCESSOR SPECIFICATIONS

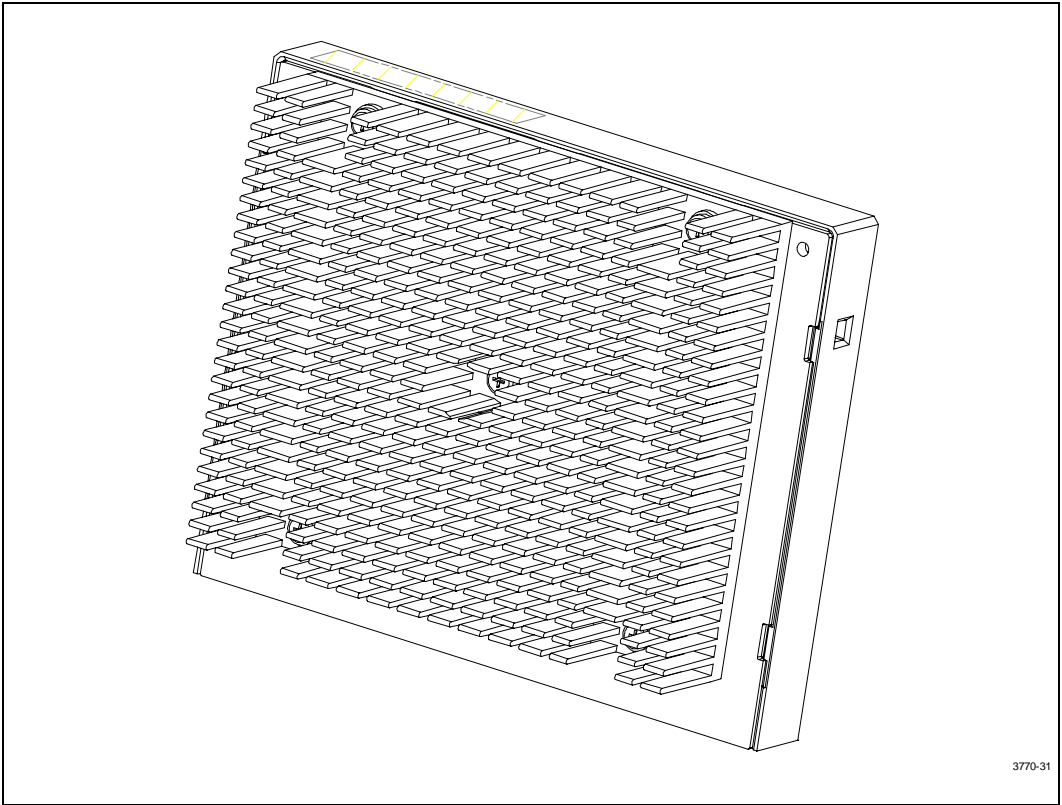
7.1. Introduction

The Pentium II Xeon processor is also offered as an Intel boxed processor. Intel boxed processors are intended for system integrators who build systems from motherboards and off-the-shelf components. The boxed Pentium II Xeon processor is supplied with an attached passive heatsink. This section documents motherboard and system requirements for the heatsink that will be supplied with the boxed Pentium II Xeon processor. This section is particularly important for OEMs that manufacture motherboards for system integrators. Unless otherwise noted, all figures in this chapter are dimensioned in inches. Figure 31 shows a mechanical representation of the boxed Pentium II Xeon processor.

7.2. Mechanical Specifications

This section documents the mechanical specifications of the boxed Pentium II Xeon processor heatsink.

The boxed processor ships with an attached passive heatsink. Clearance is required around the heatsink to ensure proper installation of the processor and unimpeded airflow for proper cooling. The space requirements and dimensions for the boxed processor are shown in Figure 32 (Side View) and Figure 33 (Front View). All dimensions are in inches.



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Figure 31. Boxed Pentium® II Xeon™ Processor

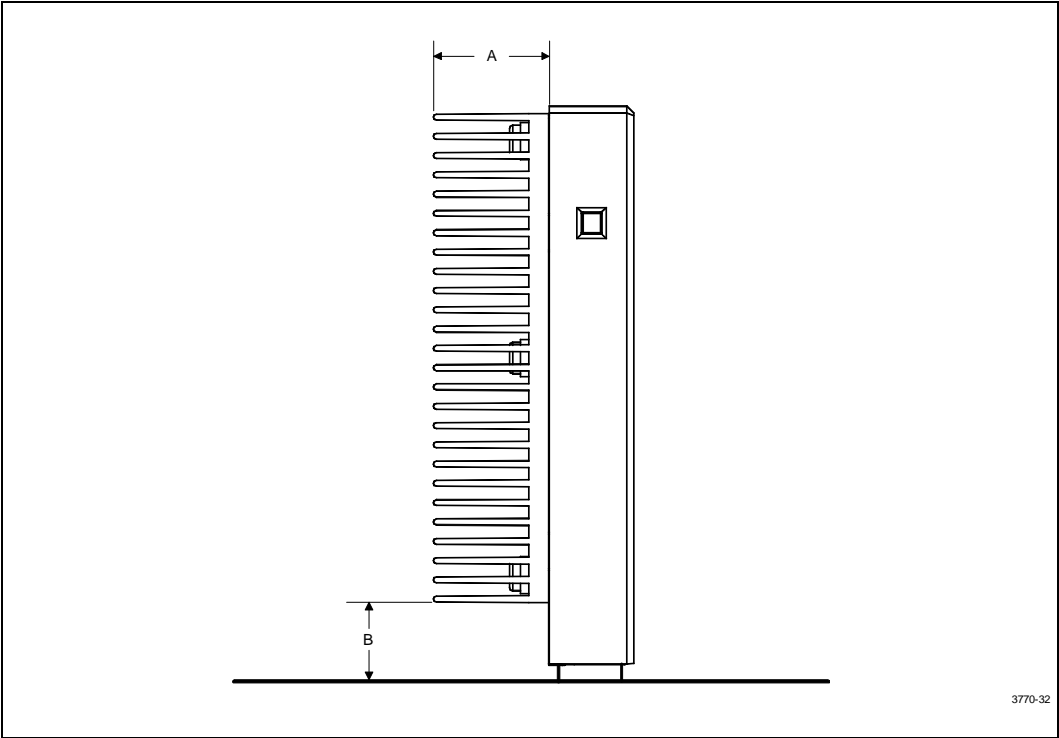
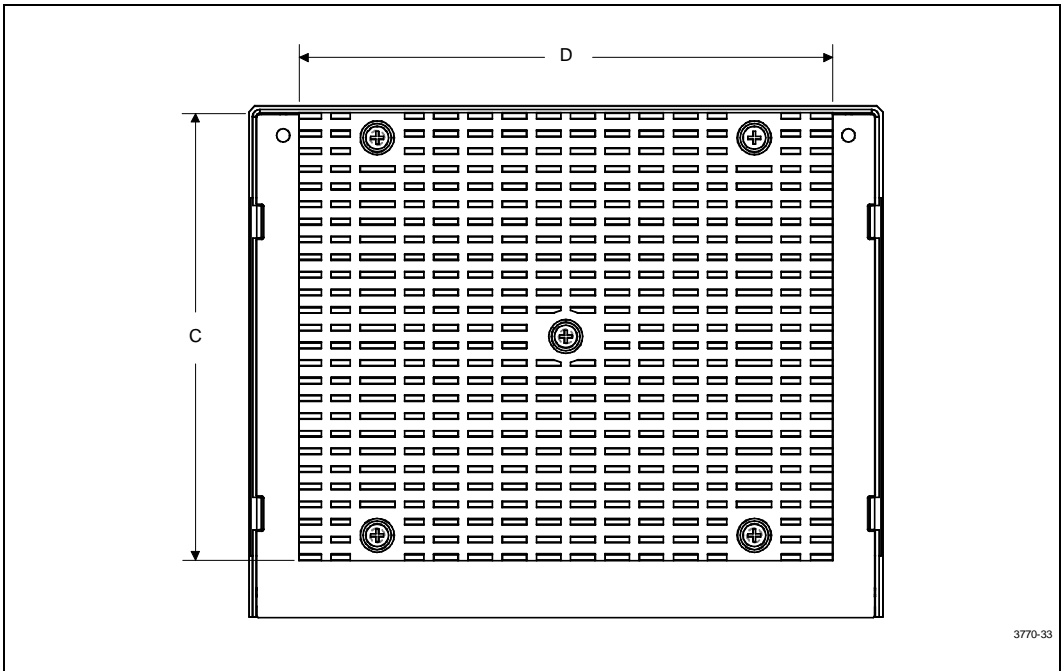


Figure 32. Side View Space Requirements for the Boxed Processor



3770-33

Figure 33. Front View Space Requirements for the Boxed Processor

7.2.1. BOXED PROCESSOR HEATSINK DIMENSIONS

Table 42. Boxed Processor Heatsink Dimensions

Fig. Ref. Label	Dimensions (Inches)	Min	Typ	Max
A	Heatsink Depth (off heatsink attach pont)		1.025	
B	Heatsink Height (above motherboard)		0.626	
C	Heatsink Height (see front view)		4.235	
D	Heatsink Width (see front view)		5.05	

7.2.2. BOXED PROCESSOR HEATSINK WEIGHT

The boxed processor heatsink will not weigh more than 350 grams.

7.2.3. BOXED PROCESSOR RETENTION MECHANISM

The boxed Pentium II Xeon processor requires a retention mechanism that supports and secures the Single Edge Contact Cartridge (S.E.C.C.) in the 330-contact slot connector. An S.E.C.C. retention mechanism is not provided with the boxed processor. Motherboards designed for use by system integrators should include a retention mechanism and appropriate installation instructions. The boxed Pentium II Xeon processor does not require additional heatsink supports. Heatsink supports will not ship with the boxed Pentium II Xeon processor.

7.3. Thermal Specifications

This section describes the cooling requirements of the heatsink solution utilized by the boxed processor.

7.3.1. BOXED PROCESSOR COOLING REQUIREMENTS

The boxed processor passive heatsink requires airflow horizontally across the heatsink to cool the processor. The boxed processor heatsink will keep the processor thermal plate temperature, T_{PLATE} , within the specifications, provided adequate airflow is directed into the system chassis, across the heatsink and out of the system chassis. System integrators should perform thermal testing using thermocouples (see Section 5.2.) to evaluate the thermal efficiency of the system. Alternately, system integrators may use software to monitor the thermal information available via the Processor Information ROM and information from the thermal sensor (see Section 4.3.) to evaluate the thermal efficiency of the system.

7.3.2. THERMAL EVALUATION

Given the complex and unique nature of motherboard layouts, and the special chassis required to support them, thermal performance may vary greatly with each motherboard/chassis combination. Motherboard manufacturers must

evaluate and recommend effective thermal solutions for their specific designs, particularly designs that are proprietary or have nonstandard layouts. Such thermal solutions must take all system components into account. The power requirements of all processors that will be supported by the motherboard should be accommodated.

8.0. INTEGRATION TOOLS

The integration tool set for Pentium II Xeon processor system designs will include an In-Target Probe (ITP) for program execution control, register/memory/IO access, and breakpoint control. This tool provides functionality commonly associated with debuggers and emulators. The ITP uses the on-chip debug features of the Pentium II Xeon processor to provide program execution control. Use of the ITP will not affect the high speed operations of the processor signals, ensuring the system can operate at full speed with the ITP attached.

This document describes the ITP as well as a number of technical issues that must be taken into account when including the ITP and logic analyzer interconnect tools in a debug strategy. Although the tool description that follows is specific to early tools available from Intel, similar tools may also be provided in the future by third-party vendors. Thus, the tools mentioned should not be considered as Intel's tools, but as debug tools in the generic sense.

In general, the information in this chapter may be used as a basis for including integration tools in any Pentium II Xeon processor-based system design. The logic analyzer interconnect tool keep-out zones described in this chapter should be used as general guidelines for Pentium II Xeon processor system design.

8.1. In-Target Probe (ITP) for Pentium® II Xeon™ Processors

An In-Target Probe (ITP) for Pentium II Xeon processors is a debug tool which allows access to on-chip debug features via a small port on the system board called the debug port. The ITP communicates to the processor through the debug port using a combination of hardware and software. The software is Windows NT 4.0 running

on a host PC. The hardware consists of a PCI board in the host PC connected to the signals which make up the Pentium II Xeon processor's debug interface. Due to the nature of the ITP, the processor may be controlled without affecting any high speed signals. This ensures that the system can operate at full speed with the ITP attached. **Intel will use an ITP for internal debug and system validation and recommends that all Pentium II Xeon processor-based system designs include a debug port.** This is especially important if Intel assistance is required in debugging a system-processor interrelationship issue.

8.1.1. PRIMARY FUNCTION

The primary function of an ITP is to provide a control and query interface for one or more processors. With an ITP, one can control program execution and have the ability to access processor registers, system memory and I/O. Thus, one can start and stop program execution using a variety of breakpoints, single-step the program at the assembly code level, as well as read and write registers, memory and I/O. The on-chip debug features will be controlled from a Windows NT 4.0 software application running on a Pentium or Pentium Pro processor-based PC with a PCI card slot. (See Figure 34.)

8.1.2. DEBUG PORT CONNECTOR DESCRIPTION

The ITP will connect to the system through the debug port. Recommended connectors, to mate the ITP cable with the debug port on the board, are available in either a vertical or right-angle configuration. Both configurations fit into the same board footprint. The connectors are manufactured by AMP Incorporated and are in the AMPMODU System 50 line. Following are the AMP part numbers for the two connectors:

- Amp 30-pin shrouded vertical header: 104068-3
- Amp 30-pin shrouded right-angle header: 104069-5

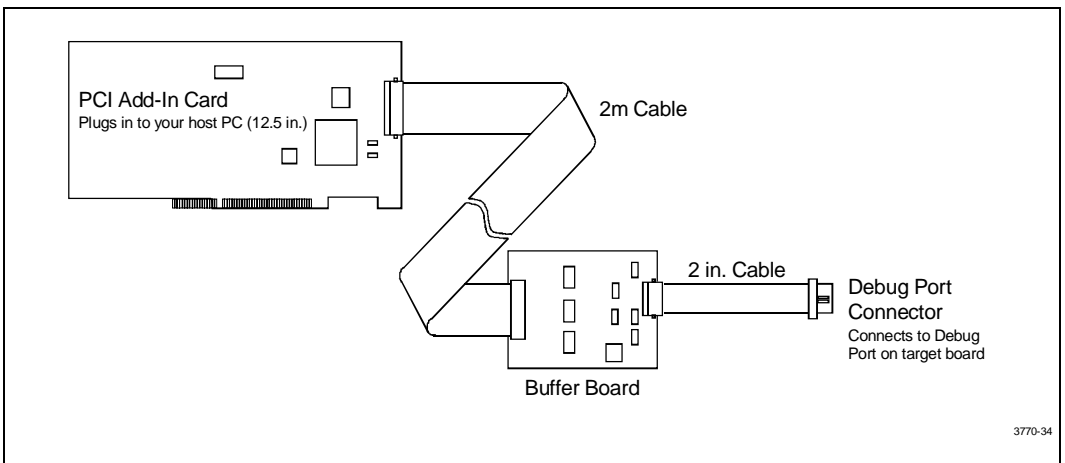
NOTE

These are high density through hole connectors with pins on 0.050 in. by 0.100 in. centers. Do not confuse these with the more common 0.100 in. by 0.100 in. center headers.

The debug port must be mounted on the system motherboard; the processor does not contain a debug port.

8.1.3. DEBUG PORT SIGNAL DESCRIPTIONS

Table 43 describes the debug port signals and provides the pin assignment.



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Figure 34. Hardware Components of the ITP

Table 43. Debug Port Pinout Description and Requirements¹

Name	Pin	Description	Specification Requirement	Notes
RESET#	1	Reset signal from MP cluster to ITP.	<p>Terminate² signal properly at the debug port</p> <p>Debug port must be at the end of the signal trace</p>	Connected to high speed comparator (biased at 2/3 of the level found at the POWERON pin) on the ITP buffer board. Additional load does not change timing calculations for the processor bus agents if routed properly.
DBRESET#	3	Allows ITP to reset entire target system.	<p>Tie signal to target system reset (recommendation: PWR OK signal on PCIsset as an ORed input)</p> <p>Pulled-up signal with the proper resistor (see notes)</p>	Open drain output from ITP to the target system. It will be held asserted for 100 ms; capacitance needs to be small enough to recognize assert. The pull-up resistor should be picked to (1) meet VIL of target system and (2) meet specified rise time.
TCK	5	The TAP (Test Access Port) clock from ITP to MP cluster.	<p>Add 1.0kΩ pull-up resistor to V_{CC}TAP near driver</p> <p>For SMP systems, each processor should receive a separately buffered TCK.</p> <p>Add a series termination resistor or a Bessel filter on each output.</p>	<p>Poor routing can cause multiple clocking problems. Should be routed to all components in the boundary scan.³</p> <p>Simulations should be run to determine the proper value for series termination or Bessel filter.</p>
TMS	7	Test mode select signal from ITP to MP cluster, controls the TAP finite state machine.	<p>Add 1.0kΩ pull-up resistor to V_{CC}TAP near driver</p> <p>For SMP systems, each processor should receive a separately buffered TMS.</p> <p>Add a series termination resistor on each output.</p>	<p>Operates synchronously with TCK. Should be routed to all components in the boundary scan.³</p> <p>Simulations should be run to determine the proper value for series termination.</p>
TDI	8	Test data input signal from ITP to first component in boundary scan chain of MP cluster; inputs test instructions and data serially.	<p>This signal is open-drain from the ITP. However, TDI is pulled up to V_{CC}TAP with ~150Ω on the Pentium® II Xeon™ processor. Add a 150 to 330Ω pull-up resistor (to V_{CC}TAP) if TDI will not be connected directly to a processor.</p>	Operates synchronously with TCK.

Table 43. Debug Port Pinout Description and Requirements¹ (Continued)

Name	Pin	Description	Specification Requirement	Notes
POWERON	9	Used by ITP to determine when target system power is ON and, once target system is ON, enables all debug port electrical interface activity. From target V_{TT} to ITP.	Add 1k Ω pull-up resistor (to V_{TT})	If no power is applied, the ITP will not drive any signals; isolation provided using isolation gates. Voltage applied is internally used to set AGTL+ threshold (or reference) at 2/3 V_{TT} .
TDO	10	Test data output signal from last component in boundary scan chain of MP cluster to ITP; test output is read serially.	Add 150 Ω pull-up resistor (to $V_{CC_{TAP}}$) Design pull-ups to route around empty processor sockets (so resistors are not in parallel)	Operates synchronously with TCK. Each Pentium II Xeon processor has a 25 Ω driver.
DBINST#	11	Indicates to target system that the ITP is installed.	Add ~10k Ω pull-up resistor	Not required if boundary scan is not used in target system.
TRST#	12	Test reset signal from ITP to MP cluster, used to reset TAP logic.	Add ~680 Ω pull-down	Asynchronous input signal. To disable TAP reset if ITP not installed.
BSEN#	14	Informs target system that ITP is using boundary scan.		Not required if boundary scan is not used in target system.
PREQ0#	16	PREQ0# signal, driven by ITP, makes requests to P0 to enter debug.	Add 150 to 330 Ω pull-up resistor (to $V_{CC_{2.5}}$)	
PRDY0#	18	PRDY0# signal, driven by P0, informs ITP that P0 is ready for debug.	Terminate ² signal properly at the debug port Debug port must be at the end of the signal trace	Connected to high speed comparator (biased at 2/3 of the level found at the POWERON pin) on the ITP buffer board. Additional load does not change timing calculations for the processor bus agents if routed properly.
PREQ1#	20	PREQ1# signal from ITP to P1.	Add 150 to 330 Ω pull-up resistor (to $V_{CC_{2.5}}$)	
PRDY1#	22	PRDY1# signal from P1 to ITP.	Terminate ² signal properly at the debug port Debug port must be at the end of the signal trace	Connected to high speed comparator (biased at 2/3 of the level found at the POWERON pin) on the ITP buffer board. Additional load does not change timing calculations for the processor bus agents.
PREQ2#	24	PREQ2# signal from ITP to P2.	Add 150 to 330 Ω pull-up resistor (to $V_{CC_{2.5}}$)	
PRDY2#	26	PRDY2# signal from ITP to P2.	Terminate ² signal properly at the debug port Debug port must be at the end of the signal trace	Connected to high speed comparator (biased at 2/3 of the level found at the POWERON pin) on the ITP buffer board. Additional load does not change timing calculations for the processor

Table 43. Debug Port Pinout Description and Requirements¹ (Continued)

Name	Pin	Description	Specification Requirement	Notes
				bus agents if routed properly.
PREQ3#	28	PREQ3# signal from ITP to P3.	Add 150 to 330Ω pull-up resistor (to $V_{CC2.5}$)	
PRDY3#	30	PRDY3# signal from ITP to P3.	Terminate ² signal properly at the debug port Debug port must be at the end of the signal trace	Connected to high speed comparator (biased at 2/3 of the level found at the POWERON pin) on the ITP buffer board. Additional load does not change timing calculations for the processor bus agents if routed properly.
BCLK	29	Bus clock from the MP cluster.	Use a separate driver to drive signal to the debug port Must be connected to support future steppings of the Pentium II Xeon processor.	A separate driver should be used to avoid loading issues associated with having the ITP either installed or not installed.
GND	2, 4, 6, 13, 15, 17, 19, 21, 23, 25, 27	Signal ground.	Connect all pins to signal ground	

NOTES:

1. Resistor values with “-” preceding them can vary from the specified value; use resistor as close as possible to the value specified.
2. Termination should include series (~240Ω) and GTL+ termination (connected to 1.5 V) resistors. See Figure 35.
3. Signal should be at end of daisy chain and the boundary scan chain should be partitioned into two distinct sections to assist in debugging the system: one partition with only the processor(s) for system debug (i.e., used with the ITP) and another with all other components for manufacturing or system test.

8.1.4. DEBUG PORT SIGNAL NOTES

In general, all open drain AGTL+ outputs from the system must be retained at a proper logic level, whether or not the debug port is installed. RESET# from the processor system should be terminated at

the debug port, as shown in Figure 35. R_t should be a 150Ω on RESET#.

PRDYn# should have a similar layout, however R_t should be 50Ω to match board impedance rather than the normal 150Ω since there are only 2 loads on this signal.

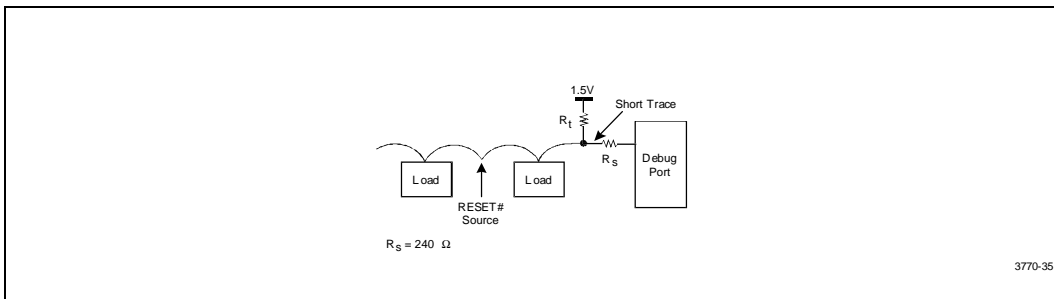


Figure 35. AGTL+ Signal Termination

8.1.4.1. General Signal Quality Notes

Signals from the debug port are fed to the system from the ITP via a buffer board and a cable. If system signals routed to the debug port (i.e., TDO, PRDY[x]# and RESET#) are used elsewhere in the system, then dedicated drivers should be used to isolate the signals from reflections coming from the end of this cable. If the Pentium II Xeon processor boundary scan signals are used elsewhere in the system, then the TDI, TMS, TCK, and TRST# signals from the debug port should be isolated from the system signals.

In general, no signals should be left floating. Thus, signals going from the debug port to the processor system should not be left floating. If they are left floating, there may be problems when the ITP is not plugged into the connector.

8.1.4.2. Signal Note: DBRESET#

The DBRESET# output signal from the ITP is an open drain with about 5Ω of R_{DS} . The usual implementation is to connect it to the PWROK open drain signal on the PCIset components as an OR input to initiate a system reset. In order for the DBRESET# signal to work properly, it must actually reset the entire target system. The signal should be pulled up (Intel recommends a 240Ω resistor, but system designers will need to fine tune specific system designs) to meet two considerations: (1) the signal must be able to meet V_{IL} of the system, and (2) it must allow the signal to meet the specified rise time. When asserted by the ITP, the DBRESET# signal will remain asserted for 100 ms. A large capacitance should not be present on this signal as it may prevent a full charge from building up within 100 ms.

8.1.4.3. Signal Note: TDO and TDI

The TDO signal of each processor has a 2.5 V Tolerant open-drain driver. The TDI signal of each

processor contains a 150Ω pull-up to V_{CCTAP} . When connecting one Pentium II Xeon processor to the next, or connecting to the TDI of the first processor, no external pull-up is required. However, the last processor of the chain does require a pull-up before passing the signal to the next device in the chain.

8.1.4.4. Signal Note: TCK

WARNING

A significant number of target systems have had signal integrity issues with the TCK signal. TCK is a critical clock signal and must be routed accordingly; make sure to observe power and ground plane integrity for this signal. Follow the guidelines below and assure the quality of the signal when beginning use of an ITP to debug your target.

Due to the number of loads on the TCK signal, special care should be taken when routing this signal on the motherboard. Poor routing can lead to multiple clocking of some agents on the debug chain. This causes information to be lost through the chain and can result in bad commands being issued to some agents on the chain.

The suggested routing scheme is to drive each of the agent TCK signals individually from a buffer device. Figure 36 shows how the TCK signal should be routed to the agents in a 4-way Pentium II Xeon Processor system incorporating the Intel 450NX PCIset. A Bessel filter is recommended over a series termination at the output of each buffer. The values shown in Figure 36 are only examples. The designer should determine the LC values appropriate for their particular application.

If it is desired to ship production systems without the 2.5 V buffers installed, then pull-up resistors should be placed at the outputs to prevent TCK from floating.

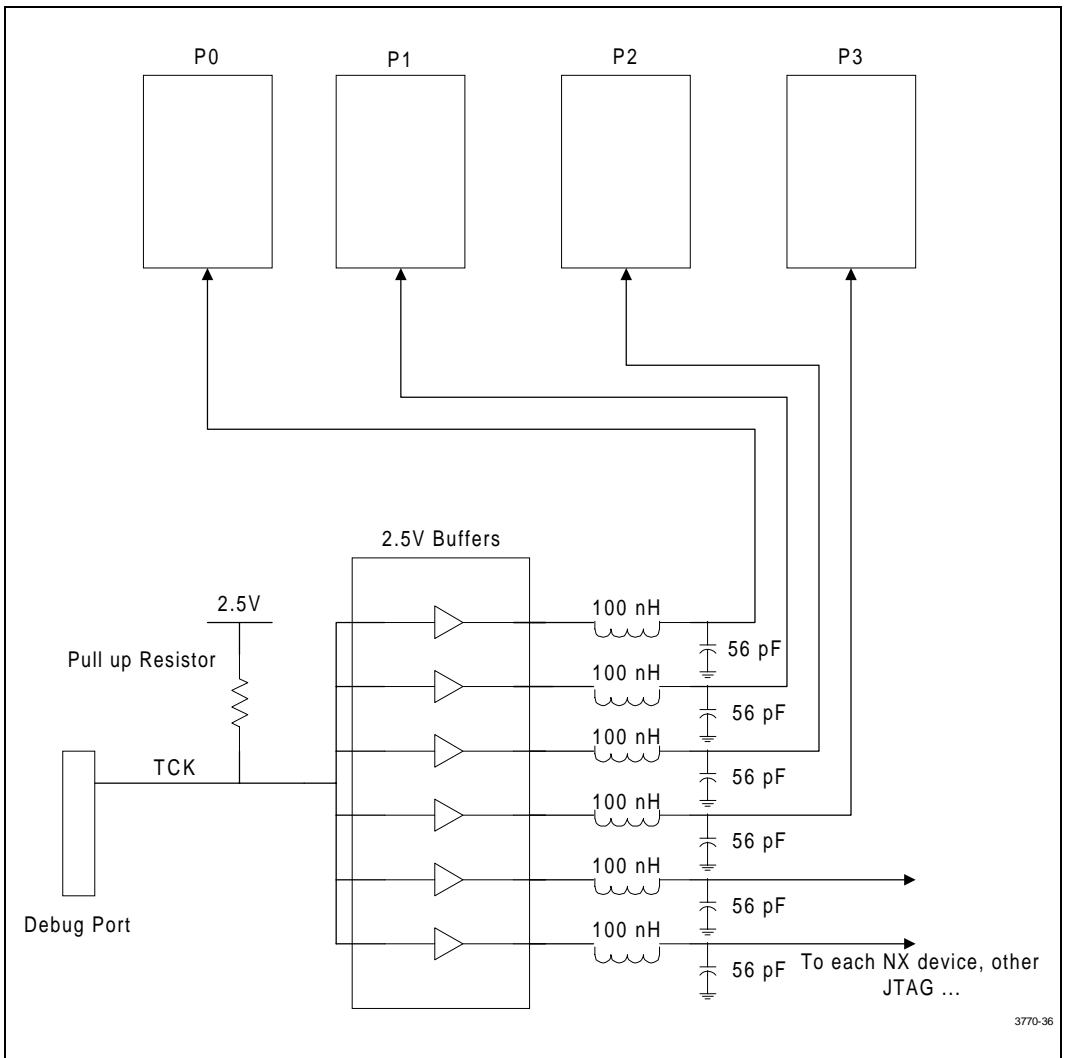


Figure 36. TCK with Individual Buffering Scheme

The ITP565 buffer board drives the TCK signal through the debug port, to the buffer device.

NOTE

The buffer rise and fall edge rates should **NOT** be **FASTER** than 3 ns. Edge rates faster than this in the system can contribute to signal reflections which endanger ITP compatibility with the target system.

A low voltage buffer capable of driving 2.5 V outputs such as an 74LVQ244 is suggested to eliminate the need for attenuation.

Simulation should be performed to verify that the edge rates of the buffer chosen are not too fast.

The pull-up resistor to 2.5 V keeps the TCK signal from floating when the ITP is not connected. The value of this resistor should be such that the ITP can still drive the signal low (1K). The trace lengths from the buffer to each of the agents should also be kept at a minimum to ensure good signal integrity.

The “synchronous” mode of the ITP, needed for debug of FRC pairs, is no longer supported. FRC mode must be disabled when debugging an FRC-capable system.

8.1.5. USING BOUNDARY SCAN TO COMMUNICATE TO THE PROCESSOR

An ITP communicates to Pentium II Xeon processors by stopping their execution and sending/receiving messages over boundary scan pins. As long as each processor is tied into the system boundary scan chain, the ITP can communicate with it. In the simplest case, the processors are back to back in the scan chain, with the boundary scan input (TDI) of the first processor connected up directly to the pin labeled TDI on the debug port and the boundary scan output of the last processor connected up to the pin labeled TDO on the debug port as shown in Figure 37.

8.2. Integration Tool (Logic Analyzer) Considerations

8.2.1. INTEGRATION TOOL MECHANICAL KEEPOUTS

Designers should also work closely with the vendor of the LAI that they will be using in debug for constraints for their tools.

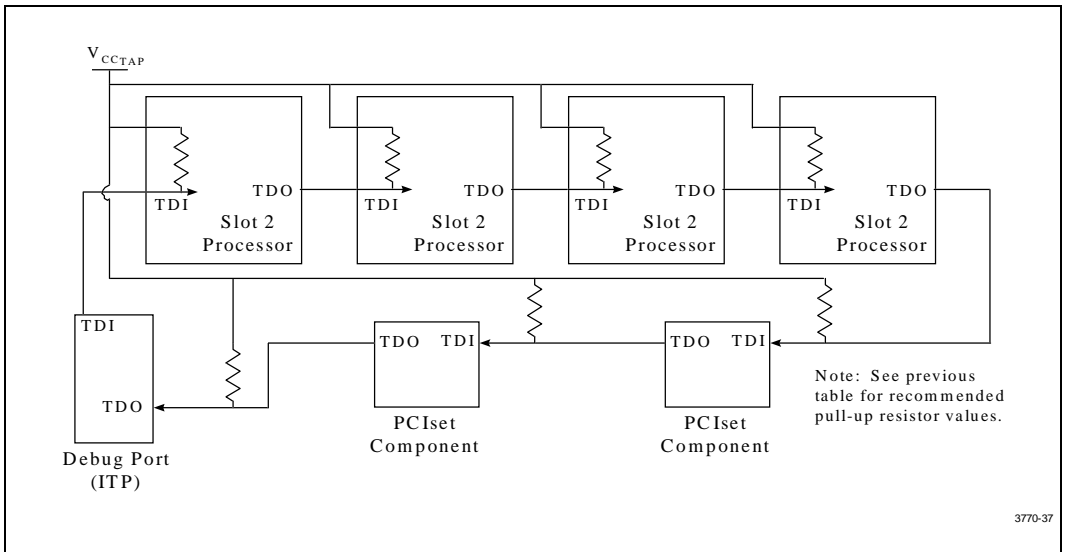


Figure 37. System Preferred Debug Port Layout

APPENDIX A

9.0. APPENDIX

This appendix provides an alphabetical listing of all Pentium II Xeon processor signals and tables that summarize the signals by direction: output, input, and I/O.

9.1. Alphabetical Signals Reference

This section provides an alphabetical listing of all Pentium II Xeon processor signals.

9.1.1. A[35:03]# (I/O)

The A[35:3]# (Address) signals define a 2³⁶-byte physical memory address space. When ADS# is active, these pins transmit the address of a transaction; when ADS# is inactive, these pins transmit transaction type information. These signals must connect the appropriate pins of all agents on the Pentium II Xeon processor system bus. The A[35:24]# signals are parity-protected by the AP1# parity signal, and the A[23:03]# signals are parity-protected by the AP0# parity signal.

On the active-to-inactive transition of RESET#, the processors sample the A[35:03]# pins to determine their power-on configuration. See the *Pentium® II Processor Developer's Manual* for details.

9.1.2. A20M# (I)

If the A20M# (Address-20 Mask) input signal is asserted, the Pentium II Xeon processor masks physical address bit 20 (A20#) before looking up a line in any internal cache and before driving a read/write transaction on the bus. Asserting A20M# emulates the 8086 processor's address wrap-around at the 1-Mbyte boundary. Assertion of A20M# is only supported in real mode.

A20M# is an asynchronous signal. However, to ensure recognition of this signal following an I/O write instruction, it must be valid along with the TRDY# assertion of the corresponding I/O Write bus transaction.

During active RESET#, each processor begins sampling the A20M#, IGNNE#, and LINT[1:0] values to determine the ratio of core-clock frequency to bus-clock frequency. See Table 1. On the active-to-inactive transition of RESET#, each processor latches these signals and freezes the frequency ratio internally. System logic must then release these signals for normal operation.

9.1.3. ADS# (I/O)

The ADS# (Address Strobe) signal is asserted to indicate the validity of the transaction address on the A[35:03]# pins. All bus agents observe the ADS# activation to begin parity checking, protocol checking, address decode, internal snoop, or deferred reply ID match operations associated with the new transaction. This signal must connect the appropriate pins on all Pentium II Xeon processor system bus agents.

9.1.4. AERR# (I/O)

The AERR# (Address Parity Error) signal is observed and driven by all Pentium II Xeon processor system bus agents, and if used, must connect the appropriate pins on all Pentium II Xeon processor system bus agents. AERR# observation is optionally enabled during power-on configuration; if enabled, a valid assertion of AERR# aborts the current transaction.

If AERR# observation is disabled during power-on configuration, a central agent may handle an assertion of AERR# as appropriate to the Machine Check Architecture (MCA) of the system.

9.1.5. AP[1:0]# (I/O)

The AP[1:0]# (Address Parity) signals are driven by the request initiator along with ADS#, A[35:03]#, REQ[4:0]#, and RP#. AP1# covers A[35:24]#, and AP0# covers A[23:03]#. A correct parity signal is high if an even number of covered signals are low and low if an odd number of covered signals are low. This allows parity to be high when all the covered signals are high. AP[1:0]# should connect the appropriate

pins of all Pentium II Xeon processor system bus agents.

9.1.6. BCLK (I)

The BCLK (Bus Clock) signal determines the bus frequency. All Pentium II Xeon processor system bus agents must receive this signal to drive their outputs and latch their inputs on the BCLK rising edge.

All external timing parameters are specified with respect to the BCLK signal.

9.1.7. BERR# (I/O)

The BERR# (Bus Error) signal is asserted to indicate an unrecoverable error without a bus protocol violation. It may be driven by all Pentium II Xeon processor system bus agents, and must connect the appropriate pins of all such agents, if used. However, Pentium II Xeon processors do not observe assertions of the BERR# signal.

BERR# assertion conditions are configurable at a system level. Assertion options are defined by the following options:

- Enabled or disabled.
- Asserted optionally for internal errors along with IERR#.
- Asserted optionally by the request initiator of a bus transaction after it observes an error.
- Asserted by any bus agent when it observes an error in a bus transaction.

9.1.8. BINIT# (I/O)

The BINIT# (Bus Initialization) signal may be observed and driven by all Pentium II Xeon processor system bus agents, and if used must connect the appropriate pins of all such agents. If the BINIT# driver is enabled during power on configuration, BINIT# is asserted to signal any bus condition that prevents reliable future information.

If BINIT# observation is enabled during power-on configuration, and BINIT# is sampled asserted, all bus state machines are reset and any data which was in transit is lost. All agents reset their rotating ID for bus arbitration to the state after reset, and internal count information is lost. The L1 and L2 caches are not affected.

If BINIT# observation is disabled during power-on configuration, a central agent may handle an assertion of BINIT# as appropriate to the Machine Check Architecture (MCA) of the system.

9.1.9. BNR# (I/O)

The BNR# (Block Next Request) signal is used to assert a bus stall by any bus agent who is unable to accept new bus transactions. During a bus stall, the current bus owner cannot issue any new transactions.

Since multiple agents might need to request a bus stall at the same time, BNR# is a wire-OR signal which must connect the appropriate pins of all Pentium II Xeon processor system bus agents. In order to avoid wire-OR glitches associated with simultaneous edge transitions driven by multiple drivers, BNR# is activated on specific clock edges and sampled on specific clock edges.

9.1.10. BP[3:2]# (I/O)

The BP[3:2]# (Breakpoint) signals are outputs from the processor that indicate the status of breakpoints.

9.1.11. BPM[1:0]# (I/O)

The BPM[1:0]# (Breakpoint Monitor) signals are breakpoint and performance monitor signals. They are outputs from the processor which indicate the status of breakpoints and programmable counters used for monitoring processor performance.

9.1.12. BPRI# (I)

The BPRI# (Bus Priority Request) signal is used to arbitrate for ownership of the Pentium II Xeon processor system bus. It must connect the appropriate pins of all Pentium II Xeon processor system bus agents. Observing BPRI# active (as asserted by the priority agent) causes all other agents to stop issuing new requests, unless such requests are part of an ongoing locked operation. The priority agent keeps BPRI# asserted until all of its requests are completed, then releases the bus by deasserting BPRI#.

9.1.13. BR0# (I/O), BR[3:1]# (I)

The BR[3:1]# (Bus Request) pins drive the BREQ[3:0]# signals on the system. The BR[3:0]#



pins are interconnected in a rotating manner to other processors' BR[3:0]# pins. Table 44 gives the rotating interconnect between the processor and bus signals for 4-way systems.

During power-up configuration, the central agent must assert its BR0# signal. All symmetric agents sample their BR[3:0]# pins on active-to-inactive transition of RESET#. The pin on which the agent samples an active level determines its agent ID. All agents then configure their BREQ[3:0]# signals to match the appropriate bus signal protocol, as shown in Table 46.

Table 45 gives the interconnect between the processor and bus signals for a 2-way system.

Table 44. BR[3:0]# Signals Rotating Interconnect, 4-Way System

Bus Signal	Agent 0 Pins	Agent 1 Pins	Agent 2 Pins	Agent 3 Pins
BREQ0#	BR0#	BR3#	BR2#	BR1#
BREQ1#	BR1#	BR0#	BR3#	BR2#
BREQ2#	BR2#	BR1#	BR0#	BR3#
BREQ3#	BR3#	BR2#	BR1#	BR0#

Table 45. BR[3:0]# Signals Rotating Interconnect, 2-Way System

Bus Signal	Agent 0 Pins	Agent 1 Pins
BREQ0#	BR0#	BR3#
BREQ1#	BR1#	BR0#
BREQ2#	BR2#	BR1#
BREQ3#	BR3#	BR2#

Table 46. Agent ID Configuration

BR0#	BR1#	BR2#	BR3#	A5#	Agent ID
L	H	H	H	H	0
H	H	H	L	H	1
H	H	L	H	H	2
H	L	H	H	H	3
L	H	H	H	L	0(master)
H	H	H	L	L	0(checker)
H	H	L	H	L	2(master)
H	L	H	H	L	2(checker)

9.1.14. D[63:00]# (I/O)

The D[63:00]# (Data) signals are the data signals. These signals provide a 64-bit data path between the Pentium II Xeon processor system bus agents, and must connect the appropriate pins on all such agents. The data driver asserts DRDY# to indicate a valid data transfer.

9.1.15. DBSY# (I/O)

The DBSY# (Data Bus Busy) signal is asserted by the agent responsible for driving data on the Pentium II Xeon processor system bus to indicate that the data bus is in use. The data bus is released after DBSY# is deasserted. This signal must connect the appropriate pins on all Pentium II Xeon processor system bus agents.

9.1.16. DEFER# (I)

The DEFER# signal is asserted by an agent to indicate that a transaction cannot be guaranteed in-order completion. Assertion of DEFER# is normally the responsibility of the addressed memory or I/O agent. This signal must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

9.1.17. DEP[7:0]# (I/O)

The DEP[7:0]# (Data Bus ECC Protection) signals provide optional ECC protection for the data bus. They are driven by the agent responsible for driving D[63:00]#, and must connect the appropriate pins of all Pentium II Xeon processor system bus agents which use them. The DEP[7:0]# signals are enabled or disabled for ECC protection during power on configuration.

9.1.18. DRDY# (I/O)

The DRDY# (Data Ready) signal is asserted by the data driver on each data transfer, indicating valid data on the data bus. In a multicycle data transfer, DRDY# may be deasserted to insert idle clocks. This signal must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

9.1.19. EMI

The EMI pins should be connected to motherboard or chassis ground through zero ohm resistors.

9.1.20. FERR# (O)

The FERR# (Floating-point Error) signal is asserted when the processor detects an unmasked floating-point error. FERR# is similar to the ERROR# signal on the Intel 387 coprocessor, and is included for compatibility with systems using MS-DOS*-type floating-point error reporting.

9.1.21. FLUSH# (I)

When the FLUSH# input signal is asserted, processors write back all data in the Modified state from their internal caches and invalidate all internal cache lines. At the completion of this operation, the processor issues a Flush Acknowledge transaction. The processor does not cache any new data while the FLUSH# signal remains asserted.

FLUSH# is an asynchronous signal. However, to ensure recognition of this signal following an I/O write instruction, it must be valid along with the TRDY# assertion of the corresponding I/O Write bus transaction.

On the active-to-inactive transition of RESET#, each processor samples FLUSH# to determine its power-on configuration. See the *Pentium® II Processor Developer's Manual* for details.

9.1.22. FRCERR (I/O)

If two processors are configured in a Functional Redundancy Checking (FRC) master/checker pair, as a single "logical" processor, the FRCERR (Functional Redundancy Checking Error) signal is asserted by the checker if a mismatch is detected between the internally sampled outputs and the master's outputs. The checker's FRCERR output pin must be connected with the master's FRCERR input pin in this configuration.

For point-to-point connections, the checker always compares against the master's outputs. For bussed single-driver signals, the checker compares against the signal when the master is the only allowed driver. For bussed multiple-driver wired-OR signals, the checker compares against the signal only if the master is expected to drive the signal low.

When a processor is configured as an FRC checker, FRCERR is toggled during its reset action. A checker asserts FRCERR for approximately 1 second after the active-to-inactive transition of RESET# if it executes its Built-In Self-Test (BIST). When BIST

execution completes, the checker processor deasserts FRCERR if BIST completed successfully, and continues to assert FRCERR if BIST fails. If the checker processor does not execute the BIST action, then it keeps FRCERR asserted for approximately 20 clocks and then deasserts it.

All asynchronous signals must be externally synchronized to BCLK by system logic during FRC mode operation.

9.1.23. HIT# (I/O), HITM# (I/O)

The HIT# (Snoop Hit) and HITM# (Hit Modified) signals convey transaction snoop operation results, and must connect the appropriate pins of all Pentium II Xeon processor system bus agents. Any such agent may assert both HIT# and HITM# together to indicate that it requires a snoop stall, which can be continued by reasserting HIT# and HITM# together.

9.1.24. IERR# (O)

The IERR# (Internal Error) signal is asserted by a processor as the result of an internal error. Assertion of IERR# is usually accompanied by a SHUTDOWN transaction on the Pentium II Xeon processor system bus. This transaction may optionally be converted to an external error signal (e.g., NMI) by system core logic. The processor will keep IERR# asserted until it is handled in software, or with the assertion of RESET#, BINIT#, or INIT#.

9.1.25. IGNNE# (I)

The IGNNE# (Ignore Numeric Error) signal is asserted to force the processor to ignore a numeric error and continue to execute noncontrol floating-point instructions. If IGNNE# is deasserted, the processor generates an exception on a noncontrol floating-point instruction if a previous floating-point instruction caused an error. IGNNE# has no effect when the NE bit in control register 0 is set.

IGNNE# is an asynchronous signal. However, to ensure recognition of this signal following an I/O write instruction, it must be valid along with the TRDY# assertion of the corresponding I/O Write bus transaction.

During active RESET#, the Pentium II Xeon processor begins sampling the A20M#, IGNNE#, and LINT[1:0] values to determine the ratio of core-clock

frequency to bus-clock frequency. See Table 1. On the active-to-inactive transition of RESET#, the Pentium II Xeon processor latches these signals and freezes the frequency ratio internally. System logic must then release these signals for normal operation.

9.1.26. INIT# (I)

The INIT# (Initialization) signal, when asserted, resets integer registers inside all processors without affecting their internal (L1 or L2) caches or floating-point registers. Each processor then begins execution at the power-on reset vector configured during power-on configuration. The processor continues to handle snoop requests during INIT# assertion. INIT# is an asynchronous signal and must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

If INIT# is sampled active on the active to inactive transition of RESET#, then the processor executes its Built-In Self-Test (BIST).

9.1.27. INTR - SEE LINT[0]

9.1.28. LINT[1:0] (I)

The LINT[1:0] (Local APIC Interrupt) signals must connect the appropriate pins of all APIC Bus agents, including all processors and the core logic or I/O APIC component. When the APIC is disabled, the LINT0 signal becomes INTR, a maskable interrupt request signal, and LINT1 becomes NMI, a nonmaskable interrupt. INTR and NMI are backward compatible with the signals of those names on the Pentium processor. Both signals are asynchronous.

Both of these signals must be software configured via BIOS programming of the APIC register space to be used either as NMI/INTR or LINT[1:0]. Because the APIC is enabled by default after reset, operation of these pins as LINT[1:0] is the default configuration.

During active RESET#, the Pentium II Xeon processor begins sampling the A20M#, IGNNE#, and LINT[1:0] values to determine the ratio of core-clock frequency to bus-clock frequency. See Table 1. On the active-to-inactive transition of RESET#, the Pentium II Xeon processor samples these signals and latches the frequency ratio internally. System logic must then release these signals for normal operation.

9.1.29. LOCK# (I/O)

The LOCK# signal indicates to the system that a transaction must occur atomically. This signal must connect the appropriate pins of all Pentium II Xeon processor system bus agents. For a locked sequence of transactions, LOCK# is asserted from the beginning of the first transaction end of the last transaction.

When the priority agent asserts BPRI# to arbitrate for ownership of the Pentium II Xeon processor system bus, it will wait until it observes LOCK# deasserted. This enables symmetric agents to retain ownership of the Pentium II Xeon processor system bus throughout the bus locked operation and ensure the atomicity of lock.

9.1.30. NMI - SEE LINT[1]
9.1.31. PICCLK (I)

The PICCLK (APIC Clock) signal is an input clock to the processor and core logic or I/O APIC which is required for operation of all processors, core logic, and I/O APIC components on the APIC bus. During FRC mode operation, PICCLK must be 1/4 of (and synchronous to) BCLK.

9.1.32. PICD[1:0] (I/O)

The PICD[1:0] (APIC Data) signals are used for bi-directional serial message passing on the APIC bus, and must connect the appropriate pins of all processors and core logic or I/O APIC components on the APIC bus.

9.1.33. PRDY# (O)

The PRDY (Probe Ready) signal is a processor output used by debug tools to determine processor debug readiness. See Section 8.0. for more information on this signal.

9.1.34. PREQ# (I)

The PREQ# (Probe Request) signal is used by debug tools to request debug operation of the processors. See Section 8.0. for more information on this signal.

9.1.34. PWREN[1:0] (I)

These 2 pins are tied directly together on the processor. They can be used to detect processor presence by applying a voltage to one pin and observing it at the other. See Table 4 for the maximum rating for this signal.

9.1.35. PWRGOOD (I)

The PWRGOOD (Power Good) signal is a 2.5 V tolerant processor input. The processor requires this signal to be a clean indication that the clocks and power supplies (V_{CCCORE} , V_{CCCL2} , $V_{CC TAP}$, $V_{CCSMBUS}$) are stable and within their specifications. Clean implies that the signal will remain low (capable of sinking leakage current), without glitches, from the time that the power supplies are turned on until they come within specification. The signal must then transition monotonically to a high (2.5 V) state. Figure 38 illustrates the relationship of PWRGOOD to other system signals. PWRGOOD can be driven inactive at any time, but clocks and power must again be stable before a subsequent rising edge of PWRGOOD. It must also meet the minimum pulse width specification in Table 11 and be followed by a 1 ms RESET# pulse.

The PWRGOOD signal must be supplied to the processor; it is used to protect internal circuits against voltage sequencing issues. The PWRGOOD signal does not need to be synchronized for FRC operation. It should be driven high throughout boundary scan operation.

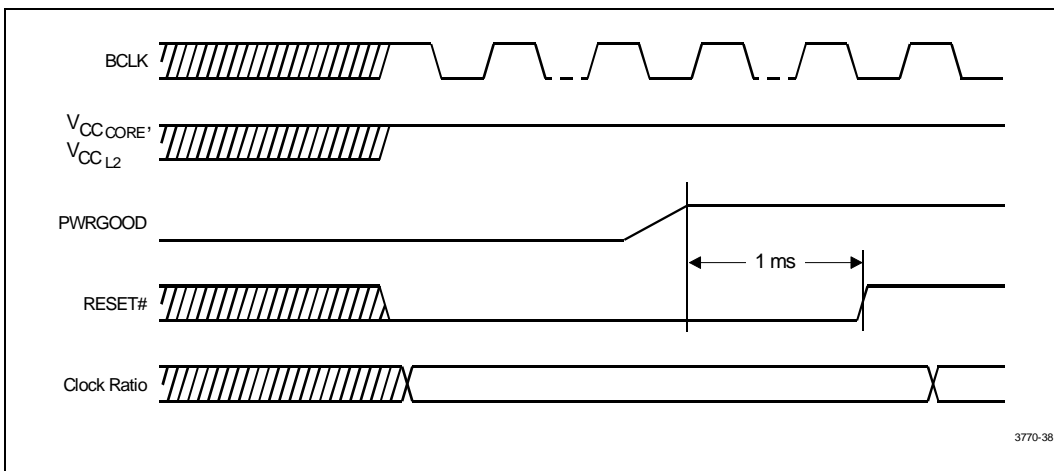


Figure 38. PWRGOOD Relationship at Power-On

9.1.37. REQ[4:0]# (I/O)

The REQ[4:0]# (Request Command) signals must connect the appropriate pins of all Pentium II Xeon processor system bus agents. They are asserted by the current bus owner over two clock cycles to define the currently active transaction type.

9.1.38. RESET# (I)

Asserting the RESET# signal resets all processors to known states and invalidates their L1 and L2 caches without writing back any of their contents. RESET# must remain active for one microsecond for a “warm” reset; for a power-on reset, RESET# must stay active for at least one millisecond after V_{CC}CORE and CLK have reached their proper specifications. On observing active RESET#, all Pentium II Xeon processor system bus agents will deassert their outputs within two clocks.

A number of bus signals are sampled at the active-to-inactive transition of RESET# for power-on configuration. These configuration options are described in the *Pentium® II Processor Developer's Manual*.

The processor may have its outputs tri-stated via power-on configuration. Otherwise, if INIT# is sampled active during the active-to-inactive transition of RESET#, the processor will execute its Built-In Self-Test (BIST). Whether or not BIST is executed, the processor will begin program execution at the

reset-vector (default 0_FFFF_FFF0h). RESET# must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

9.1.39. RP# (I/O)

The RP# (Request Parity) signal is driven by the request initiator, and provides parity protection on ADS# and REQ[4:0]#. It must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

A correct parity signal is high if an even number of covered signals are low and low if an odd number of covered signals are low. This definition allows parity to be high when all covered signals are high.

9.1.40. RS[2:0]# (I)

The RS[2:0]# (Response Status) signals are driven by the response agent (the agent responsible for completion of the current transaction), and must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

9.1.41. RSP# (I)

The RSP# (Response Parity) signal is driven by the response agent (the agent responsible for completion of the current transaction) during assertion of RS[2:0]#, the signals for which RSP# provides parity

protection. It must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

A correct parity signal is high if an even number of covered signals are low and low if an odd number of covered signals are low. While $RS[2:0]\# = 000$, $RSP\#$ is also high, since this indicates it is not being driven by any agent guaranteeing correct parity.

9.1.42. SA[2:0] (I)

The SA (Select Address) pins are decoded on the SMBus in conjunction with the upper address bits in order to maintain unique addresses on the SMBus in a system with multiple Pentium II Xeon processors. To set an SA line high, a pull-up resistor should be used that is no larger than $1k\Omega$. To set an SA line as low, SA1 and SA0 can be left unconnected. To set SA2 as low, it should be pulled to ground ($\sim 10k\Omega$). SA2 can also be tri-stated to define additional addresses for the thermal sensor. A tri-state or “Z” state on this pin is achieved by leaving this pin unconnected.

Of the addresses broadcast across the SMBus, the memory components claim those of the form “1010XXYZb”. The “XX” and “Y” bits are used to enable the devices on the cartridge at adjacent addresses. The Y bit is hard-wired on the cartridge to V_{SS} (‘0’) for the Scratch EEPROM and pulled to $V_{CCSMBUS}$ (‘1’) for the Processor Information ROM. The “XX” bits are defined by the processor slot via the SA0 and SA1 pins on the SC330 connector. These address pins are pulled down weakly ($10k\Omega$) on the cartridge to ensure that the memory components are in a known state in systems which do not support the SMBus, or only support a partial implementation. The “Z” bit is the read/write bit for the serial bus transaction.

The thermal sensor internally decodes 1 of 3 upper address patterns from the bus of the form “0011XXXZb”, “1001XXXZb” or “0101XXXZb”. The device’s addressing, as implemented, includes a Hi-Z state for one address pin (SA2), and therefore supports 6 unique resulting addresses. The ability of the system to drive this pin to a Hi-Z state is dependent on the motherboard implementation (The pin must be left floating). The system should drive SA1 and SA0, and will be pulled low (if not driven) by the $10k\Omega$ pull-down resistor on the processor substrate. Driving these signals to a Hi-Z state would cause ambiguity in the memory device address decode, possibly resulting in the devices not responding, thus timing out or hanging the SMBus.

As before, the “Z” bit is the read/write bit for the serial bus transaction.

For more information on the usage of these pins, see Section 4.3.7.

9.1.43. SMBALERT# (O)

SMBALERT# is an asynchronous interrupt line associated with the SMBus Thermal Sensor device.

9.1.44. SMBCLK (I)

The SMBCLK (SMBus Clock) signal is an input clock to the system management logic which is required for operation of the system management features of the Pentium II Xeon processor. This clock is asynchronous to other clocks to the processor.

9.1.45. SMBDAT (I/O)

The SMBDAT (SMBus DATA) signal is the data signal for the SMBus. This signal provides the single-bit mechanism for transferring data between SMBus devices.

9.1.46. SELFSB0 (I/O)

Current Pentium II Xeon processors do not have a selectable system bus speed option. SELFSB0 should be left as an open on the motherboard to ensure compatibility with future processors.

9.1.47. SLP# (I)

The SLP# (Sleep) signal, when asserted in Stop Grant state, causes processors to enter the Sleep state. During Sleep state, the processor stops providing internal clock signals to all units, leaving only the Phase-Locked Loop (PLL) still operating. Processors in this state will not recognize snoops or interrupts. The processor will recognize only assertions of the SLP#, STPCLK#, and RESET# signals while in Sleep state. If SLP# is deasserted, the processor exits Sleep state and returns to Stop Grant state, restarting its internal clock signals to the bus and APIC processor core units.

9.1.48. SMI# (I)

The SMI# (System Management Interrupt) signal is asserted asynchronously by system logic. On

accepting a System Management Interrupt, processors save the current state and enter System Management Mode (SMM). An SMI Acknowledge transaction is issued, and the processor begins program execution from the SMM handler.

9.1.49. STPCLK# (I)

The STPCLK# (Stop Clock) signal, when asserted, causes processors to enter a low power Stop Grant state. The processor issues a Stop Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the bus and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input.

9.1.50. TCK (I)

The TCK (Test Clock) signal provides the clock input for the Pentium II Xeon processor Test Bus (also known as the Test Access Port).

9.1.51. TDI (I)

The TDI (Test Data In) signal transfers serial test data into the Pentium II Xeon processor. TDI provides the serial input needed for TAP support.

9.1.52. TDO (O)

The TDO (Test Data Out) signal transfers serial test data out of the Pentium II Xeon processor. TDO provides the serial output needed for TAP support.

9.1.53. TEST_25_A62 (I)

The TEST_25_A62 signal must be connected to a 2.5 V power source through a 1-10kΩ resistor for proper processor operation.

9.1.54. TEST_VCC_CORE_XXX (I)

The TEST_VCC_CORE_XXX signals must be connected separately to V_{CC}CORE via ~10K resistors.

9.1.55. THERMTRIP# (O)

This pin indicates a thermal overload condition (thermal trip). The processor protects itself from catastrophic overheating by use of an internal thermal sensor. This sensor is set well above the normal operating temperature to ensure that there are no false trips. The processor will immediately stop all execution when the junction temperature exceeds approximately 135 °C. This is signaled to the system by the THERMTRIP# pin. Once activated, the signal remains latched, and the processor stopped, until RESET# goes active. There is no hysteresis built into the thermal sensor itself. Once the die temperature drops below the trip level, a RESET# pulse will reinitialize the processor and execution will continue at the reset vector. If the temperature has not dropped below the trip level, the processor will continue to drive THERMTRIP# and remain stopped regardless of the state of RESET#.

9.1.56. TMS (I)

The TMS (Test Mode Select) signal is a TAP support signal used by debug tools.

9.1.57. TRDY# (I)

The TRDY# (Target Ready) signal is asserted by the target to indicate that it is ready to receive a write or implicit writeback data transfer. TRDY# must connect the appropriate pins of all Pentium II Xeon processor system bus agents.

9.1.58. TRST# (I)

The TRST# (Test Reset) signal resets the Test Access Port (TAP) logic. Pentium II Xeon processors self-reset during power on; therefore, it is not necessary to drive this signal during power on reset.

9.1.59. VID_L2[4:0], VID_CORE[4:0](O)

The VID (Voltage ID) pins can be used to support automatic selection of power supply voltages. These pins are not signals, but are either an open circuit or a short circuit to V_{SS} on the processor. The combination of opens and shorts defines the voltage required by the processor. The VID pins are needed to cleanly support voltage specification variations on Pentium II Xeon processors. See Table 2 for definitions of these pins. The power supply must supply the voltage that is requested by these pins, or

disable itself. See Table 4 for the maximum rating for these signals.

9.2. Signal Summaries

The following tables list attributes of the Pentium II Xeon processor output, input, and I/O signals.

9.1.60. WP (I)

WP (Write Protect) can be used to write protect the scratch EEPROM. A high level write-protects the scratch EEPROM.

Table 47. Output Signals¹

Name	Active Level	Clock	Signal Group
FERR#	Low	Asynch	CMOS Output
IERR#	Low	Asynch	CMOS Output
PRDY#	Low	BCLK	AGTL+ Output
SMBALERT#	Low	Asynch	SMBus Output
TDO	High	TCK	TAP Output
THERMTRIP#	Low	Asynch	CMOS Output
VID_CORE[4:0]	High	Asynch	Power/Other
VID_L2[4:0]	High	Asynch	Power/Other

NOTE:

1. Outputs are not checked in FRC mode.

Table 48. Input Signals¹

Name	Active Level	Clock	Signal Group	Qualified
A20M#	Low	Asynch	CMOS Input	Always ²
BPRI#	Low	BCLK	AGTL+ Input	Always
BR[3:1]#	Low	BCLK	AGTL+ Input	Always
BCLK	High	—	System Bus Clock	Always
DEFER#	Low	BCLK	AGTL+ Input	Always
FLUSH#	Low	Asynch	CMOS Input	Always ²
IGNNE#	Low	Asynch	CMOS Input	Always ²
INIT#	Low	Asynch	CMOS Input	Always ²
INTR	High	Asynch	CMOS Input	APIC disabled mode
LINT[1:0]	High	Asynch	CMOS Input	APIC enabled mode
NMI	High	Asynch	CMOS Input	APIC disabled mode
PICCLK	High	—	APIC Clock	Always
PREQ#	Low	Asynch	CMOS Input	Always

Table 48. Input Signals¹ (Continued)

Name	Active Level	Clock	Signal Group	Qualified
PWRGOOD	High	Asynch	CMOS Input	Always
RESET#	Low	BCLK	AGTL+ Input	Always
RS[2:0]#	Low	BCLK	AGTL+ Input	Always
RSP#	Low	BCLK	AGTL+ Input	Always
SA[2:0]	High	SMBCLK	Power/Other	
SMBCLK#	High	—	SMBus Clock	Always
SLP#	Low	Asynch	CMOS Input	During Stop Grant state
SMI#	Low	Asynch	CMOS Input	
STPCLK#	Low	Asynch	CMOS Input	
TCK	High	—	TAP Clock	
TDI	High	TCK	TAP Input	
TMS	High	TCK	TAP Input	
TRST#	Low	Asynch	TAP Input	
TRDY#	Low	BCLK	AGTL+ Input	
WP	High	Asynch	SMBus Input	

NOTES:

1. All asynchronous input signals except PWRGOOD must be synchronous in FRC.
2. Synchronous assertion with active TDRY# ensures synchronization.

Table 49. I/O Signals (Single Driver)

Name	Active Level	Clock	Signal Group	Qualified
A[35:03]#	Low	BCLK	AGTL+ I/O	ADS#, ADS#+1
ADS#	Low	BCLK	AGTL+ I/O	Always
AP[1:0]#	Low	BCLK	AGTL+ I/O	ADS#, ADS#+1
SELFSB0	High	—	Power/Other	
BR0#	Low	BCLK	AGTL+ I/O	Always
BP[3:2]#	Low	BCLK	AGTL+ I/O	Always
BPM[1:0]#	Low	BCLK	AGTL+ I/O	Always
D[63:00]#	Low	BCLK	AGTL+ I/O	DRDY#
DBSY#	Low	BCLK	AGTL+ I/O	Always

Table 49. I/O Signals (Single Driver) (Continued)

Name	Active Level	Clock	Signal Group	Qualified
DEP[7:0]#	Low	BCLK	AGTL+ I/O	DRDY#
DRDY#	Low	BCLK	AGTL+ I/O	Always
FRCERR	High	BCLK	AGTL+ I/O	Always
LOCK#	Low	BCLK	AGTL+ I/O	Always
REQ[4:0]#	Low	BCLK	AGTL+ I/O	ADS#, ADS#+1
RP#	Low	BCLK	AGTL+ I/O	ADS#, ADS#+1
SMBDAT	High	SMBCLK	SMBus I/O	

Table 50. I/O Signals (Multiple Driver)

Name	Active Level	Clock	Signal Group	Qualified
AERR#	Low	BCLK	AGTL+ I/O	ADS#+3
BERR#	Low	BCLK	AGTL+ I/O	Always
BNR#	Low	BCLK	AGTL+ I/O	Always
BINIT#	Low	BCLK	AGTL+ I/O	Always
HIT#	Low	BCLK	AGTL+ I/O	Always
HITM#	Low	BCLK	AGTL+ I/O	Always
PICD[1:0]	High	PICCLK	APIC I/O	Always